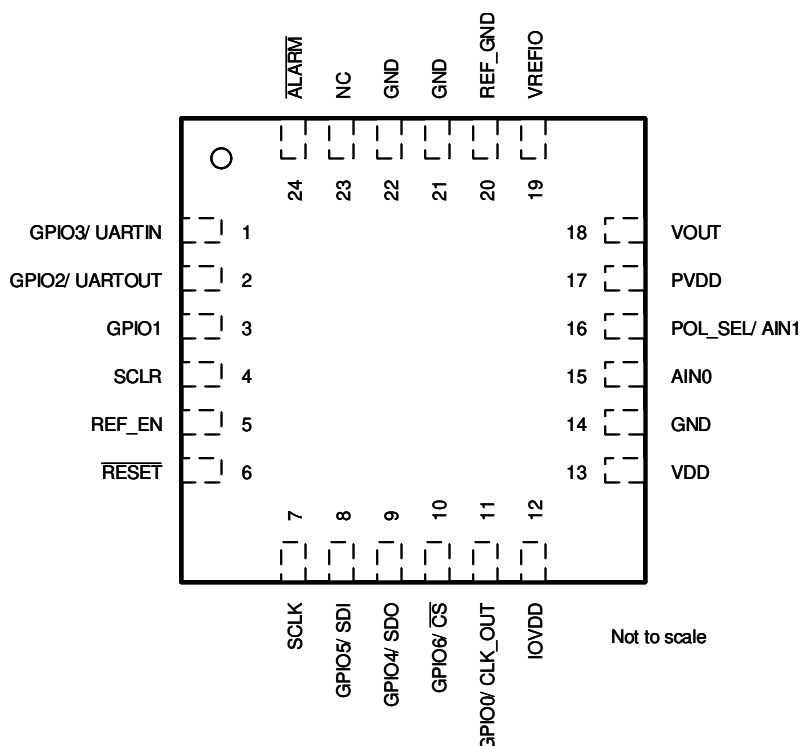




## Table of Contents

|                                                 |           |                                                                  |           |
|-------------------------------------------------|-----------|------------------------------------------------------------------|-----------|
| <b>1 Features</b> .....                         | <b>1</b>  | 6.4 Device Functional Modes.....                                 | <b>40</b> |
| <b>2 Applications</b> .....                     | <b>1</b>  | 6.5 Programming.....                                             | <b>43</b> |
| <b>3 Description</b> .....                      | <b>1</b>  | <b>7 Register Maps</b> .....                                     | <b>52</b> |
| <b>4 Pin Configuration and Functions</b> .....  | <b>3</b>  | 7.1 AFEx8201 Registers.....                                      | <b>54</b> |
| <b>5 Specifications</b> .....                   | <b>5</b>  | <b>8 Application and Implementation</b> .....                    | <b>75</b> |
| 5.1 Absolute Maximum Ratings.....               | <b>5</b>  | 8.1 Application Information.....                                 | <b>75</b> |
| 5.2 ESD Ratings.....                            | <b>5</b>  | 8.2 Typical Application.....                                     | <b>76</b> |
| 5.3 Recommended Operating Conditions.....       | <b>5</b>  | 8.3 Initialization Setup.....                                    | <b>82</b> |
| 5.4 Thermal Information.....                    | <b>5</b>  | 8.4 Power Supply Recommendations.....                            | <b>82</b> |
| 5.5 Electrical Characteristics.....             | <b>6</b>  | 8.5 Layout.....                                                  | <b>83</b> |
| 5.6 Timing Requirements.....                    | <b>10</b> | <b>9 Device and Documentation Support</b> .....                  | <b>85</b> |
| 5.7 Timing Diagrams .....                       | <b>11</b> | 9.1 Documentation Support .....                                  | <b>85</b> |
| 5.8 Typical Characteristics: VOUT DAC.....      | <b>12</b> | 9.2 Receiving Notification of Documentation Updates....          | <b>85</b> |
| 5.9 Typical Characteristics: ADC.....           | <b>17</b> | 9.3 Support Resources.....                                       | <b>85</b> |
| 5.10 Typical Characteristics: Reference.....    | <b>18</b> | 9.4 Trademarks.....                                              | <b>85</b> |
| 5.11 Typical Characteristics: Power Supply..... | <b>20</b> | 9.5 Electrostatic Discharge Caution.....                         | <b>85</b> |
| <b>6 Detailed Description</b> .....             | <b>21</b> | 9.6 Glossary.....                                                | <b>85</b> |
| 6.1 Overview.....                               | <b>21</b> | <b>10 Revision History</b> .....                                 | <b>86</b> |
| 6.2 Functional Block Diagram.....               | <b>21</b> | <b>11 Mechanical, Packaging, and Orderable Information</b> ..... | <b>86</b> |
| 6.3 Feature Description.....                    | <b>22</b> |                                                                  |           |

## 4 Pin Configuration and Functions



**Figure 4-1. RRU Package, 24-pin UQFN (Top View)**

**Table 4-1. Pin Functions**

| PIN               |     | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                        |
|-------------------|-----|---------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME              | NO. |                     |                                                                                                                                                                                                                                                                                                                                                                    |
| AIN0              | 15  | AI                  | ADC input voltage. The input range is 0 V to 2 × VREF.                                                                                                                                                                                                                                                                                                             |
| ALARM             | 24  | DO                  | Alarm notification pin, open drain, active low. When alarm condition is asserted, this pin is held to logic low; otherwise, this pin is in a high-impedance state (Hi-Z).                                                                                                                                                                                          |
| GND               | 14  | P                   | Digital and analog ground. Ground reference point for all circuitry on the device.                                                                                                                                                                                                                                                                                 |
| GND               | 21  | P                   | Digital and analog ground.                                                                                                                                                                                                                                                                                                                                         |
| GND               | 22  | P                   | Digital and analog ground.                                                                                                                                                                                                                                                                                                                                         |
| GPIO0/<br>CLK_OUT | 11  | DO/DI               | General-purpose input/output (GPIO) pin. Can be configured as a clock output for the 1.2288-MHz internal clock or as a timer. In Hi-Z if not driven. An external pullup or pulldown resistor is required.                                                                                                                                                          |
| GPIO1             | 3   | DO/DI               | General-purpose input/output (GPIO) pin. In Hi-Z if not driven. An external pullup or pulldown resistor is required.                                                                                                                                                                                                                                               |
| GPIO2/<br>UARTOUT | 2   | DO/DI               | General-purpose input/output (GPIO) pin. Configured as UART data output at power up. This pin can be configured to function as IRQ pin in SPI only mode. In Hi-Z if not driven. An external pullup or pulldown resistor is required.                                                                                                                               |
| GPIO3/<br>UARTIN  | 1   | DI/DO               | General-purpose input/output (GPIO) pin. Configured as UART data input at power up. Connect to IOVDD or logic high if not used. An external pullup or pulldown resistor is required.                                                                                                                                                                               |
| GPIO4/<br>SDO     | 9   | DO/DI               | General-purpose input/output (GPIO) pin. Can be configured as an SPI data output in SPI mode. Data are output on the rising edge of SCLK when $\overline{CS}$ is low. Interrupt request (IRQ) pin in the UART break mode (UBM). The output is in Hi-Z at power up and must be enabled in the CONFIG register. An external pullup or pulldown resistor is required. |
| GPIO5/<br>SDI     | 8   | DI/DO               | General-purpose input/output (GPIO) pin. Configured as an SPI data input at power up. Data are clocked into the 24-bit input shift register on the falling edge of the serial clock input. SDI is a Schmitt-trigger logic input. An external pullup or pulldown resistor is required.                                                                              |

**Table 4-1. Pin Functions (continued)**

| PIN              |     | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                                                                                                         |
|------------------|-----|---------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME             | NO. |                     |                                                                                                                                                                                                                                                                                     |
| GPI06/<br>CS     | 10  | DI/DO               | General-purpose input/output (GPIO) pin. Configured as an SPI chip-select input at power up. Data bits are clocked into the serial shift register when CS is low. When CS is high, SDO is in Hi-Z and data on SDI are ignored. An external pullup or pulldown resistor is required. |
| IOVDD            | 12  | P                   | Interface supply. Supply voltage for digital input and output circuitry. This voltage sets the logical thresholds for the digital interfaces.                                                                                                                                       |
| NC               | 23  | —                   | Must be left unconnected.                                                                                                                                                                                                                                                           |
| POL_SEL/<br>AIN1 | 16  | DI/AI               | ADC input voltage if SPECIAL_CFG.AIN1_ENB bit is set to 1. The input range is 0 V to 2 × VREF. Otherwise, this pin acts as ALMV_POL, which sets the polarity of the VOUT alarm voltage.                                                                                             |
| PVDD             | 17  | P                   | Power supply for the internal low-dropout regulator (LDO), ADC input and VOUT DAC output.                                                                                                                                                                                           |
| REF_EN           | 5   | DI                  | Internal VREF enable input. A logic high on this pin enables the internal VREF and the VREFIO pin outputs 1.25 V. A logic low on this pin disables the internal VREF and the external 1.25-V reference is required at the VREFIO pin.                                               |
| REF_GND          | 20  | P                   | GND reference for VREFIO pin.                                                                                                                                                                                                                                                       |
| RESET            | 6   | DI                  | Reset pin, active low. Logic low on this pin turns off the internal oscillator and resets the device. Logic high returns the device to normal operation. Do not leave any digital pins floating.                                                                                    |
| SCLK             | 7   | DI                  | SPI clock. Data are transferred at rates up to 12.5 MHz. SCLK is a Schmitt-trigger logic input. Connect to GND or logic low if not used. Do not leave any digital pins floating.                                                                                                    |
| SCLR             | 4   | DI                  | DAC clear input pin in SPI mode. A logic high on this pin forces the DAC output into a CLEAR state. Connect to GND in UBM. Do not leave any digital input pins floating.                                                                                                            |
| VDD              | 13  | P/AO                | Internal low voltage LDO output. When 2.7 V to 5.5 V on PVDD pin is provided, the internal LDO is enabled. Connect a 1-μF to 10-μF capacitor on this pin.                                                                                                                           |
| VOUT             | 18  | AO                  | DAC output voltage.                                                                                                                                                                                                                                                                 |
| VREFIO           | 19  | AI/AO               | When the internal VREF is enabled by REF_EN pin, this pin outputs the internal VREF voltage. In this case, a load capacitance of 70 nF to 130 nF is required for stability. When disabled, this pin is the external 1.25-V reference input.                                         |

(1) AI = analog input, AO = analog output, DI = digital input, DO = digital output, P = power.

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                  |                            |                                 | MIN  | MAX         | UNIT |
|------------------|----------------------------|---------------------------------|------|-------------|------|
| Voltage          |                            | PVDD, IOVDD to GND              | –0.3 | 5.5         | V    |
|                  |                            | VDD to GND                      | –0.3 | 1.98        | V    |
|                  |                            | AIN0, POL_SEL/AIN1, VOUT to GND | –0.3 | PVDD + 0.3  | V    |
|                  |                            | Digital Input/Output to GND     | –0.3 | IOVDD + 0.3 | V    |
|                  |                            | VREFIO to GND                   | –0.3 | VDD + 0.3   | V    |
|                  |                            | REF_GND to GND                  | –0.3 | 0.3         | V    |
|                  | Input current into any pin |                                 | –10  | 10          | mA   |
| T <sub>J</sub>   | Junction temperature       |                                 | –55  | 150         | °C   |
| T <sub>stg</sub> | Storage temperature        |                                 | –65  | 150         |      |

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 5.2 ESD Ratings

|                    |                         |                                                                                 | VALUE | UNIT |
|--------------------|-------------------------|---------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>     | ±2000 | V    |
|                    |                         | Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins <sup>(2)</sup> | ±500  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.  
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                |                              |           | MIN  | NOM  | MAX  | UNIT |
|----------------|------------------------------|-----------|------|------|------|------|
|                | PVDD to GND                  |           | 2.7  |      | 5.5  | V    |
|                | VDD to GND                   |           | 1.71 |      | 1.89 | V    |
|                | IOVDD to GND                 |           | 1.71 |      | 5.5  | V    |
|                | VREFIO to GND, external VREF |           | 1.2  | 1.25 | 1.3  | V    |
| T <sub>A</sub> | Ambient temperature          | Specified | –40  |      | 125  | °C   |
|                |                              | Operating | –55  |      | 125  | °C   |

### 5.4 Thermal Information

| THERMAL METRIC <sup>1</sup> |                                              | AFE8201    | UNIT |
|-----------------------------|----------------------------------------------|------------|------|
|                             |                                              | RRU (UQFN) |      |
|                             |                                              | 24 PINS    |      |
| R <sub>θJA</sub>            | Junction-to-ambient thermal resistance       | 103.1      | °C/W |
| R <sub>θJC(top)</sub>       | Junction-to-case (top) thermal resistance    | 84.4       | °C/W |
| R <sub>θJC(bottom)</sub>    | Junction-to-case (bottom) thermal resistance | N/A        | °C/W |
| R <sub>θJB</sub>            | Junction-to-board thermal resistance         | 69.5       | °C/W |
| Ψ <sub>JT</sub>             | Junction-to-top characterization parameter   | 0.4        | °C/W |
| Ψ <sub>JB</sub>             | Junction-to-board characterization parameter | 68.4       | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics application report](#).

## 5.5 Electrical Characteristics

all minimum and maximum values at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and all typical values at  $T_A = 25^{\circ}\text{C}$ ,  $PVDD = IOVDD = 3.3\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)

| PARAMETER                    |                                                     | TEST CONDITIONS                                                                        | MIN   | TYP | MAX  | UNIT       |
|------------------------------|-----------------------------------------------------|----------------------------------------------------------------------------------------|-------|-----|------|------------|
| VOUT DAC STATIC PERFORMANCE  |                                                     |                                                                                        |       |     |      |            |
|                              | Resolution                                          | AFE88201                                                                               | 16    |     |      | Bits       |
|                              |                                                     | AFE78201                                                                               | 14    |     |      |            |
| INL                          | Integral nonlinearity <sup>(1)</sup>                | AFE88201, T <sub>A</sub> = −40°C to +125°C                                             | −12   |     | 12   | LSB        |
|                              |                                                     | AFE88201, T <sub>A</sub> = −40°C to +85°C                                              | −4    |     | 4    |            |
|                              |                                                     | AFE78201                                                                               | −3    |     | 3    |            |
| DNL                          | Differential nonlinearity <sup>(1)</sup>            |                                                                                        | −1    |     | 1    | LSB        |
| TUE                          | Total unadjusted error <sup>(1)</sup>               | T <sub>A</sub> = −40°C to +125°C                                                       | −0.1  |     | 0.1  | %FSR       |
|                              |                                                     | T <sub>A</sub> = −40°C to +85°C                                                        | −0.08 |     | 0.08 |            |
|                              |                                                     | T <sub>A</sub> = 25°C                                                                  | −0.05 |     | 0.05 |            |
|                              | Zero code error, no load                            | T <sub>A</sub> = −40°C to +125°C                                                       |       |     | 1    | mV         |
|                              |                                                     | T <sub>A</sub> = −40°C to +85°C                                                        |       |     | 1    |            |
|                              |                                                     | T <sub>A</sub> = 25°C                                                                  |       |     | 0.5  |            |
|                              | Zero code error temperature coefficient             |                                                                                        | ±3    |     |      | ppm/°C     |
|                              | Offset error <sup>(1)</sup>                         | T <sub>A</sub> = −40°C to +125°C                                                       | −0.07 |     | 0.07 | %FSR       |
|                              |                                                     | T <sub>A</sub> = −40°C to +85°C                                                        | −0.05 |     | 0.05 |            |
|                              |                                                     | T <sub>A</sub> = 25°C                                                                  | −0.03 |     | 0.03 |            |
|                              | Offset error temperature coefficient <sup>(1)</sup> |                                                                                        | ±3    |     |      | ppm/°C     |
|                              | Gain error <sup>(1)</sup>                           | T <sub>A</sub> = −40°C to +125°C                                                       | −0.1  |     | 0.1  | %FSR       |
|                              |                                                     | T <sub>A</sub> = −40°C to +85°C                                                        | −0.08 |     | 0.08 |            |
|                              |                                                     | T <sub>A</sub> = 25°C                                                                  | −0.05 |     | 0.05 |            |
|                              | Gain error temperature coefficient <sup>(1)</sup>   |                                                                                        | ±3    |     |      | ppm FSR/°C |
|                              | Full-scale error                                    | T <sub>A</sub> = −40°C to +125°C                                                       | −0.1  |     | 0.1  | %FSR       |
|                              |                                                     | T <sub>A</sub> = −40°C to +85°C                                                        | −0.08 |     | 0.08 |            |
|                              |                                                     | T <sub>A</sub> = 25°C                                                                  | −0.05 |     | 0.05 |            |
|                              | Full-scale error temperature coefficient            |                                                                                        | ±3    |     |      | ppm FSR/°C |
| VOUT DAC DYNAMIC PERFORMANCE |                                                     |                                                                                        |       |     |      |            |
| t <sub>s</sub>               | Output voltage settling time                        | ¼ to ¾ scale and ¾ to ¼ scale settling to ±2 LSB                                       | 65    |     |      | µs         |
|                              |                                                     | 10-mV step settling to ±2 LSB                                                          | 30    |     |      |            |
|                              | Slew rate                                           | Full-scale transition measured from 10% to 90%                                         | 30    |     |      | mV/µs      |
| V <sub>n</sub>               | Output noise                                        | 0.1 Hz to 10 Hz, DAC at midscale                                                       | 0.25  |     |      | LSBpp      |
|                              |                                                     | 100-kHz bandwidth, DAC at midscale                                                     | 32    |     |      | µVrms      |
| V <sub>n</sub>               | Output noise density                                | Measured at 1 kHz, DAC at midscale, PVDD = 3 V                                         | 180   |     |      | nV/√Hz     |
|                              |                                                     | Measured at 1 kHz, DAC at midscale, PVDD = 5 V                                         | 260   |     |      |            |
|                              | Power supply rejection ratio (ac)                   | 200-mV 50-Hz to 60-Hz sine wave superimposed on power supply voltage, DAC at midscale. | 85    |     |      | dB         |
|                              | Code change glitch impulse                          | Midcode ±1 LSB (including feedthrough)                                                 | 4.5   |     |      | nV-s       |
|                              | Code change glitch magnitude                        | Midcode ±1 LSB (including feedthrough), PVDD = 5 V                                     | 1.5   |     |      | mV         |
|                              | Digital feedthrough                                 | At SCLK = 1 MHz, DAC output at midscale                                                | 1     |     |      | nV-s       |

## 5.5 Electrical Characteristics (continued)

all minimum and maximum values at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and all typical values at  $T_A = 25^{\circ}\text{C}$ ,  $\text{PVDD} = \text{IOVDD} = 3.3\text{ V}$ , external or internal  $\text{VREFIO} = 1.25\text{ V}$ ,  $R_{\text{LOAD}} = 50\text{ k}\Omega$  to GND,  $C_{\text{LOAD}} = 100\text{ pF}$  to GND, and digital inputs at IOVDD or GND (unless otherwise noted)

| PARAMETER                              |                                          | TEST CONDITIONS                                                       | MIN    | TYP        | MAX    | UNIT                    |
|----------------------------------------|------------------------------------------|-----------------------------------------------------------------------|--------|------------|--------|-------------------------|
| <b>VOUT DAC OUTPUT CHARACTERISTICS</b> |                                          |                                                                       |        |            |        |                         |
|                                        | Output voltage                           |                                                                       | 0      |            | 2.5    | V                       |
|                                        | VOUT alarm output high                   |                                                                       | 2.35   | 2.5        | 2.65   | V                       |
|                                        | VOUT alarm output low                    |                                                                       | 0.285  | 0.3        | 0.315  | V                       |
| $R_{\text{LOAD}}$                      | Resistive load <sup>(2)</sup>            |                                                                       | 10     |            |        | k $\Omega$              |
| $C_{\text{LOAD}}$                      | Capacitive load <sup>(2)</sup>           |                                                                       |        |            | 100    | pF                      |
|                                        | Load regulation                          | DAC at midscale, $-1\text{ mA} \leq I_{\text{OUT}} \leq +1\text{ mA}$ |        | 10         |        | $\mu\text{V}/\text{mA}$ |
|                                        | Short-circuit current                    | Full-scale output shorted to GND                                      |        | 5          |        | mA                      |
|                                        |                                          | Zero output shorted to VDD                                            |        | 5          |        |                         |
|                                        | Output voltage headroom to PVDD          | DAC at full code, $I_{\text{OUT}} = 1\text{ mA}$ (sourcing)           | 200    |            |        | mV                      |
| $Z_O$                                  | Large signal dc output impedance         | To GND, DAC at code 0                                                 |        | 60         |        | $\Omega$                |
|                                        |                                          | DAC at midscale                                                       |        | 10         |        | m $\Omega$              |
|                                        |                                          | DAC at code 65535                                                     |        | 10         |        |                         |
|                                        |                                          | Output Hi-Z                                                           |        | 500        |        | k $\Omega$              |
|                                        | Power supply rejection ratio (dc)        | DAC at midscale                                                       |        | 0.1        |        | mV/V                    |
|                                        | Output voltage drift vs time, ideal VREF | $T_A = 35^{\circ}\text{C}$ , VOUT = midscale, 1000 hours              |        | $\pm 5$    |        | ppmFSR                  |
| <b>DIAGNOSTIC ADC</b>                  |                                          |                                                                       |        |            |        |                         |
|                                        | Input voltage                            |                                                                       | 0      |            | 2.5    | V                       |
|                                        | Resolution                               |                                                                       |        | 12         |        | Bits                    |
| DNL                                    | Differential nonlinearity                | Specified 12-bit monotonic                                            | -1     | $\pm 0.2$  | 1      | LSB                     |
| INL                                    | Integral nonlinearity                    |                                                                       | -4     | $\pm 1$    | 4      | LSB                     |
|                                        | Offset error                             | After calibration                                                     | -10    | $\pm 1.6$  | 10     | LSB                     |
|                                        | Gain error                               |                                                                       | -0.8   | $\pm 0.13$ | 0.8    | %FSR                    |
|                                        | Noise                                    |                                                                       |        | $\pm 4$    |        | LSB                     |
|                                        | Input capacitance                        |                                                                       |        | 6          |        | pF                      |
|                                        | Input bias current                       | ADC not converting                                                    | -50    |            | 50     | nA                      |
|                                        | Acquisition time                         |                                                                       |        | 52         |        | $\mu\text{s}$           |
|                                        | Conversion time                          |                                                                       |        | 210        |        | $\mu\text{s}$           |
|                                        | Conversion rate                          |                                                                       |        |            | 3.84   | kSPS                    |
|                                        | Temperature sensor accuracy              |                                                                       |        | 5          |        | $^{\circ}\text{C}$      |
| <b>INTERNAL OSCILLATOR</b>             |                                          |                                                                       |        |            |        |                         |
|                                        | Frequency                                | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                 | 1.2165 | 1.2288     | 1.2411 | MHz                     |

## 5.5 Electrical Characteristics (continued)

all minimum and maximum values at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and all typical values at  $T_A = 25^{\circ}\text{C}$ ,  $\text{PVDD} = \text{IOVDD} = 3.3\text{ V}$ , external or internal  $\text{VREFIO} = 1.25\text{ V}$ ,  $R_{\text{LOAD}} = 50\text{ k}\Omega$  to GND,  $C_{\text{LOAD}} = 100\text{ pF}$  to GND, and digital inputs at IOVDD or GND (unless otherwise noted)

| PARAMETER                      |                                             | TEST CONDITIONS                                               | MIN   | TYP  | MAX   | UNIT             |
|--------------------------------|---------------------------------------------|---------------------------------------------------------------|-------|------|-------|------------------|
| VOLTAGE REFERENCE INPUT        |                                             |                                                               |       |      |       |                  |
| Z <sub>VREFIO</sub>            | Reference input impedance (VREFIO)          |                                                               |       | 125  |       | kΩ               |
| C <sub>VREFIO</sub>            | Reference input capacitance (VREFIO)        |                                                               |       | 100  |       | pF               |
| VOLTAGE REFERENCE OUTPUT       |                                             |                                                               |       |      |       |                  |
|                                | Output (initial accuracy) <sup>(3)</sup>    | T <sub>A</sub> = 25°C                                         | 1.248 | 1.25 | 1.252 | V                |
|                                | Output drift <sup>(3)</sup>                 | T <sub>A</sub> = −40°C to +125°C                              |       |      | 10    | ppm/°C           |
|                                | Output impedance <sup>(3)</sup>             |                                                               |       | 0.1  |       | Ω                |
|                                | Output noise <sup>(3)</sup>                 | 0.1 Hz to 10 Hz                                               |       | 7.5  |       | μV <sub>PP</sub> |
|                                | Output noise density <sup>(3)</sup>         | Measured at 10 kHz, reference load = 100 nF                   |       | 200  |       | nV/√Hz           |
|                                | Load current <sup>(3)</sup>                 | Sourcing, 0.1% VREF change from nominal                       |       | 2.5  |       | mA               |
|                                |                                             | Sinking, 0.1% VREF change from nominal                        |       |      | 0.3   |                  |
|                                | Load regulation <sup>(3)</sup>              | Sourcing, 0 mA to 2.5 mA                                      |       | 4    |       | μV/mA            |
| C <sub>OUT</sub>               | Stable output capacitance                   | T <sub>A</sub> = −40°C to +125°C,<br>ESR from 10 mΩ to 400 mΩ | 70    | 100  | 130   | nF               |
|                                | Line regulation <sup>(3)</sup>              |                                                               |       | 100  |       | μV/V             |
|                                | Output voltage drift vs time <sup>(3)</sup> | T <sub>A</sub> = 35°C, 1000 hours                             |       | ±100 |       | ppm              |
|                                | Thermal hysteresis <sup>(3)</sup>           | 1st cycle                                                     |       | 500  |       | μV               |
|                                |                                             | Additional cycles                                             |       | 25   |       | μV               |
| VDD VOLTAGE REGULATOR OUTPUT   |                                             |                                                               |       |      |       |                  |
|                                | Output voltage                              |                                                               | 1.71  | 1.8  | 1.89  | V                |
|                                | Output impedance <sup>(3)</sup>             | Sourcing, 0.5 mA to 2.5 mA                                    |       | 3    |       | Ω                |
|                                | Load current <sup>(3)</sup>                 | Sourcing, 1% VDD change from nominal                          |       | 4    |       | mA               |
| THERMAL ALARM                  |                                             |                                                               |       |      |       |                  |
|                                | Alarm trip point                            |                                                               |       | 130  |       | °C               |
|                                | Warning trip point                          |                                                               |       | 85   |       | °C               |
|                                | Hysteresis                                  |                                                               |       | 12   |       | °C               |
|                                | Trip point absolute accuracy                |                                                               |       | 5    |       | °C               |
|                                | Trip point relative accuracy                |                                                               |       | 2    |       | °C               |
| DIGITAL INPUT CHARACTERISTICS  |                                             |                                                               |       |      |       |                  |
| V <sub>IH</sub>                | High-level input voltage                    |                                                               | 0.7   |      |       | V/IOVDD          |
| V <sub>IL</sub>                | Low-level input voltage                     |                                                               |       |      | 0.3   | V/IOVDD          |
|                                | Hysteresis voltage                          |                                                               | 0.05  |      |       | V/IOVDD          |
|                                | Input current                               |                                                               | −1.56 |      | 1.56  | μA               |
|                                | Pin capacitance                             | Per pin                                                       |       | 10   |       | pF               |
| DIGITAL OUTPUT CHARACTERISTICS |                                             |                                                               |       |      |       |                  |
| V <sub>OH</sub>                | High-level output voltage                   | I <sub>SOURCE</sub> = 1 mA                                    | 0.8   |      |       | V/IOVDD          |
| V <sub>OL</sub>                | Low-level output voltage                    | I <sub>SINK</sub> = 1 mA                                      |       |      | 0.2   | V/IOVDD          |
| V <sub>OL</sub>                | Open-drain low-level output voltage         | I <sub>SINK</sub> = 2 mA                                      |       |      | 0.3   | V                |
|                                | Output pin capacitance                      |                                                               |       | 10   |       | pF               |

## 5.5 Electrical Characteristics (continued)

all minimum and maximum values at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and all typical values at  $T_A = 25^{\circ}\text{C}$ ,  $\text{PVDD} = \text{IOVDD} = 3.3\text{ V}$ , external or internal  $\text{VREFIO} = 1.25\text{ V}$ ,  $R_{\text{LOAD}} = 50\text{ k}\Omega$  to GND,  $C_{\text{LOAD}} = 100\text{ pF}$  to GND, and digital inputs at IOVDD or GND (unless otherwise noted)

| PARAMETER                 |                                        | TEST CONDITIONS               | MIN | TYP | MAX | UNIT          |
|---------------------------|----------------------------------------|-------------------------------|-----|-----|-----|---------------|
| <b>POWER REQUIREMENTS</b> |                                        |                               |     |     |     |               |
| $I_{\text{PVDD}}$         | Current flowing into PVDD              | DAC at zero-scale, SPI static |     | 170 | 210 | $\mu\text{A}$ |
| $I_{\text{REFIO}}$        | Internal reference current consumption |                               |     | 52  | 70  | $\mu\text{A}$ |
| $I_{\text{ADC}}$          | ADC current consumption                | ADC converting at 3.84 kSPS   |     | 10  |     | $\mu\text{A}$ |
| $C_{\text{VDD}}$          | Recommended VDD decoupling capacitance |                               | 1   |     | 10  | $\mu\text{F}$ |
| $I_{\text{IOVDD}}$        | Current flowing into IOVDD             | SPI static                    |     | 10  | 25  | $\mu\text{A}$ |
| $I_{\text{VREFIO}}$       | Current flowing into VREFIO            | DAC at midscale code          |     | 10  |     | $\mu\text{A}$ |

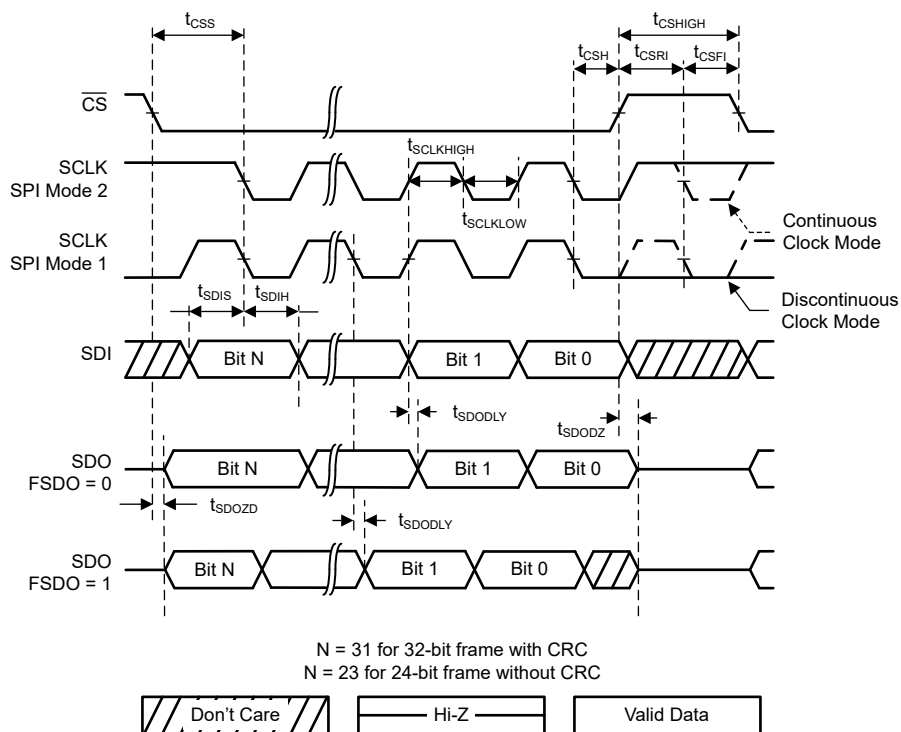
- (1) End point fit between code 512 to code 65,535 for 16-bit, code 128 to code 16,383 for 14-bit, DAC output unloaded, performance under resistive and capacitive load conditions are specified by design and characterization.
- (2) Not production tested. Design target.
- (3) Not production tested. Derived from the characterization data.

## 5.6 Timing Requirements

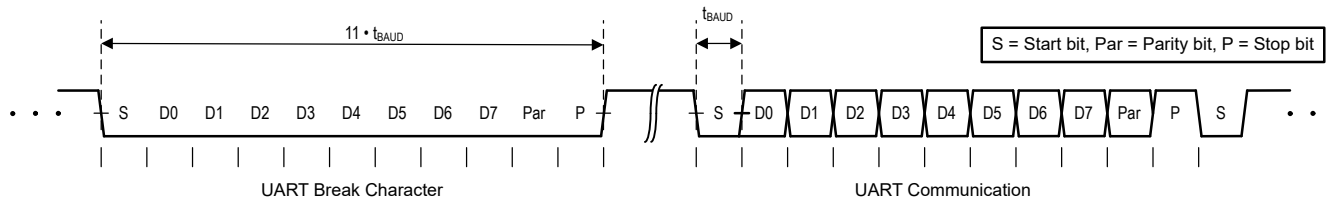
all input signals are specified with  $t_R = t_F = 1 \text{ ns/V}$  and timed from a voltage level of  $(V_{IL} + V_{IH}) / 2$ ,  $2.7 \text{ V} \leq \text{PVDD} \leq 5.5 \text{ V}$ ,  $V_{IH} = 1.62 \text{ V}$ ,  $V_{IL} = 0.15 \text{ V}$ ,  $V_{REFIO} = 1.25 \text{ V}$  and  $T_A = -40^\circ\text{C}$  to  $+125^\circ\text{C}$  (unless otherwise noted)

| PARAMETER                                          |                                                                          | MIN | NOM | MAX  | UNIT          |
|----------------------------------------------------|--------------------------------------------------------------------------|-----|-----|------|---------------|
| <b>SERIAL INTERFACE - WRITE AND READ OPERATION</b> |                                                                          |     |     |      |               |
| $f_{\text{SCLK}}$                                  | Serial clock frequency                                                   |     |     | 12.5 | MHz           |
| $t_{\text{SCLKHIGH}}$                              | SCLK high time                                                           | 36  |     |      | ns            |
| $t_{\text{SCLKLOW}}$                               | SCLK low time                                                            | 36  |     |      | ns            |
| $t_{\text{CSHIGH}}$                                | $\overline{\text{CS}}$ high time                                         | 80  |     |      | ns            |
| $t_{\text{CSS}}$                                   | $\overline{\text{CS}}$ to SCLK falling edge setup time                   | 30  |     |      | ns            |
| $t_{\text{CSH}}$                                   | SCLK falling edge to $\overline{\text{CS}}$ rising edge                  | 30  |     |      | ns            |
| $t_{\text{CSRI}}$                                  | $\overline{\text{CS}}$ rising edge to SCLK falling edge ignore           | 30  |     |      | ns            |
| $t_{\text{CSFI}}$                                  | SCLK falling edge ignore to $\overline{\text{CS}}$ falling edge          | 5   |     |      | ns            |
| $t_{\text{SDIS}}$                                  | SDI setup time                                                           | 5   |     |      | ns            |
| $t_{\text{SDIH}}$                                  | SDI hold time                                                            | 5   |     |      | ns            |
| $t_{\text{SDOZD}}$                                 | $\overline{\text{CS}}$ falling edge to SDO tri-state condition to driven |     |     | 40   | ns            |
| $t_{\text{SDODZ}}$                                 | $\overline{\text{CS}}$ rising edge to SDO driven to tri-state condition  |     |     | 40   | ns            |
| $t_{\text{SDODLY}}$                                | SCLK to SDO output delay                                                 |     |     | 40   | ns            |
| <b>UART</b>                                        |                                                                          |     |     |      |               |
| $t_{\text{BAUDUART}}$                              | Baud rate = 9600 $\pm$ 1%                                                |     | 104 |      | $\mu\text{s}$ |
| <b>DIGITAL LOGIC</b>                               |                                                                          |     |     |      |               |
| $t_{\text{DACWAIT}}$                               | Sequential DAC update wait time                                          | 2.1 |     |      | $\mu\text{s}$ |
| $t_{\text{POR}}$                                   | POR reset delay                                                          |     |     | 100  | $\mu\text{s}$ |
| $t_{\text{RESET}}$                                 | RESET pulse duration                                                     | 100 |     |      | ns            |
| $t_{\text{RESETWAIT}}$                             | Wait time after RESET pulse                                              | 10  |     |      | $\mu\text{s}$ |
| $t_{\text{PULSE\_GPIO}}$                           | GPIO input pulse duration                                                | 10  |     |      | ns            |

## 5.7 Timing Diagrams



**Figure 5-1. SPI Timing**



**Figure 5-2. UBM Timing**

## 5.8 Typical Characteristics: VOUT DAC

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = 2.7\text{ V}$ ,  $IOVDD = 1.8\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)

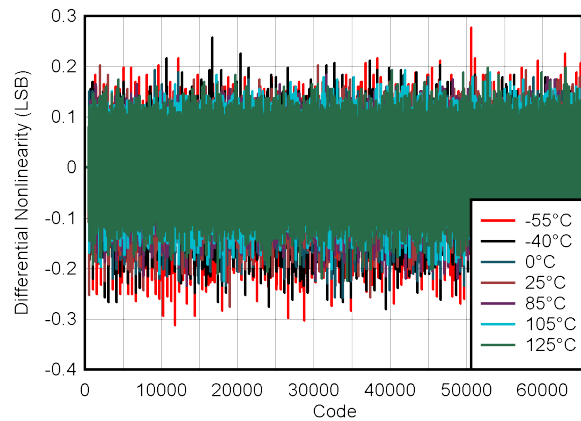


Figure 5-3. DAC DNL vs Digital Input Code

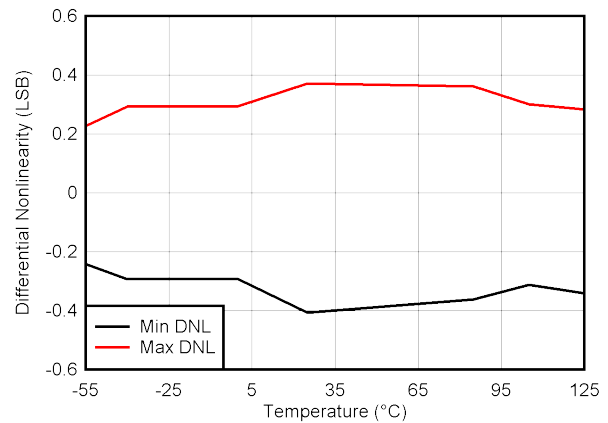


Figure 5-4. MIN and MAX DAC DNL Range vs Temperature

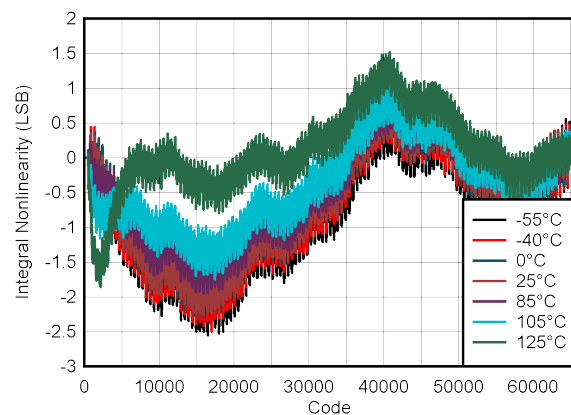


Figure 5-5. DAC INL vs Digital Input Code

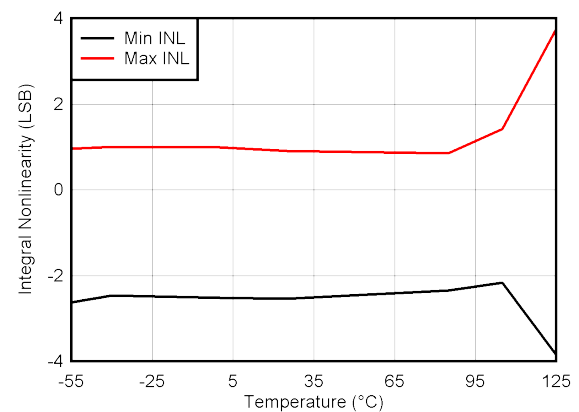


Figure 5-6. MIN and MAX DAC INL Range vs Temperature

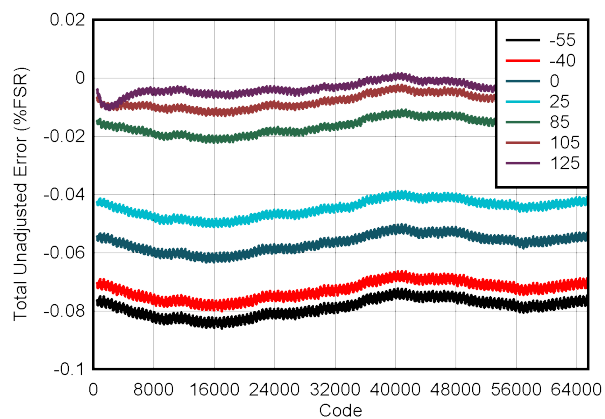


Figure 5-7. DAC TUE vs Digital Input Code

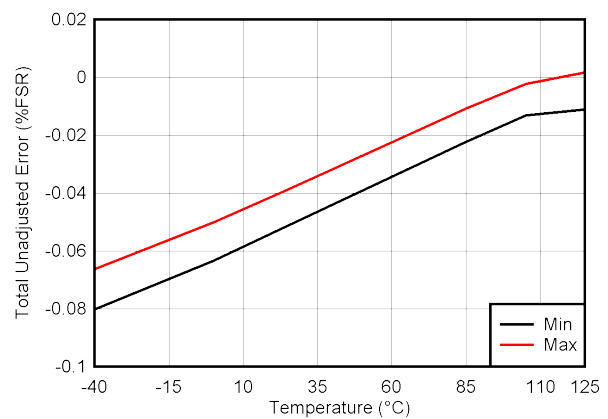
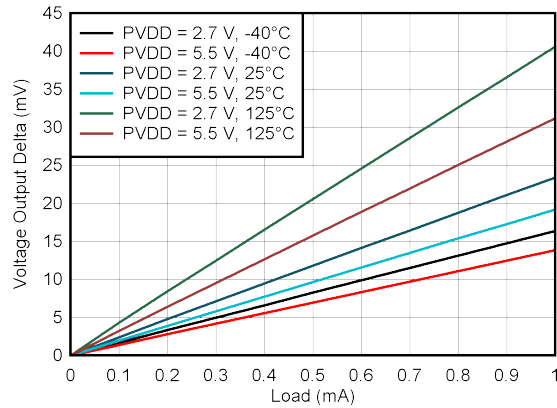


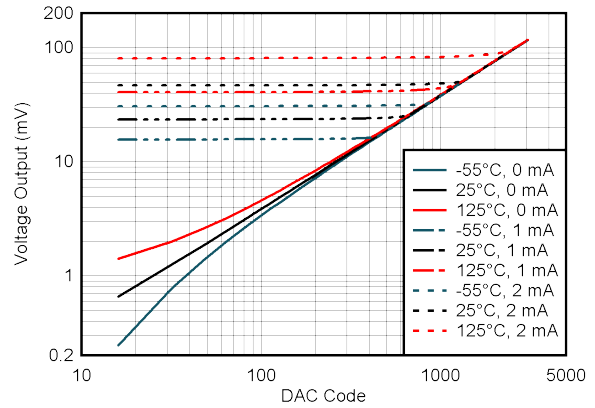
Figure 5-8. MIN and MAX DAC TUE vs Temperature

## 5.8 Typical Characteristics: VOUT DAC (continued)

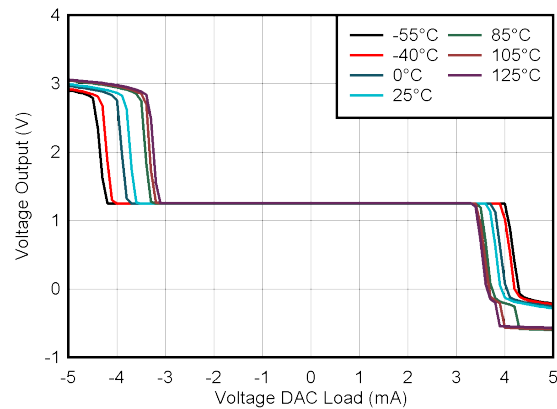
at  $T_A = 25^\circ\text{C}$ ,  $PVDD = 2.7\text{ V}$ ,  $IOVDD = 1.8\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)



**Figure 5-9. Zero-code Impedance**

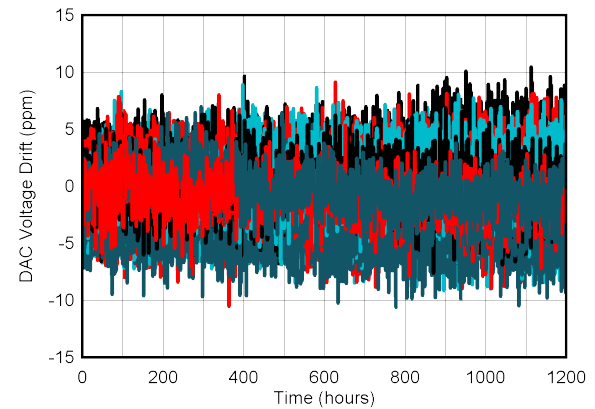


**Figure 5-10. DAC Footroom Over Temperature and Load**



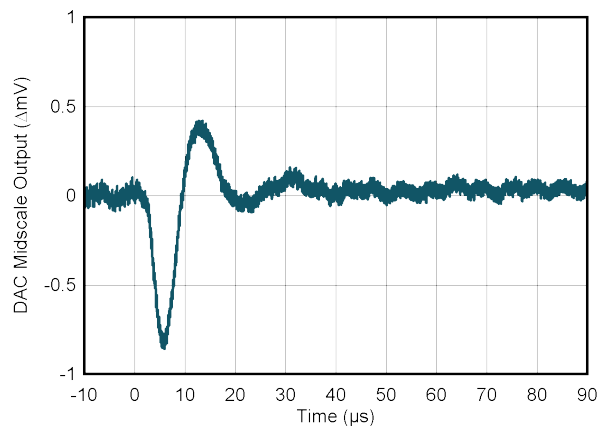
DAC at midcode

**Figure 5-11. DAC Source and Sink Current Capability**



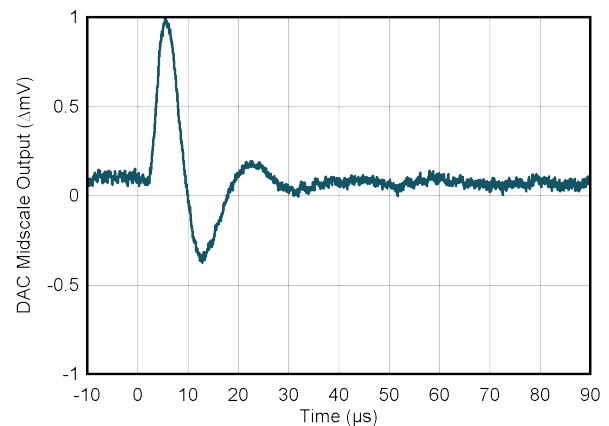
Ideal reference

**Figure 5-12. DAC Output Voltage Long-Term Stability**



$PVDD = 5.5\text{ V}$

**Figure 5-13. DAC Glitch Impulse Rising Edge**



$PVDD = 5.5\text{ V}$

**Figure 5-14. DAC Glitch Impulse Falling Edge**

## 5.8 Typical Characteristics: VOUT DAC (continued)

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = 2.7\text{ V}$ ,  $IOVDD = 1.8\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)

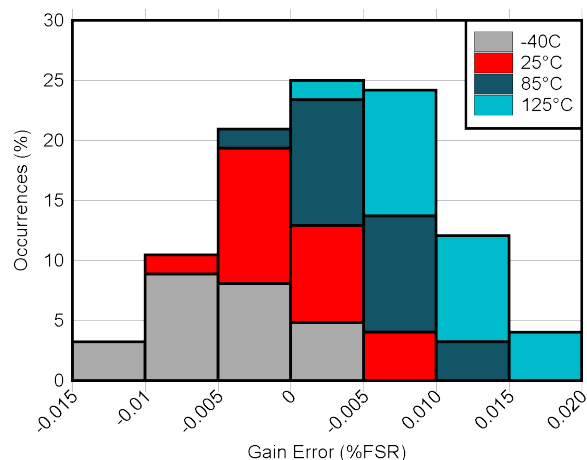


Figure 5-15. DAC Gain Error vs Temperature

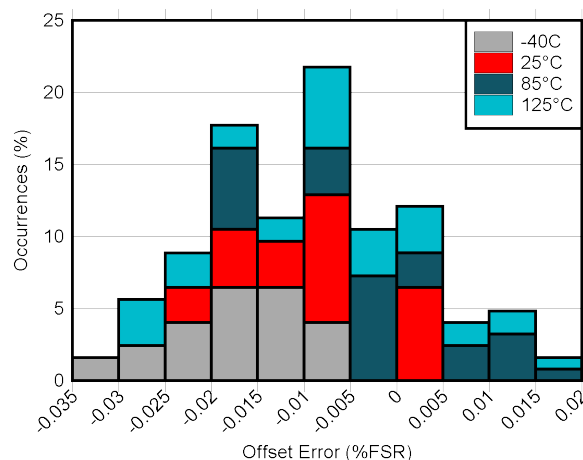


Figure 5-16. DAC Offset Error vs Temperature

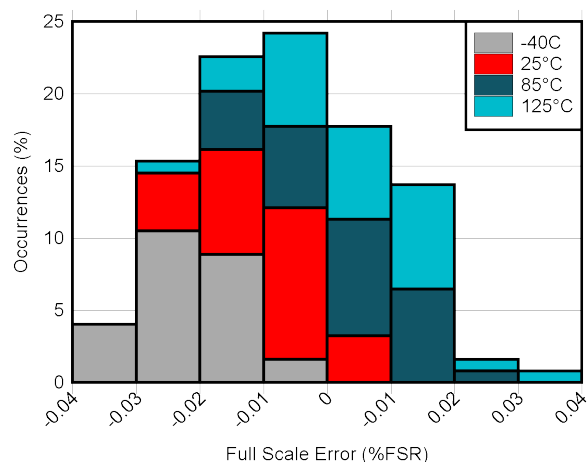


Figure 5-17. DAC Full Scale Error vs Temperature

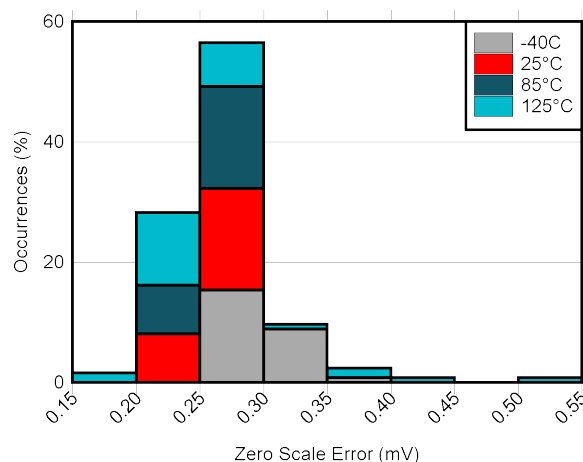
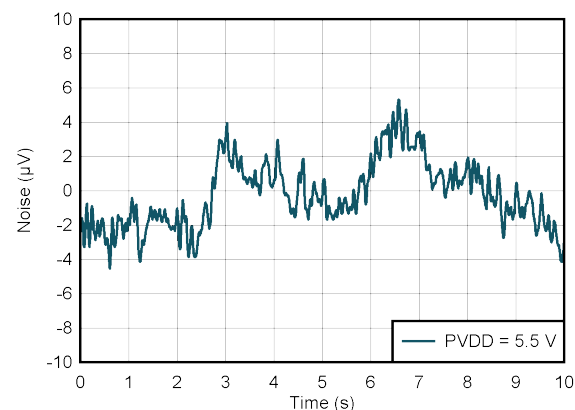
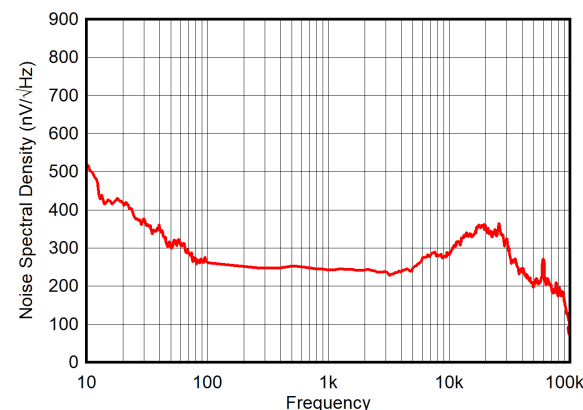


Figure 5-18. DAC Zero Scale Error vs Temperature



DAC at midcode PVDD = 5.5 V

Figure 5-19. DAC Output Noise, 0.1 Hz to 10 Hz



DAC at midcode PVDD = 5.5 V

Figure 5-20. DAC Output Noise Density vs Frequency

## 5.8 Typical Characteristics: VOUT DAC (continued)

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = 2.7\text{ V}$ ,  $IOVDD = 1.8\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)

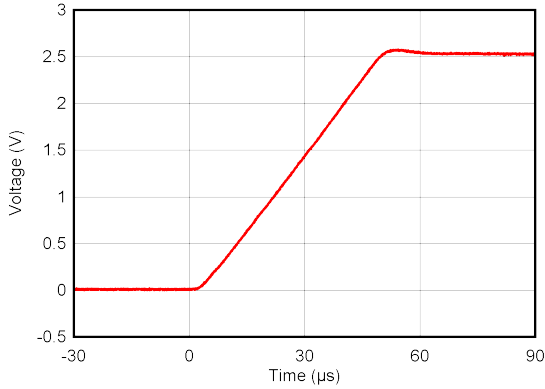


Figure 5-21. DAC Rising Settling Time

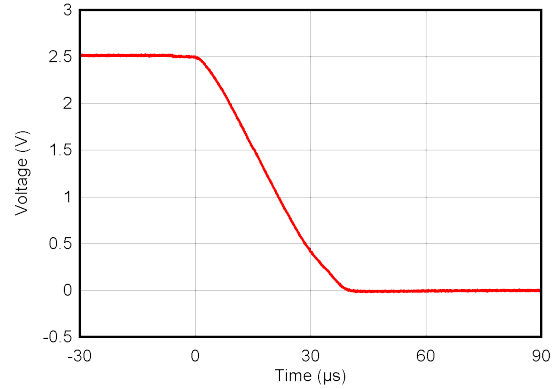


Figure 5-22. DAC Falling Settling Time

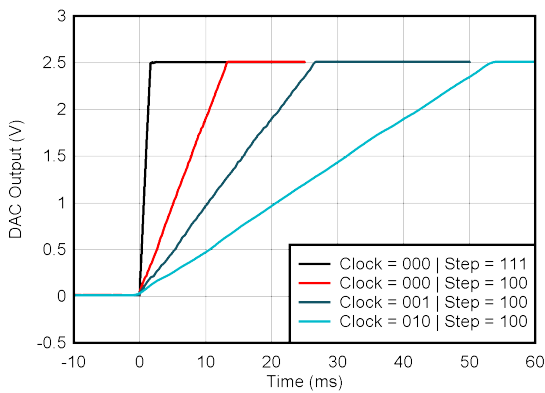


Figure 5-23. DAC Settling Time With Linear Slew Rate Control

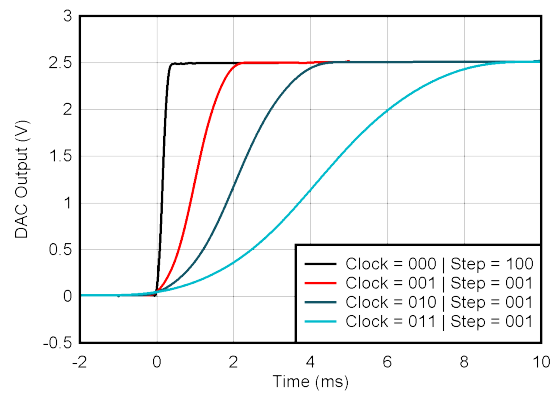


Figure 5-24. DAC Settling Time With Sinusoidal Slew Rate Control

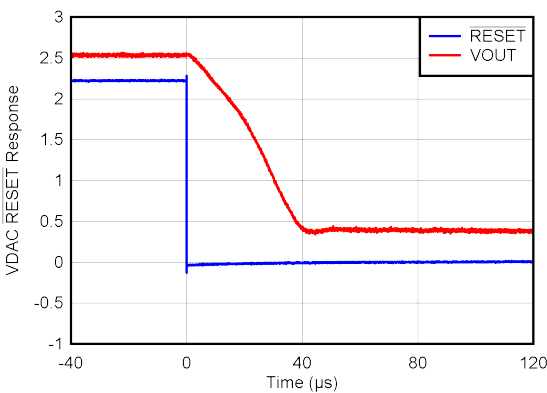


Figure 5-25. DAC  $\overline{\text{RESET}}$  Response

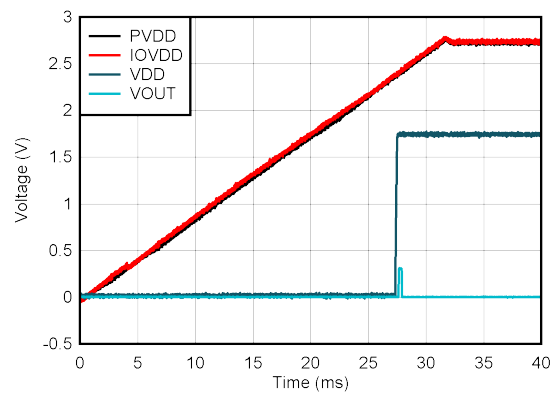
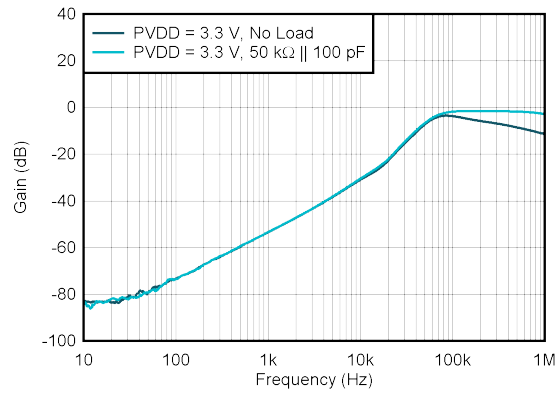


Figure 5-26. DAC Supply Power On,  $PVDD = 2.7\text{ V}$

## 5.8 Typical Characteristics: VOUT DAC (continued)

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = 2.7\text{ V}$ ,  $IOVDD = 1.8\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)



Internal reference

**Figure 5-27. DAC AC PSRR vs Frequency**

## 5.9 Typical Characteristics: ADC

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = 3.3\text{ V}$ ,  $IOVDD = 1.8\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)

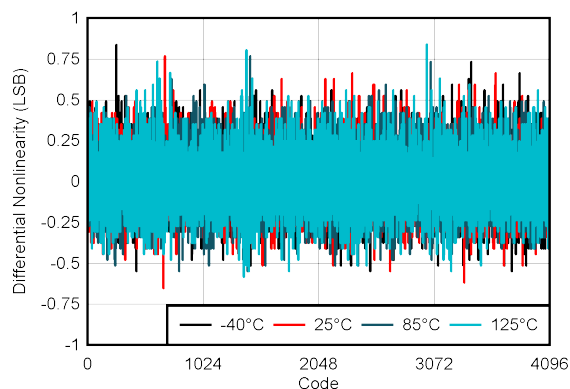


Figure 5-28. ADC DNL vs Digital Input Code

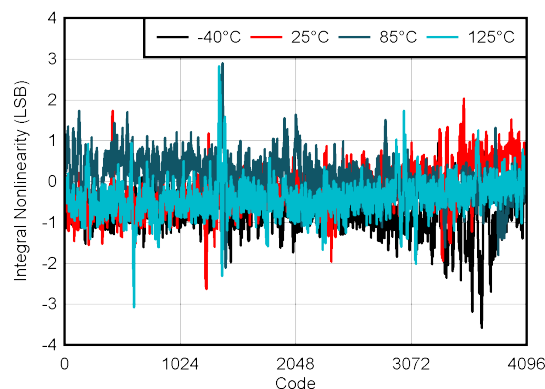


Figure 5-29. ADC INL vs Digital Input Code

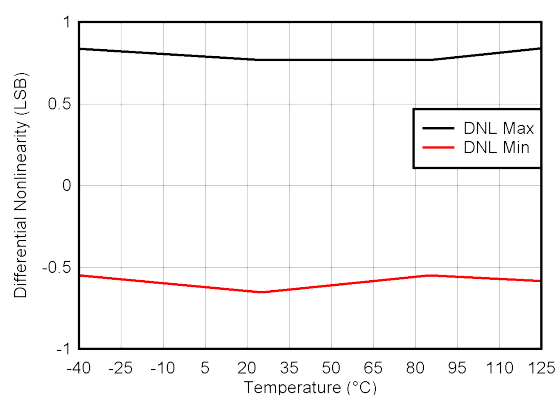


Figure 5-30. ADC DNL Range vs Temperature

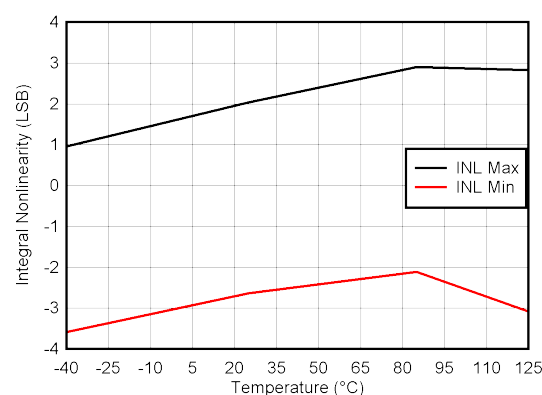


Figure 5-31. ADC INL Range vs Temperature

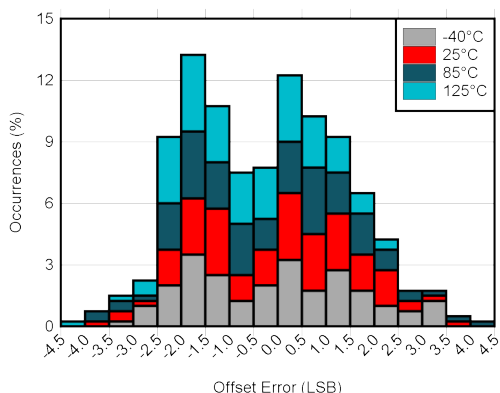


Figure 5-32. ADC Offset Error vs Temperature

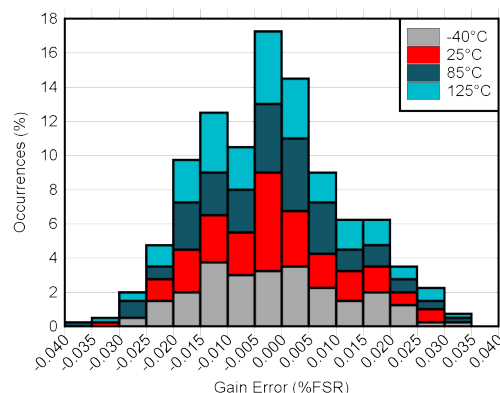
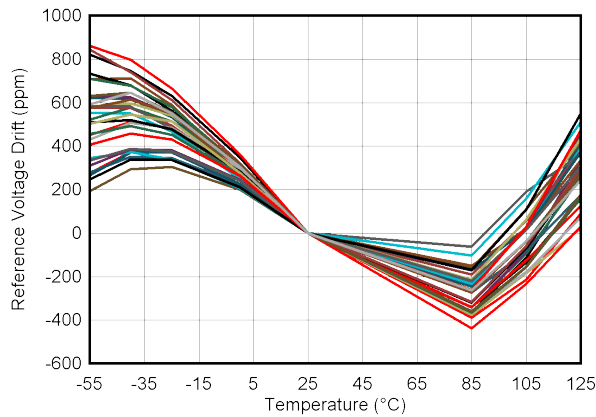


Figure 5-33. ADC Gain Error vs Temperature

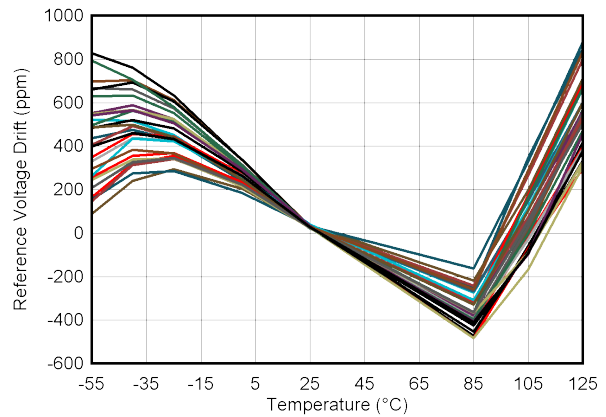
## 5.10 Typical Characteristics: Reference

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = IOVDD = 3.3\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at IOVDD or GND (unless otherwise noted)



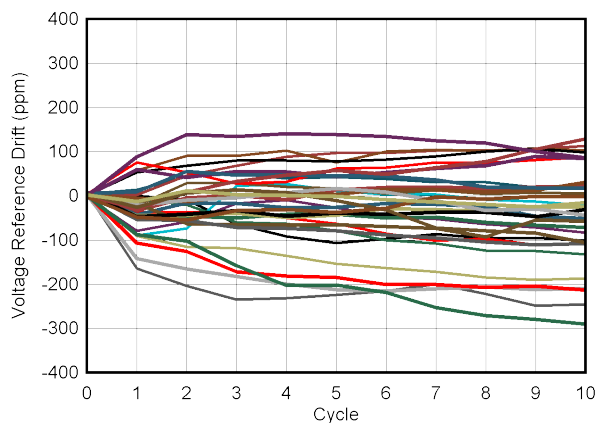
Pre-soldered 30 units

**Figure 5-34. Reference Voltage Temperature Drift**



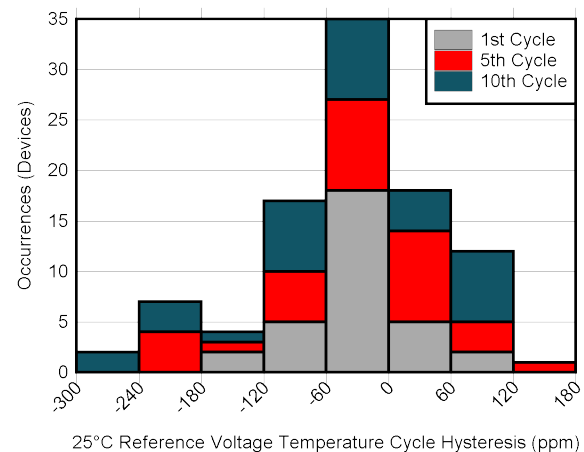
Post-soldered 30 units

**Figure 5-35. Reference Voltage Temperature Drift**



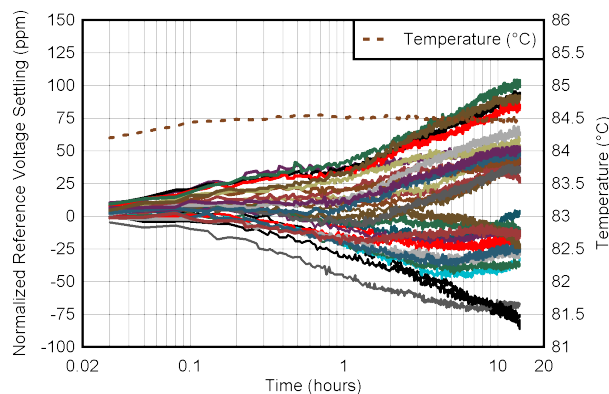
–40°C to +85°C cycles, 60 minutes per cycle, 30 units

**Figure 5-36. Multiple Temperature Cycle Hysteresis**



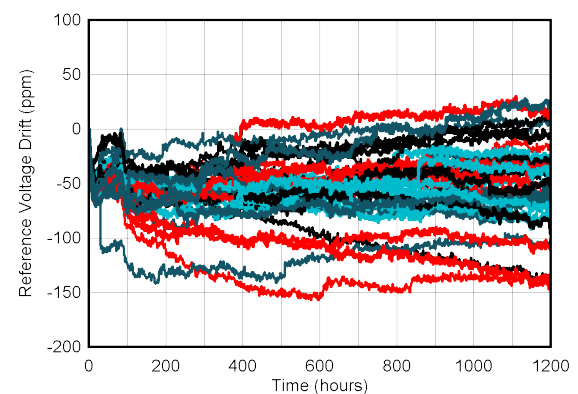
–40°C to +85°C cycles, 60 minutes per cycle

**Figure 5-37. Multiple Temperature Cycle Hysteresis**



Two minutes after 25°C to 85°C temperature step, 30 units

**Figure 5-38. Ambient Temperature Change Settling**

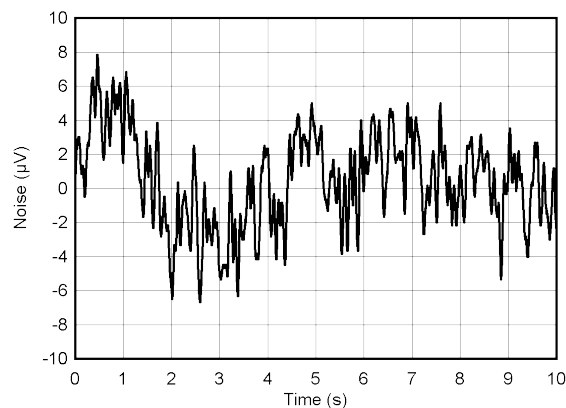


30 units

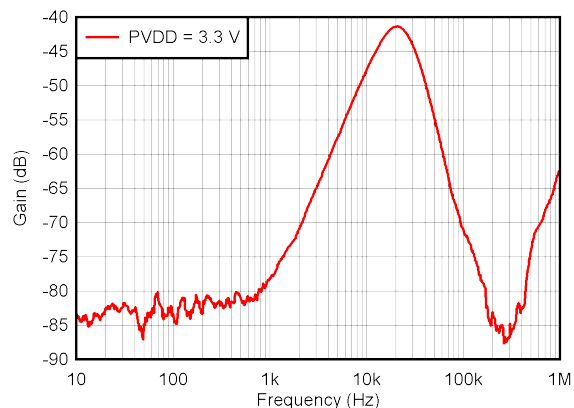
**Figure 5-39. Reference Voltage Long-Term Stability**

## 5.10 Typical Characteristics: Reference (continued)

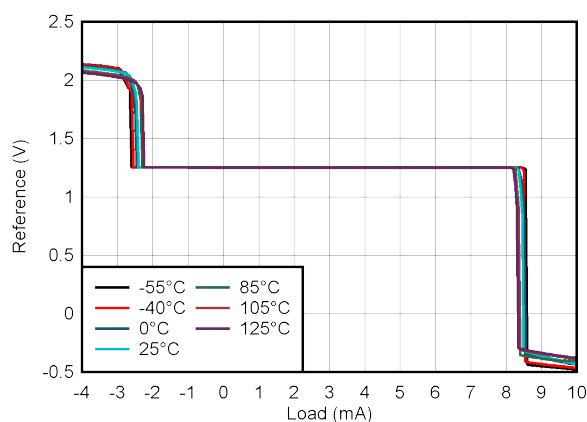
at  $T_A = 25^\circ\text{C}$ ,  $PVDD = IOVDD = 3.3\text{ V}$ , external or internal  $VREFIO = 1.25\text{ V}$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at IOVDD or GND (unless otherwise noted)



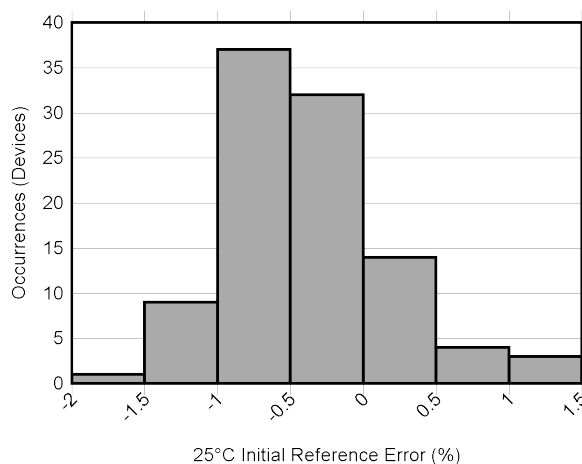
**Figure 5-40. Reference Output Noise, 0.1 Hz to 10 Hz**



**Figure 5-41. Reference AC PSRR vs frequency**



**Figure 5-42. Reference Source and Sink Current Capability**



**Figure 5-43. Initial Accuracy Distribution**

## 5.11 Typical Characteristics: Power Supply

at  $T_A = 25^\circ\text{C}$ ,  $PVDD = IOVDD = 3.3\text{ V}$ , internal  $VREFIO$ ,  $R_{LOAD} = 50\text{ k}\Omega$  to GND,  $C_{LOAD} = 100\text{ pF}$  to GND, and digital inputs at  $IOVDD$  or GND (unless otherwise noted)

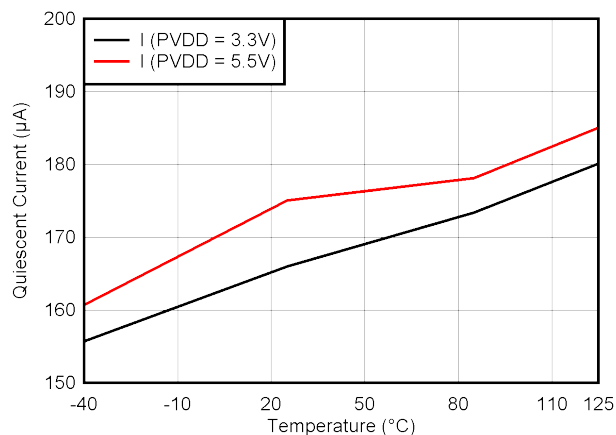


Figure 5-44. PVDD Supply Current vs Temperature

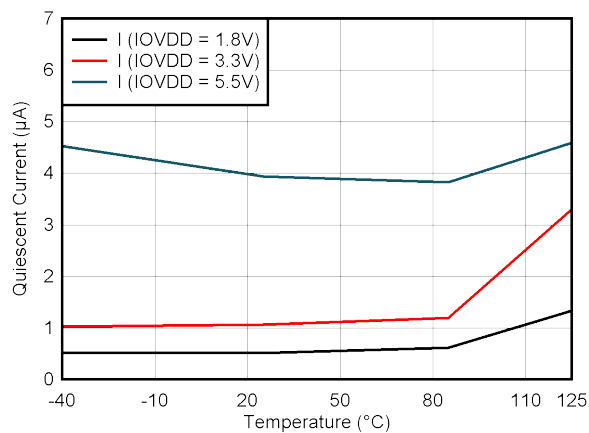


Figure 5-45. IOVDD Supply Current vs Temperature

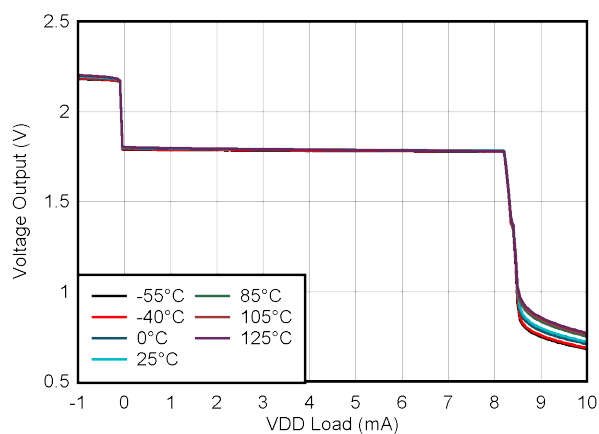


Figure 5-46. VDD Voltage vs Load Current

## 6 Detailed Description

### 6.1 Overview

The AFEx8201 feature a 16-bit (AFE88201) or 14-bit (AFE78201) string DAC with voltage output buffer. Both devices have a buffered voltage output and are designed for use in three-wire or four-wire sensor transmitters or analog output modules. The DAC has calibration registers for setting gain and offset values for adjusting the DAC outputs. The DAC also has different output slewing modes that allow for a programmable linear slew and a sinusoidal shaped output slew.

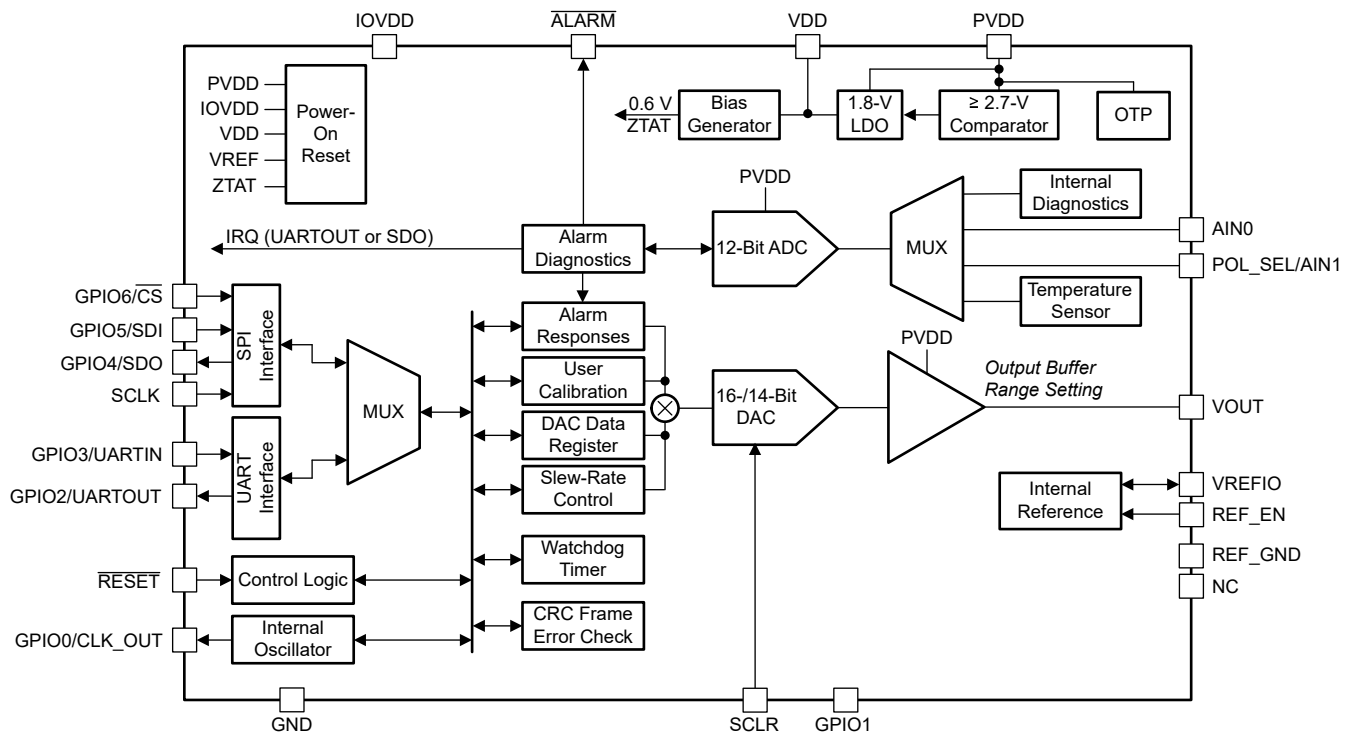
The AFEx8201 also feature a 12-bit SAR ADC that can be multiplexed to measure different inputs, including external nodes and internal nodes for diagnostic measurements on the device. The ADC is capable of making direct-mode measurements with on-demand conversions or auto-mode measurements through continuous conversions using a channel sequencer with a multiplexer. The devices have optional alarm configurations with fault detection and alarm actions.

Device communication and programming are done through an SPI or through the UART break mode (UBM). With the SPI, a cyclic redundancy check (CRC) is implemented by default, which can be disabled. Additionally, communications can be monitored with a watchdog timer (WDT) that alerts the user if the device becomes unresponsive to periodic communication.

The AFEx8201 feature a 1.25-V, onboard precision voltage reference, and an integrated precision oscillator.

Throughout this data sheet, register and bit names are combined with a period to use the following format: <register\_name>.<bit\_name>. For example, the CLR bit in the DAC\_CFG register is labeled DAC\_CFG.CLR.

### 6.2 Functional Block Diagram



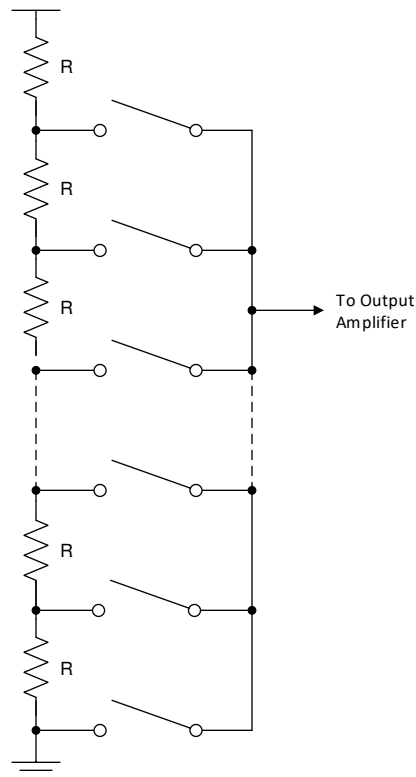
## 6.3 Feature Description

### 6.3.1 Digital-to-Analog Converter (DAC) Overview

The AFE<sub>x</sub>8201 feature a 16-bit (AFE88201) or 14-bit (AFE78201) string DAC followed by an output voltage buffer. Using an external circuit, the device output voltage can be translated to different output voltages and output currents for use in 3-wire or 4-wire sensor transmitters or analog output modules. The DAC is configured to support a 0-V to 2.5-V range of operation. The alarm function is triggered when PVDD exceeds the valid configuration range of 2.7 V to 5.5 V; see also [Table 6-5](#).

#### 6.3.1.1 DAC Resistor String

[Figure 6-1](#) shows that the resistor string structure consists of a series of resistors, each of value  $R$ . The code loaded to the DAC determines the node on the string at which the voltage is tapped off to be fed into the output amplifier. The voltage is tapped off by closing one of the switches connecting the string to the amplifier. The resistor string architecture has inherent monotonicity, voltage output, and low glitch.



**Figure 6-1. DAC Resistor String**

#### 6.3.1.2 DAC Buffer Amplifier

The VOUT output pin is driven by the DAC output buffer amplifier. The output amplifier default settings are designed to drive capacitive loads as high as 100 pF without oscillation. The output buffer is able to source and sink 1 mA. The device implements short-circuit protection for momentary output shorts to ground and VDD supply. The source and sink short-circuit current thresholds are set to 5 mA.

### 6.3.1.3 DAC Transfer Function

The following equation describes the DAC transfer function, which is the relationship between internal signal DAC\_CODE and output voltage VOUT:

$$VOUT = \frac{DAC\_CODE}{2^N} \times FSR \quad (1)$$

where

- DAC\_CODE is an internal signal and the decimal equivalent of the gain and offset calibrated binary code loaded into the DAC\_DATA register. DAC\_CODE range = 0 to  $2^N - 1$ .
- N = DAC\_CODE resolution in bits (16 for the AFE88201 and 14 for the AFE78201).
- FSR = VOUT full-scale range = 2.5 V.

### 6.3.1.4 DAC Gain and Offset Calibration

The AFEx8201 provide DAC gain and offset calibration capability to correct for end-point errors present in the system. Implement the gain and offset calibration using two registers, DAC\_GAIN.GAIN and DAC\_OFFSET.OFFSET. Update DAC\_DATA register after gain or offset codes are changed for the new values to take effect. The DAC\_GAIN can be programmed from 0.5 to 1.499985 using [Equation 2](#).

$$DAC\_GAIN = \frac{1}{2} + \frac{GAIN}{2^N} \quad (2)$$

where

- N = DAC\_GAIN resolution in bits: 16 for the AFE88201 and 14 for the AFE78201.
- GAIN is the decimal value of the DAC\_GAIN register setting.
- GAIN data are left justified; the last two LSBs in the DAC\_GAIN register are ignored for the AFE78201.

The example DAC\_GAIN settings for the AFE88201 are shown in [Table 6-1](#).

**Table 6-1. DAC\_GAIN Setting vs GAIN Code**

| DAC_GAIN | GAIN (HEX) |
|----------|------------|
| 0.5      | 0x0000     |
| 1.0      | 0x8000     |
| 1.499985 | 0xFFFF     |

The DAC\_OFFSET is stored in the DAC\_OFFSET register using 2's-complement encoding. The DAC\_OFFSET value can be programmed from  $-2^{(N-1)}$  to  $2^{(N-1)} - 1$  using [Equation 3](#).

$$DAC\_OFFSET = -OFFSET_{MSB} \times 2^{(N-1)} + \sum_{i=0}^{(N-2)} OFFSET_i \times 2^i \quad (3)$$

where

- N = DAC\_OFFSET resolution in bits: 16 for the AFE88201 and 14 for the AFE78201.
- $OFFSET_{MSB}$  = MSB bit of the DAC\_OFFSET register.
- $OFFSET_i$  = The rest of the bits of the DAC\_OFFSET register.
- i = Position of the bit in the DAC\_OFFSET register.
- OFFSET data are left justified; the last two LSBs in the DAC\_OFFSET register are ignored for the device.

The most significant bit determines the sign of the number and is called the sign bit. The sign bit has the weight of  $-2^{(N-1)}$  as shown in [Equation 3](#).

The example DAC\_OFFSET settings for the AFE88201 are shown in [Table 6-2](#).

**Table 6-2. DAC\_OFFSET Setting vs OFFSET Code**

| DAC_OFFSET | OFFSET (HEX) |
|------------|--------------|
| 32767      | 0x7FFF       |
| 1          | 0x0001       |
| 0          | 0x0000       |
| -1         | 0xFFFF       |
| -2         | 0xFFFE       |
| -32768     | 0x8000       |

The following transfer function is applied to the DAC\_DATA.DATA based on the DAC\_GAIN and DAC\_OFFSET values:

$$\text{DAC\_CODE} = (\text{DATA} \times \text{DAC\_GAIN}) + \text{DAC\_OFFSET} \quad (4)$$

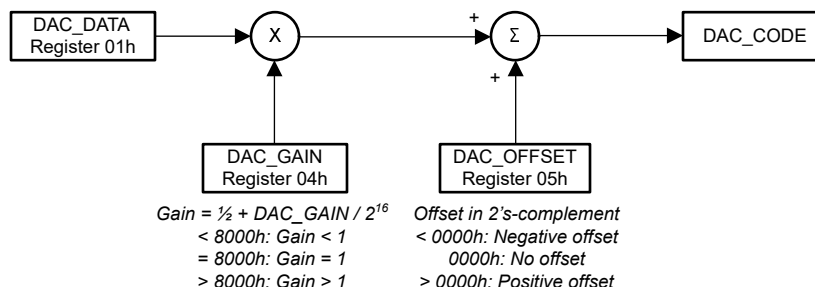
where

- DAC\_CODE is the internal signal applied to the DAC.
- DATA is the decimal value of the DAC\_DATA register.
- DAC\_GAIN and DAC\_OFFSET are the user calibration settings.
- DATA data are left justified; the last two LSBs in the DAC\_DATA register are ignored for the AFE78201.

Substituting DAC\_GAIN and DAC\_OFFSET in Equation 4 with Equation 2 and Equation 3 results in:

$$\text{DAC\_CODE} = \left( \text{DATA} \times \left[ \frac{1}{2} + \frac{\text{GAIN}}{2^N} \right] \right) - \text{OFFSET}_{\text{MSB}} \times 2^{(N-1)} + \sum_{i=0}^{(N-2)} \text{OFFSET}_i \times 2^i \quad (5)$$

The multiplier is implemented using truncation instead of rounding. This truncation can cause a difference of one LSB if rounding is expected. Figure 6-2 shows the DAC calibration path.

**Figure 6-2. DAC Calibration Path**

### 6.3.1.5 Programmable Slew Rate

The slew rate feature controls the rate at which the output voltage or current changes. This feature is disabled by default and is enabled by writing a logic 1 to the DAC\_CFG.SR\_EN bit. With the slew rate control feature disabled, the output changes smoothly at a rate limited by the output drive circuitry and the attached load.

With this feature enabled, the output does not slew directly between the two values. Instead, the output steps digitally at a rate defined by DAC\_CFG.SR\_STEP[2:0] and DAC\_CFG.SR\_CLK[2:0]. SR\_CLK defines the rate at which the digital slew updates. SR\_STEP defines the amount by which the output value changes at each update. The register descriptions show different settings for SR\_STEP and SR\_CLK.

The time required for the output to slew is expressed as [Equation 6](#):

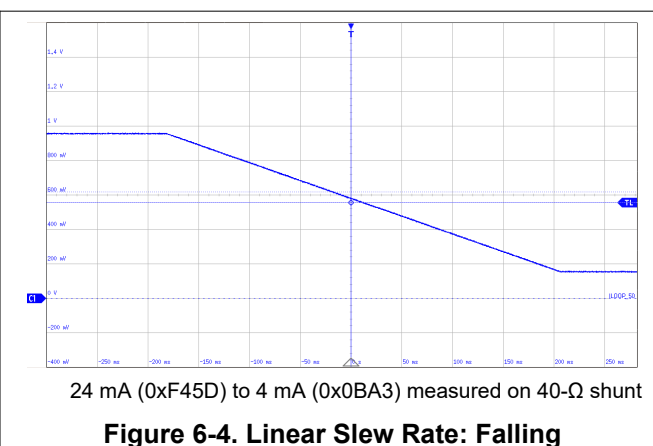
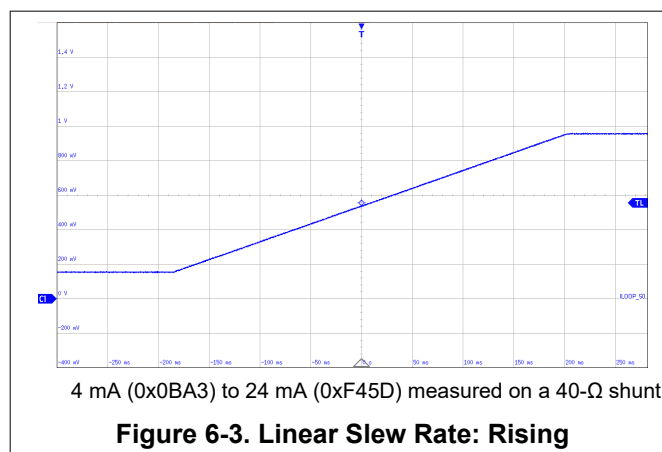
$$\text{Slew Time} = \frac{\text{Delta Code Change}}{\text{Slew Step} \times \text{Slew Clock Rate}} \quad (6)$$

where

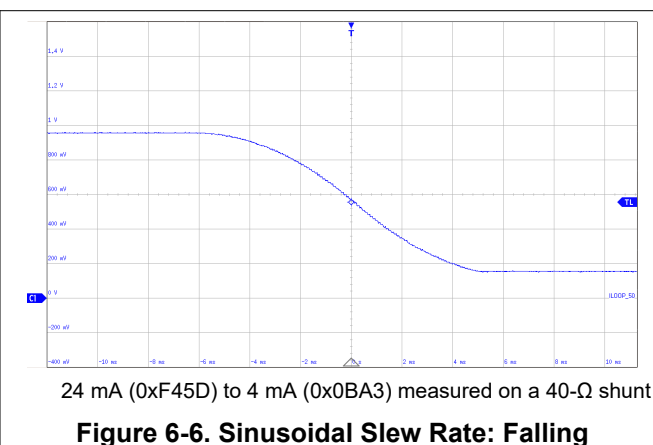
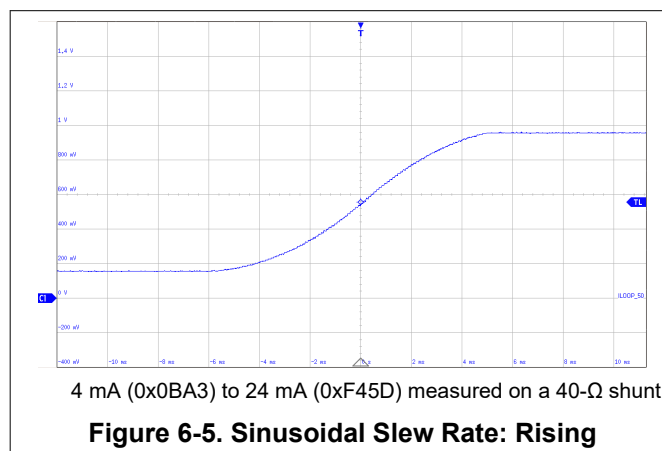
- *Slew Time* is expressed in seconds
- *Slew Step* is controlled by DAC\_CFG.SR\_STEP
- *Slew Clock Rate* is controlled by DAC\_CFG.SR\_CLK

When the slew-rate control feature is enabled, the output changes at the programmed slew rate. This configuration results in a staircase formation at the output. If the clear code is asserted (see [Section 6.3.1.6](#)), the output slews to the DAC\_CLR\_CODE value at the programmed slew rate. When new DAC data are written, the output starts slewing to the new value at the slew rate determined by the current DAC code and the new DAC data.

Two slew-rate control modes are available: linear (default) and sinusoidal. [Figure 6-3](#) and [Figure 6-4](#) show the typical rising and falling DAC output waveforms, respectively.



Sinusoidal mode enables fast DAC settling while improving analog rate of change characteristics. Sinusoidal mode is selected by the DAC\_CFG.SR\_MODE bit. [Figure 6-5](#) and [Figure 6-6](#) show the typical rising and falling DAC output waveforms with sinusoidal slew-rate control, respectively.



If the slew-rate feature is disabled while the DAC is executing the slew-rate command, the slew-rate operation is aborted, and the DAC output goes to the target code.

### 6.3.1.6 DAC Register Structure and CLEAR State

The AFE88201 DAC has a 16-bit voltage output, and the AFE78201 DAC has a 14-bit voltage output. The output range is 0 V to 2.5 V.

The AFEx8201 provide the option to quickly set the DAC output to the value set in the DAC\_CLR\_CODE register without writing to the DAC\_DATA register, referred to as the CLEAR state. For register details, see [Table 7-6](#).

Transitioning from the DAC\_DATA to the DAC\_CLR\_CODE is synchronous to the clock. If slew mode is enabled, the output slews during the transition. [Figure 6-7](#) shows the full AFEx8201 DAC\_DATA signal path. The devices synchronize the DAC\_DATA code to the internal clock, causing up to 2.5 internal clock cycles of latency (2  $\mu$ s) with respect to the rising edge of  $\overline{CS}$  or the end of a UBM command. Update DAC\_GAIN and DAC\_OFFSET values when DAC\_CFG.SR\_EN = 0 to avoid an IRQ pulse generated by SR\_BUSY.

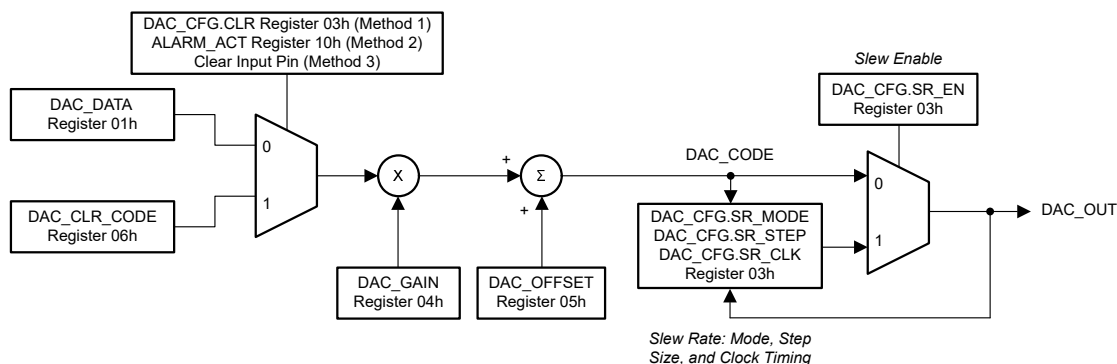
Set the DAC to CLEAR state either by:

1. Setting DAC\_CFG.CLR.
2. Configuring the DAC to transition to the CLEAR state in response to an alarm condition.
3. Using the SDI pin in UBM or the SCLR pin in SPI mode as the CLEAR state input pin.

Method 1 is a direct command to the AFEx8201 to set the DAC to CLEAR state. Set the DAC\_CFG.CLR bit to 1h to set the DAC to CLEAR state.

Method 2 is controlled by settings of ALARM\_ACT register. For details of conditions and other masks required to use this method, see [Table 7-15](#) and [Section 6.3.3.2](#).

Method 3 supports setting the DAC to CLEAR state without writing to the AFEx8201. This pin-based DAC CLEAR state function is available in SPI mode on the SCLR pin, or in UBM on the SDI pin. The SCLR pin must be tied to GND in UBM. For details of connection options based on communication modes and pins used in each mode, see [Section 6.5.1](#). Set the appropriate pin high to drive the DAC to CLEAR state.



**Figure 6-7. DAC Data Path**

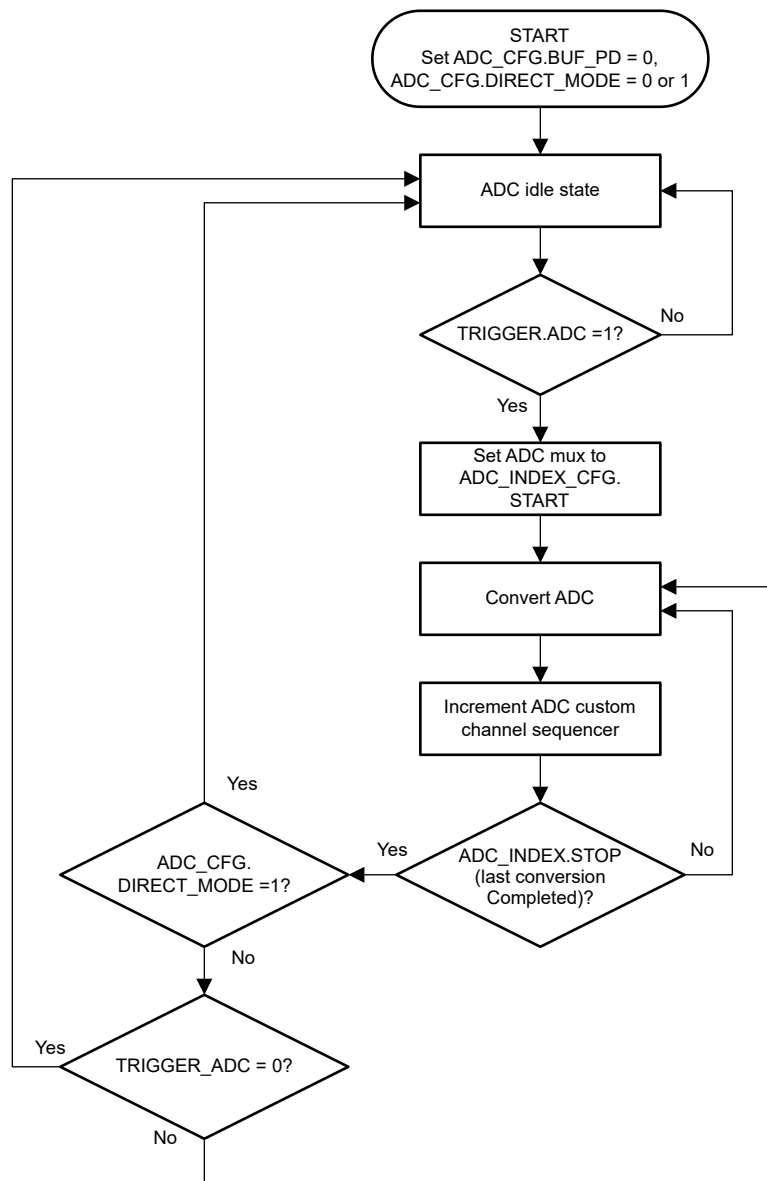
### 6.3.2 Analog-to-Digital Converter (ADC) Overview

The AFE78201 feature a monitoring system centered on a 12-bit successive approximation register (SAR) ADC and a highly flexible analog multiplexer. The monitoring system is capable of sensing up to two external inputs, as well as several internal device signals.

The ADC uses the VREFIO pin voltage as a reference. The ADC timing signals are derived from an on-chip oscillator. The conversion results are accessed through the device serial interface.

#### 6.3.2.1 ADC Operation

The device ADC supports direct-mode and auto-mode conversions. Both conversion modes use a custom channel sequencer to determine which of the input channels are converted by the ADC. The sequence order is fixed. The user selects the start channel and stop channel of the conversion sequence. The conversion method and channel sequence are specified in the ADC Configuration registers. The default conversion method is auto-mode. [Figure 6-8](#) shows the ADC conversion sequence.



**Figure 6-8. ADC Conversion Sequence**

To use the ADC, first enable the ADC buffer by setting `ADC_CFG.BUF_PD = 0`. Then wait at least 210  $\mu$ s before setting the trigger using the `TRIGGER.ADC` bit. An internal delay is forced if the trigger signal is sent before the timer has expired. Make sure the ADC is not converting before setting the `ADC_CFG.BUF_PD = 1`. If `ADC_CFG.BUF_PD` is set to 1 while the ADC is still converting, the internal timer delays this command. When the timer expires, the enable signal for the ADC is cleared, and the current conversion finishes before powering down the ADC and the ADC Buffer.

A trigger signal must occur for the ADC to exit the idle state. The ADC trigger is generated through the `TRIGGER.ADC` bit. The ADC data registers have the latest available data. Accessing the data registers does not interfere with the conversion process, and thus provides continuous ADC operation.

In direct-mode conversion, the selected ADC input channels are converted on demand by issuing an ADC trigger signal. After the last enabled channel is converted, the ADC enters the idle state and waits for a new trigger. Read the results of the ADC conversion through the register map. Direct-mode conversion is typically used to gather the ADC data of any of the data channels. In direct-mode, use the `ADC_BUSY` bit to determine when a direct-mode conversion is complete and the ADC has returned to the idle state. Direct mode is set by writing `ADC_CFG.DIRECT_MODE = 1`.

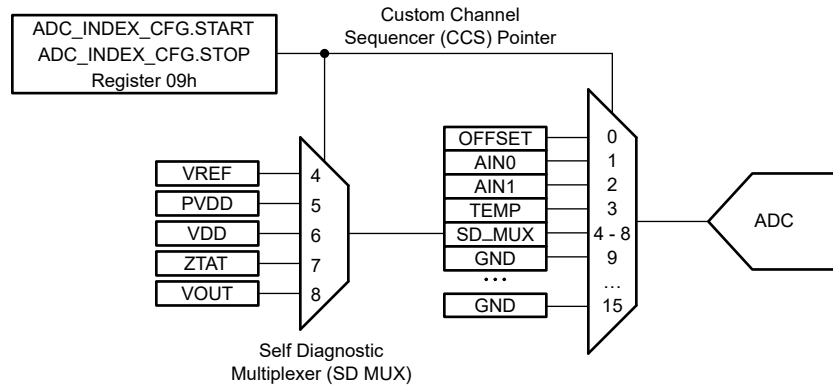
In auto-mode conversion, the selected ADC input channels are converted continuously. The conversion cycle is initiated by issuing an ADC trigger. Upon completion of the first conversion sequence, another sequence is automatically started. Conversion of the selected channels occurs repeatedly until the auto-mode conversion is stopped by clearing the ADC trigger signal. Auto-mode conversion is not typically used to gather the ADC data. Instead, auto-mode conversions are used in combination with upper and lower ADC data thresholds to detect when the data has exceeded the programmable out-of-range alarm thresholds. Auto mode is set by writing `ADC_CFG.DIRECT_MODE = 0`.

Regardless of the selected conversion method, update the ADC configuration register only while the ADC is in the idle state. Do not change the ADC configuration bits while the ADC is converting channels. Before changing configuration bits, disable the ADC and verify that `GEN_STATUS.ADC_BUSY = 0`.

### 6.3.2.2 ADC Custom Channel Sequencer

The device uses a custom channel sequencer to control the multiplexer of the ADC. The ADC sequencer allows the user to specify which channels are converted. The sequencer consists of 16 indexed slots with programmable start and stop index fields to configure the start and stop conversion points.

In direct-mode conversion, the ADC converts from the start index to the stop index once and then stops. In auto-mode conversion, the ADC converts from the start to stop index repeatedly until the ADC is stopped. [Figure 6-9](#) shows the indexed custom channel sequence slots available in the device.



**Figure 6-9. ADC MUX Control**

[Table 6-3](#) lists the ADC input channel assignments for the sequencer.

**Table 6-3. Indexed Custom Channel Sequence**

| CCS POINTER | CHANNEL    | CONV_RATE    | RANGE        |
|-------------|------------|--------------|--------------|
| 0           | OFFSET     | 2560 Hz      | VREF         |
| 1           | AIN0       | Programmable | Programmable |
| 2           | AIN1       | Programmable | Programmable |
| 3           | TEMP       | 2560 Hz      | VREF         |
| 4           | SD0 (VREF) | 2560 Hz      | VREF         |
| 5           | SD1 (PVDD) | 2560 Hz      | VREF         |
| 6           | SD2 (VDD)  | 2560 Hz      | VREF         |
| 7           | SD3 (ZTAT) | 2560 Hz      | VREF         |
| 8           | SD4 (VOUT) | 2560 Hz      | 2 × VREF     |
| 9-15        | GND        | 2560 Hz      | VREF         |

Use the ADC\_INDEX\_CFG register to select the channels. The order of the channels is fixed and shown in [Table 6-3](#). Then, use ADC\_INDEX\_CFG.START and ADC\_INDEX\_CFG.STOP to select the range of indices to convert. If these two values are the same, then the ADC only converts a single channel. If the START and STOP values are different, then the ADC cycles through the corresponding indices. By default, all channels are configured to be converted; START = 0 and STOP = 8. If the AIN1 channel is not configured as an ADC input, then the result for this channel is 0x000. The minimum time for a conversion is still allotted to AIN1 if the channel is within the START and STOP range. If START is configured to be greater than STOP, then the device interprets the conversion sequence as if START = STOP.

In direct mode, each selected channel in the ADC\_INDEX\_CFG register is converted once per TRIGGER.ADC command. In auto mode, each channel selected in the ADC\_INDEX\_CFG register is converted once; after the last channel, the loop is repeated as long as the ADC is enabled. In auto mode, writing to TRIGGER.ADC = 1 starts the conversions. Writing TRIGGER.ADC = 0 disables the ADC after the current channel being converted finishes. In direct mode, writing TRIGGER.ADC = 1 starts the sequence. When the sequence ends, then TRIGGER.ADC is self-cleared.

A minimum of 20 clock cycles is required to perform one conversion. The ADC clock is derived from the internal oscillator and divided by 16, which gives an ADC clock frequency of  $1.2288 \text{ MHz} / 16 = 76.8 \text{ kHz}$ , for a clock period =  $13.02 \mu\text{s}$ .

Each of the internal nodes has a fixed conversion rate. Pins AIN0 and AIN1 have programmable conversion rates (see also the ADC\_CFG register). Pins AIN0 and AIN1 also have a configurable range. The input range can be either 0 V to 1.25 V or 0 V to 2.5 V, depending on the ADC\_CFG.RANGE bit.

If any ADC configuration bits are changed, the following sequence is recommended:

1. Disable the ADC
2. Wait for ADC\_BUSY to go low
3. Change the configuration
4. Restart the conversions

ADC\_BUSY can be monitored in the GEN\_STATUS register.

If the ADC is configured for direct mode (ADC\_CFG.DIRECT\_MODE = 1), then after setting the desired channels to convert, write a 1 to TRIGGER.ADC. This bit is self-cleared when the sequence is finished converting. This command converts all the selected channels once. To initiate another conversion of the channels, send another TRIGGER.ADC command.

#### 6.3.2.3 ADC Synchronization

The trigger signal must be generated for the ADC to exit the idle state and start conversions. The ADC trigger is generated through the TRIGGER.ADC bit. The ADC data registers have the latest available data. Accessing the data registers does not interfere with the conversion process, and thus provides continuous ADC operation.

In direct-mode, use the GEN\_STATUS.ADC\_BUSY bit to determine when a direct-mode conversion is complete, and the ADC has returned to the idle state. Similarly, monitor the TRIGGER.ADC bit to see if the ADC has returned to the idle state.

#### 6.3.2.4 ADC Offset Calibration

Channel 0 of the CCS pointer is named OFFSET. The OFFSET channel is used to calibrate and improve the ADC offset performance. Convert the OFFSET channel, and use the result as a calibration for the ADC offset in subsequent measurements.

This ADC channel samples  $V_{REF} / 2$  and compares this result against 7FFh as a measure of the ADC offset. The data rate for the ADC measuring this channel is 2560 Hz. The ADC conversion for the OFFSET channel is subtracted from 7FFh and the resulting value is stored in ADC\_OFFSET (28h). The offset can be positive or negative; therefore, the value is stored in 2's complement notation.

With the subtraction from 7FFh, ADC\_OFFSET is the negative of the offset. This value is subtracted from conversions of the ADC by default. For direct measurements of the ADC, set ADC\_BYP.OFST\_BYP\_EN to 1 to enable the offset bypass; see [Section 6.3.2.8](#).

### 6.3.2.5 External Monitoring Inputs

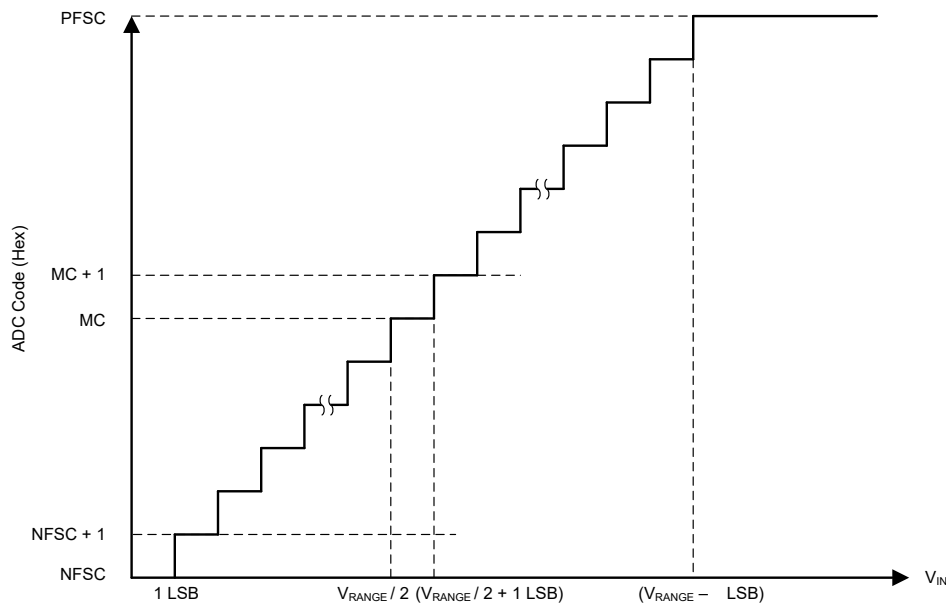
The AFE78201 have two analog inputs for external voltage sensing. Channels 1 and 2 for the CCS pointer are for external monitoring inputs that can be measured by pins AIN0 and AIN1, respectively. The input range for the analog inputs is configurable to either 0 V to 1.25 V or 0 V to 2.5 V. The analog inputs conversion values are stored in straight binary format in the ADC registers. The ADC resolution can be computed by [Equation 7](#):

$$1 \text{ LSB} = \frac{V_{\text{RANGE}}}{2^{12}} \quad (7)$$

where

- $V_{\text{RANGE}} = 2.5 \text{ V}$  for the 0-V to 2.5-V input range or 1.25 V for the 0-V to 1.25-V input range.

[Figure 6-10](#) and [Table 6-4](#) detail the transfer characteristics.



**Figure 6-10. ADC Transfer Characteristics**

**Table 6-4. Transfer Characteristics**

| INPUT VOLTAGE                                                                       | CODE     | DESCRIPTION                     | IDEAL OUTPUT CODE |
|-------------------------------------------------------------------------------------|----------|---------------------------------|-------------------|
| $\leq 1 \text{ LSB}$                                                                | NFSC     | Negative full-scale code        | 000               |
| 1 LSB to 2 LSB                                                                      | NFSC + 1 | Negative full-scale code plus 1 | 001               |
| $(V_{\text{RANGE}} / 2) \text{ to } (V_{\text{RANGE}} / 2) + 1 \text{ LSB}$         | MC       | Midcode                         | 800               |
| $(V_{\text{RANGE}} / 2) + 1 \text{ LSB to } (V_{\text{RANGE}} / 2) + 2 \text{ LSB}$ | MC + 1   | Midcode plus 1                  | 801               |
| $\geq V_{\text{RANGE}} - 1 \text{ LSB}$                                             | PFSC     | Positive full-scale code        | FFF               |

For these external monitoring inputs, the ADC is configurable for both data rate and voltage range. The data rate is set to either 640 Hz, 1280 Hz, 2560 Hz, or 3840 Hz with the ADC\_CFG.CONV\_RATE bits. The range of the ADC measurement is set with the ADC\_CFG.AIN\_RANGE bit. The ADC range is  $2 \times V_{\text{REF}}$  when the bit = 0; the ADC range is  $V_{\text{REF}}$  when the bit = 1.

When the ADC conversion is completed for AIN0 and AIN1, the resulting ADC data are stored in the ADC\_AIN0.DATA and ADC\_AIN1.DATA bits at 24h and 25h of the register map.

If the external monitoring inputs are not used, connect the AIN0 and AIN1 pins to GND through a 1-kΩ resistor.

### 6.3.2.6 Temperature Sensor

Channel 3 of the CCS is used to measure the die temperature of the device. The ADC measures an internal temperature sensor that measures a voltage complementary to the absolute temperature (CTAT). This CTAT voltage has a negative temperature coefficient. The ADC converts this voltage at a data rate of 2560 Hz. When the ADC conversion is completed, the data are found in the ADC\_TEMP.DATA bits (address 26h).

The relationship between the ambient temperature and the ADC code is shown in [Equation 8](#):

$$\text{ADC Code} = 2681 - 11 \times T_A(^{\circ}\text{C}) \quad (8)$$

### 6.3.2.7 Self-Diagnostic Multiplexer

In addition to the ADC offset, the two external monitoring inputs, and the temperature sensor, the ADC of the AFE78201 has five other internal inputs to monitor the reference voltage, the power supplies, a static voltage, and the DAC output. These five voltages measurements are part of the self-diagnostic multiplexer (SD0 to SD4) measurements of the ADC, and are reported in the ADC\_SD\_MUX register at 27h; see also [Section 7](#).

Channel 4 (SD0) measures the reference voltage of the device. The ADC measures the reference voltage through a resistor divider (divide by two). Be aware that all ADC measurements are a function of the reference; using SD0 to measure the reference is not revealing as a diagnostic measurement. The data rate for this conversion is 2560 Hz and the range of the ADC is set to VREF.

Channel 5 (SD1) measures the PVDD power supply of the device. The ADC measures the PVDD voltage through a resistor divider (divide by six). The data rate for this conversion is 2560 Hz and the range of the ADC is set to VREF.

Channel 6 (SD2) measures the VDD power supply of the device. When channel 6 is selected, the ADC measures the VDD voltage through a resistor divider (divide by 2). The data rate for this conversion is 2560 Hz and the range of the ADC is set to VREF.

Channel 7 (SD3) is a ZTAT (zero temperature coefficient) voltage. This internal voltage is nominally 0.6 V with a low temperature drift and does not depend on the reference voltage. An ADC measurement of ZTAT voltage can be useful to determine the state of the reference voltage. The data rate for this conversion is 2560 Hz and the range of the ADC is set to VREF.

Channel 8 (SD4) measures the VOUT of the DAC. The ADC measures the VOUT voltage through a resistor divider (divide by two). The data rate for this conversion is 2560 Hz and the range of the ADC is set to  $2 \times \text{VREF}$ .

### 6.3.2.8 ADC Bypass

To test the offset, modify the ADC data path by programming the bypass data register, ADC\_BYP.DATA (2Eh). This read/write register is used in two different ways.

First, by setting the ADC\_BYP.OFST\_BYP\_EN to 1, this bypass data register is used as a substitute for the ADC\_OFFSET. However, if the ADC\_BYP.DATA data must be stored in the ADC\_OFFSET register, use the second method.

Second, the ADC\_BYP.DATA is used to set a known value into the ADC readback register of the channel being converted. Write the desired data into ADC\_BYP.DATA, set the ADC\_BYP.DATA\_BYP\_EN bit, and convert the selected channel. When ADC\_BYP.DATA\_BYP\_EN bit is set to 1, the ADC conversion is bypassed, and the value of ADC\_BYP.DATA is written into the selected ADC channel readback register. This setting is used to test the alarm settings of the ADC.

When the ADC bypass is unused, set the ADC\_BYP.DATA to 000h.

Figure 6-11 shows the ADC bypass data flow.

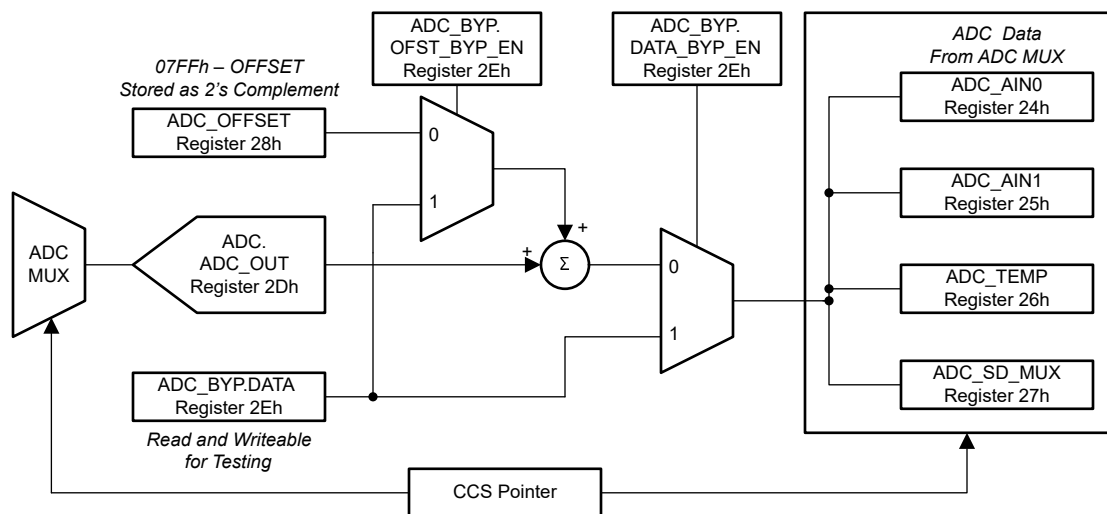


Figure 6-11. ADC Bypass Data Flow

### 6.3.3 Programmable Out-of-Range Alarms

The AFE8201 are capable of continuously analyzing the supplies, external ADC inputs, DAC output voltage, reference, internal temperature, and other internal signals for normal operation.

Normal operation for the conversion results is established through the lower- and upper-threshold registers. When any of the monitored inputs are out of the specified range, the corresponding alarm bit in the alarm status registers is set.

The alarm bits in the alarm status registers are latched. The alarm bits are referred to as being latched because the alarm bits remain set until read by software. This design makes sure that out-of-limit events cannot be missed if the software is polling the device periodically. All bits are cleared when reading the alarm status registers, and all bits are reasserted if the out-of-limit condition still exists on the next monitoring cycle. When the alarm event is cleared, the DAC is reloaded with the contents of the DAC active registers, which allows the DAC outputs to return to the previous operating point without any additional commands.

All alarms can be used to generate a hardware interrupt signal on the  $\overline{\text{ALARM}}$  pin; see also Section 6.3.3.1. In addition, Section 6.3.3.2 describes how the alarm action can be individually configured for each alarm.

### 6.3.3.1 Alarm-Based Interrupts

One or more of the available alarms can be set to activate the  $\overline{\text{ALARM}}$  pin. Connect the  $\overline{\text{ALARM}}$  pin as an optional hardware interrupt to the host. The host can query the alarm status registers to determine the alarm source upon assertion of the interrupt. Any alarm event activates the pin, as long as the alarm is not masked in the ALARM\_STATUS\_MASK register. When an alarm event is masked, the occurrence of the event sets the corresponding status bit in the alarm status registers, but does not activate the  $\overline{\text{ALARM}}$  pin.

---

#### Note

The  $\overline{\text{ALARM}}$  pin output depends on ALARM\_STATUS and ALARM\_STATUS\_MASK register settings, independent of ALARM\_ACT register settings.

---

### 6.3.3.2 Alarm Action Configuration Register

The AFEx8201 provides an alarm action configuration register: ALARM\_ACT, [Table 7-15](#). Writing to this register selects the device action that automatically occurs for a specific alarm condition. The ALARM\_ACT register determines how the main DAC responds to an alarm event from either an ADC conversion on the self-diagnostics channels (AIN0, AIN1, and TEMP), or from a CRC, WDT, VREF, TEMP\_HI, or TEMP\_LO fault. Only these faults cause a response by the DAC. Any other alarm status events trigger the  $\overline{\text{ALARM}}$  pin. There are four options for alarm action. In case different settings are selected for different alarm conditions, the following low-to-high priority is considered when taking action:

- 0. → No action
- 1. → DAC CLEAR state
- 2. → VOUT alarm voltage
- 3. → VOUT Hi-Z

If option 1 is selected when the alarm event occurs, then the DAC is forced to the clear code. This operation is done by controlling the input code to the DAC.

If option 2 is selected when the alarm event occurs, then VOUT is forced to the alarm voltage. The alarm voltage is controlled by either pin or register bit. If SPECIAL\_CFG.AIN1\_ENB = 0, then the AIN1 pin controls alarm polarity. Also, register bit SPECIAL\_CFG.ALMV\_POL can be used. If either of these signals = 1, then the alarm voltage is high; otherwise, the alarm voltage is low. The SPECIAL\_CFG register is only reset with POR, so the user setting remains intact through hardware or software resets.

If option 3 is selected when the alarm event occurs, then the VOUT buffer is put into Hi-Z. If multiple events occur, then the highest setting takes precedence. Option 3 has the highest priority.

To disable action response to an alarm, set the corresponding bits in ALARM\_ACT to 0h. Alarm action response is cleared either when the triggered condition bit resets (behavior depends on whether the fault bit in ALARM\_STATUS is sticky or not), or by changing the action configuration to 0h.

---

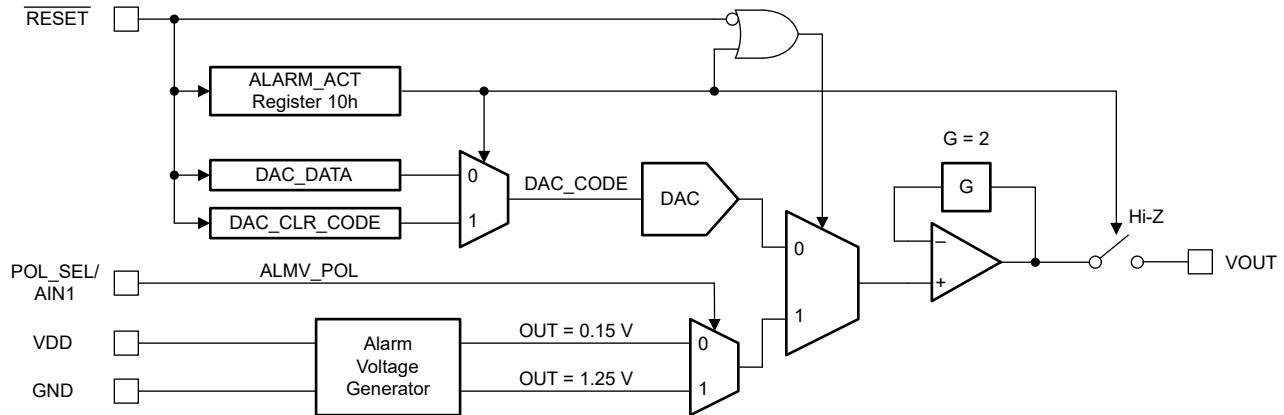
#### Note

An alarm action, as configured, executes when an alarm occurs depending on ALARM\_STATUS and ALARM\_ACT registers. Action response is independent of ALARM\_STATUS\_MASK settings.

---

### 6.3.3.3 Alarm Voltage Generator

Figure 6-12 shows that the alarm voltage is generated independently from the DAC output voltage. The alarm polarity control logic selects the output level of the alarm voltage generator. The alarm action control logic selects between the DAC output and alarm voltage generator output voltages. The alarm action control logic also controls the output buffer Hi-Z switch.



**Figure 6-12. Alarm Voltage Generator Architecture**

During normal operation, the expected VOUT voltage depends on the DAC\_CODE. The ADC thresholds for the SD4 (VOUT) diagnostic channel are set around the programmed DAC\_CODE. During the alarm condition, if the alarm action changes the VOUT voltage to the alarm voltage, or switches the VOUT buffer into Hi-Z mode, the VOUT voltage no longer depends on the DAC\_CODE. In this case, the SD4 (VOUT) diagnostic channel also reports the alarm. To clear this alarm, as long as all other alarm conditions are cleared, set the alarm action to either no action or to the DAC clear code. Applying either alarm action sets the VOUT voltage within the expected ADC thresholds and clears the alarm after the next ADC measurement of the SD4 (VOUT) channel.

Give special consideration to the alarm logic during the transient events. When the new DAC\_CODE goes beyond the SD4 (VOUT) alarm thresholds with the ADC monitoring the SD4 (VOUT) input in auto mode, the ADC conversion can occur while VOUT settles to a new value. This conversion can trigger a false alarm. There are two ways to prevent this false alarm:

1. Use direct mode and allow VOUT to settle before triggering the next ADC conversion.
2. Set ADC\_CFG.FLT\_CNT > 0. With this configuration, a single error in SD4 or any other measurement does not cause an alarm condition to be asserted.

### 6.3.3.4 Temperature Sensor Alarm Function

The AFE8201 continuously monitor the internal die temperature. In addition to the ADC measurement, the temperature sensor triggers a comparator to show a thermal warning and a thermal error. A thermal warning alarm is set when the temperature exceeds 85°C. Additionally, a thermal error alarm is set when the die temperature exceeds 130°C.

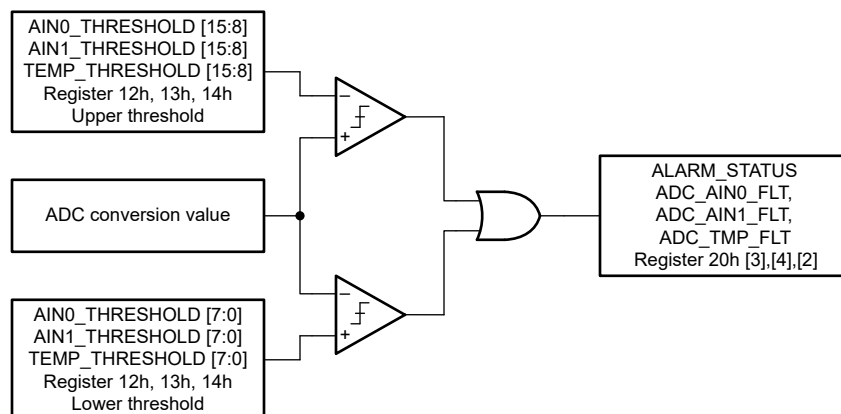
The thermal warning and thermal error alarms can be configured to set the  $\overline{\text{ALARM}}$  pin and are indicated in the ALARM\_STATUS register. These alarms can be masked with the ALARM\_MASK register and also be configured to control the DAC output with the ALARM\_ACT register.

### 6.3.3.5 Internal Reference Alarm Function

The devices provide out-of-range detection for the reference voltage. When the reference voltage exceeds  $\pm 5\%$  of the nominal value, the reference alarm flag (VREF\_FLT bit) is set. Make sure that a reference alarm condition has not been issued by the device before powering up the DAC output.

### 6.3.3.6 ADC Alarm Function

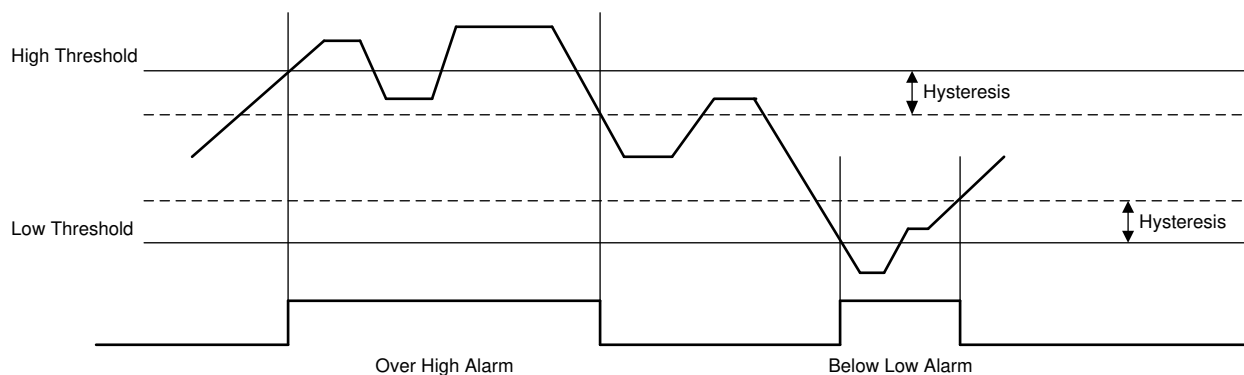
The AFE<sub>x</sub>8201 provide independent out-of-range detection for each of the ADC inputs. Figure 6-13 shows the out-of-range detection block. When the measurement is out of range, the corresponding alarm bit is set to flag the out-of-range condition.



**Figure 6-13. ADC Out-of-Range Alarm**

An alarm event is only registered when the monitored signal is out of range for  $N$  number of consecutive conversions, where  $N$  is configured in the ADC\_CFG.FLT\_CNT false alarm register settings. If the monitored signal returns to the normal range before  $N$  consecutive conversions, an alarm event is not issued.

If an ADC input signal is out of range and the alarm is enabled, then the corresponding alarm bit is set to 1. However, the alarm condition is cleared only when the conversion result returns to a value less than the high-limit register setting and greater than the low-limit register setting by the number of codes specified by the hysteresis setting (see Figure 6-14). The hysteresis is a programmable value between 0 LSB to 127 LSB in the ADC\_CFG.HYST register.



**Figure 6-14. ADC Alarm Hysteresis**

### 6.3.3.7 Fault Detection

There are two fields within the ADC\_CFG register: FLT\_CNT and HYST. These fields are applied to the assertion and deassertion of alarm conditions for all the ADC channels.

ADC\_CFG.FLT\_CNT determines the maximum number of accepted consecutive failures before an alarm condition is reported. For example, if ADC\_CFG.FLT\_CNT is set for two counts, then three consecutive conversions must be outside of the thresholds to trigger an alarm. Each failure counts towards the FLT\_CNT limit even if the failures alternate between high threshold and low threshold.

ADC\_CFG.HYST sets the hysteresis used by the alarm-detection circuit. After an alarm is triggered, the hysteresis is applied before the alarm condition is released. In the case of the high threshold, the hysteresis is subtracted from the threshold value. In the case of the low threshold limit, the hysteresis is added to the threshold value.

Channels AIN0, AIN1, and TEMP have high and low thresholds associated with them. If a conversion value falls outside of these limits (that is, if  $TEMP < \text{low threshold}$  or  $TEMP > \text{high threshold}$ ), an alarm condition for that channel is set. The alarms are disabled by setting 0x000 for the low threshold and 0xFFF for the high threshold, respectively. These alarms are disabled by default. Because the configuration fields for the thresholds are only eight bits wide, the four LSBs are hardcoded for each threshold. The high thresholds four LSBs are hardcoded to 0xF, and the low thresholds four LSBs are hardcoded to 0x0.

All the self diagnostic (SD) channels have fixed thresholds, except SD4, which measures the VOUT of the main DAC. The threshold for SD4 tracks the VOUT with respect to the DAC code. [Table 6-5](#) shows the calculations used to determine the high and low ADC thresholds for each SD channel. The limits in the two right-most columns are determined by the threshold columns to the left and given some margin. The four LSBs are assigned as described previously.

**Table 6-5. Self Diagnostic (SD) Alarm ADC Thresholds**

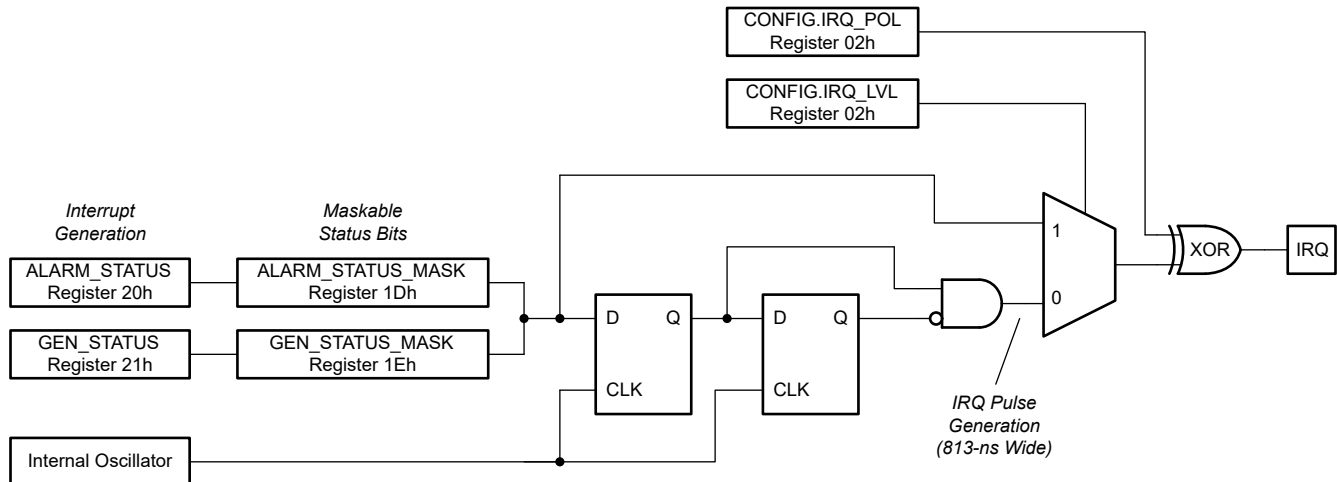
| SD  | ADC INPUT | ACCEPTED LOW VALUE                    | ACCEPTED HIGH VALUE                   | LOW THRESHOLD          | HIGH THRESHOLD         | ADC LOW (HEX)    | ADC HIGH (HEX)   |
|-----|-----------|---------------------------------------|---------------------------------------|------------------------|------------------------|------------------|------------------|
| SD0 | VREF/2    | $VREF/2 - 9\% - 25 \text{ mV}$        | $VREF/2 + 9\% + 25 \text{ mV}$        | 0.54375 V              | 0.70625 V              | 0x6D0            | 0x92F            |
| SD1 | PVDD/6    | $1.65/6 - 25 \text{ mV}$              | $6/6 + 25 \text{ mV}$                 | 0.25 V                 | 1.025 V                | 0x310            | 0xD3F            |
| SD2 | VDD/2     | $1.6/2 - 25 \text{ mV}$               | $2/2 + 25 \text{ mV}$                 | 0.775 V                | 1.025 V                | 0x9C0            | 0xD3F            |
| SD3 | 0.6 V     | $0.6 \text{ V} - 9\% - 25 \text{ mV}$ | $0.6 \text{ V} + 9\% + 25 \text{ mV}$ | 0.521 V                | 0.679 V                | 0x690            | 0x8CF            |
| SD4 | VOUT/2    | $VOUT/2 - 6 \text{ mV}$               | $VOUT/2 + 6 \text{ mV}$               | $VOUT - 12 \text{ mV}$ | $VOUT + 12 \text{ mV}$ | Expected - 0x040 | Expected + 0x040 |

The alarm threshold for the SD4 input depends on the expected ADC measurement based on the DAC code. [Equation 9](#) shows the expected ADC code for SD4.

$$\text{ADC Expected Code} = \text{DAC\_CODE}[\text{MSB}:\text{MSB}-11] \quad (9)$$

### 6.3.4 IRQ

The devices include an interrupt request (IRQ) to communicate the occurrence of a variety of events to the host controller. The IRQ block initiates interrupts that are reported internally in a status register, externally on the IRQ pin if the function is enabled, or on the  $\overline{\text{ALARM}}$  pin if the condition is from the ALARM\_STATUS register. Figure 6-15 shows the IRQ block diagram.



**Figure 6-15. IRQ Block Diagram**

There are two registers that can generate interrupts: GEN\_STATUS and ALARM\_STATUS. Each of these registers has a corresponding STATUS\_MASK register. The mask register controls which of the events trigger an interrupt. Writing a 1 in the mask register masks, or disables, the event from triggering an interrupt. Writing a 0 in the mask register allows the event to trigger an IRQ. All bits are masked by default. Some status bits are sticky. Reading the corresponding register clears a sticky bit, unless the condition still exists.

The IRQ is configured through CONFIG.IRQ\_LVL to be edge- or level-sensitive. Set this bit to logic 1 to enable level-sensitive functionality (default). In edge-sensitive mode, the IRQ signal is a synchronous pulse, one internal clock period wide (813 ns). In level-sensitive mode, the IRQ is set and remains set as long as the condition exists. After the IRQ condition is removed, the condition is cleared by reading the corresponding status register. Trying to clear the bit while the condition still exists does not allow the bit to be cleared if the bit is sticky.

CONFIG.IRQ\_POL determines the active level of the IRQ. A logic 1 configures IRQ to be active high.

When using edge-sensitive IRQ signals, there is a clock cycle delay for synchronization and edge detection. With a 307.2-kHz clock, this delay is up to 3.26  $\mu$ s. For level-sensitive mode, the delay is approximately 10 ns to 20 ns.

Most status bits have two versions within the design. The first version is an edge event that is created when the status is asserted. This signal is used to generate edge-sensitive IRQs. This edge detection prevents multiple status events from blocking one another. The second version is the sticky version of the status bit. This signal is set upon assertion of the status bit and cleared when the corresponding status register is read, as long as the status condition does not still persist. Signals GEN\_IRQ and ALARM\_IRQ are driven by the logical OR of the of the status bits within the corresponding register.

If a status bit is unmasked and the sticky version of that bit has been asserted, and the IRQ is level-sensitive, then an interrupt is triggered as soon as the bit is unmasked. If the IRQ is edge-sensitive then a status event must occur after the bit has been unmasked to assert an interrupt.

### 6.3.5 Internal Reference

The AFEx8201 family of devices includes a 1.25-V precision band-gap reference. The internal reference is externally available at the VREFIO pin and sources up to 2.5 mA. For noise filtering, use a 100-nF capacitor between the reference output and GND.

The internal reference circuit is enabled or disabled by using the REF\_EN pin. A logic high on this pin enables the internal reference, and the VREFIO pin outputs 1.25 V. A logic low on this pin disables the internal reference, and the device expects to have 1.25 V from external VREF at the VREFIO pin.

An invalid reference voltage asserts an alarm condition. The DAC response depends on the VREF\_FLT setting in the ALARM\_ACT register (10h).

### 6.3.6 Integrated Precision Oscillator

The internal time base of the device is provided by an internal oscillator that is trimmed to less than 0.5% tolerance at room temperature. The precision oscillator is the timing source for ADC conversions. At power up, the internal oscillator and ADC take roughly 300  $\mu$ s to reach < 1% error stability. After the clock stabilizes, the ADC data output is accurate to the electrical specifications provided in [Section 5](#).

### 6.3.7 Precision Oscillator Diagnostics

The AFEx8201 features two methods to continuously detect the functional status of the internal precision oscillator.

The first method requires a connection from the AFEx8201 to the system controller. To use the first method, program the AFEx8201 to output a subdivided internal oscillator clock signal on the CLK\_OUT pin. Write to the CONFIG.CLKO register field (see [Table 7-5](#)) to enable the output with the chosen divider or to disable the output. The output digital signal is compliant to the [Section 5.5](#). The CLK\_OUT pin is also a shared GPIO pin. For details on connecting CLK\_OUT and CLK\_OUT interoperability as a GPIO pin, see [Section 6.5.1](#).

The second method does not require a connection from the AFEx8201 and is a polled-communication-based method to determine the functionality of the internal oscillator using SPI communication. See [Section 6.5.3.1](#) and [Section 6.5.5](#) for SPI communication details and SDO status bits details, respectively. The OSC\_DIV\_2 bit reports the logical value of a subdivided internal oscillator signal (divided by 2) sampled at the  $\overline{CS}$  falling edge. Use an appropriate SCLK frequency and interval between SPI frames to capture bit changes from frame to frame as a method of verifying the continued proper operation of the clock. Similar status reports of the logical value of a subdivided internal oscillator signal (divided by 1024) are available in UBM as the OSC\_DIV\_1024 bit. For details on UBM frames and timing, see [Section 6.5.4.1](#).

### 6.3.8 One-Time Programmable (OTP) Memory

One-time programmable (OTP) memory in the device is used to store the device trim settings and is not accessible to users. The OTP memory data are loaded to the memory (OTP shadow load) at power up. The OTP memory CRC is performed to verify the correct data are loaded. The TRIGGER.SHADOWLOAD bit is available to initiate a reload of the OTP memory data if a CRC error is detected. The SPECIAL\_CFG.OTP\_LOAD\_SW\_RST bit controls whether the OTP memory data are reloaded with a software reset.

### 6.3.9 GPIO

AFEx8201 feature multiple GPIO pins, each independently configurable in either input only or output only or input-output mode through GPIO\_CFG and GPIO registers. Select either push-pull or pseudo open drain sub modes supported when the GPIO is in output mode. No dedicated GPIO pins are present since the same pins are also configurable for communication interfaces. Based on the selection of the interface protocol and how many pins are used for communication purposes, the AFEx8201 have up to four available GPIOs. Refer to [Section 6.5.1](#) for detailed diagrams of available GPIOs in each communication mode. If a GPIO pin is unused or undriven, the pin must be tied resistively to either IOVDD or GND according to the connection diagrams in [Section 6.5.1](#). Unconnected floating input pins lead to unknown states for the communication interfaces and varying supply currents for the AFEx8201. When functioning as an output, each GPIO pin is capable of sourcing and sinking current and when functioning as an input the register address 0x1C reflects the digital state of the GPIO pins (for details of source and sink capabilities and input thresholds, see [Section 5.5](#)). The minimum pulse width for transition detection is  $t_{PULSE\_GPIO}$ . When a state transition occurs on a GPIO input, the new state must be held for a minimum of  $t_{PULSE\_GPIO}$  for detection by the AFEx8201.

### 6.3.10 Timer

The AFEx8201 have an integrated timer for generating accurate time delays, pulse width modulation or oscillation. The devices have the ability to have timing parameters from the microseconds range to hours. The timer is brought out on the CLK\_OUT pin by setting CONFIG.CLKO = Fh. The timer is controlled with three registers; TIMER\_CFG\_0, TIMER\_CFG\_1, and TIMER\_CFG\_2.

In the first of the three registers, TIMER\_CFG\_0.ENABLE turns the timer function on and off. If the timer is off, then the output defaults to 0. TIMER\_CFG\_0.INVERT inverts the output of the timer. If the INVERT bit is set, the output defaults to 1. TIMER\_CFG\_0.CLK\_SEL selects the clock frequency according to [Table 6-6](#). If 2'b00 is selected, and no clock is applied, then the timer pauses if the timer has previously been enabled and counting.

**Table 6-6. Timer Select Range**

| CLK_SEL | Clock Frequency | Resolution  | Range    |
|---------|-----------------|-------------|----------|
| 00      | No clock        | -           | -        |
| 01      | 1.2288 MHz      | 814 ns      | 53.3 ms  |
| 10      | 1.200 kHz       | 833 $\mu$ s | 54.6 s   |
| 11      | 1.171 Hz        | 853 ms      | 55,923 s |

The second timer register, TIMER\_CFG\_1.PERIOD sets the period of the timer. The period of the timer is PERIOD + 1 cycles of the clock period.

The last timer register, TIMER\_CFG\_2.SET\_TIME determines when the timer output goes to 1 (INVERT = 0). This effectively defines the duty cycle of the timer. The duty cycle can be calculated as (PERIOD – SET\_TIME)  $\times$  clock period.

### 6.3.11 Unique Chip Identifier (ID)

AFEx8201 include two read only registers: CHIP\_ID\_MSB (1Ah) and CHIP\_ID\_LSB (19h) where unique chip ID is stored. The 16-bit CHIP\_ID\_MSB register stores the encoded lot identification number while the CHIP\_ID\_LSB register stores the unique part number within each lot.

### 6.3.12 Scratch Pad Register

AFEx8201 feature a 16-bit Scratch Pad register to enable interface debug and verification without affecting the part functionality. This register is located at the address 18h. The readback value of the Scratch Pad register is the inverted code of the value stored in the register (for example, writing 0xAAAA results in 0x5555 while reading back ).

## 6.4 Device Functional Modes

### 6.4.1 Register Built-In Self-Test (RBIST)

The AFEx8201 feature a register built-in self-test (RBIST) that runs on all the registers listed in [Table 6-7](#) through a CRC calculation in the order the registers are listed in [Table 6-7](#). If a register is reserved, the reset value is used in the calculation of the RBIST. If the final CRC value is zero, then no error is present in the configuration of the registers. If a non-zero value is present at the end of the calculation, then there is a configuration error. The polynomial used has a Hamming distance (HD) of 4 for data packets up to 2048 bits. With HD = 4, the CRC detects any combination of 4-bit errors within the stored data. Independently calculate the expected CRC polynomial and store the output in the RBIST\_CRC register at 3Fh.

The final value of the CRC is read in the CRC\_RD register at address 3Eh. This value is updated while either an RBIST or shadow load is running. Both the RBIST and OTP memory use the same CRC calculation engine and polynomial. The value in the CRC\_RD register remains constant until another RBIST or SHADOWLOAD in TRIGGER register (0Ah) is triggered.

Set TRIGGER.RBIST to 1 to initiate an RBIST. The TRIGGER.RBIST bit stays high as long as the RBIST is running and clears when the self-test is complete. While the RBIST is running, the registers cannot be written to or read. Send NOP commands and monitor the RBIST SDO status bit to determine if the RBIST has completed.

In UBM, the RBIST does not interfere with register communication. UBM communication is slow enough that the RBIST completes before any following read or write command.

Set the GEN\_STATUS.RBIST\_MODE bit to 1 to enable the RBIST. This bit is sticky until the GEN\_STATUS register is read.

The 16-bit CRC used to generate the RBIST is compliant to the openSAFETY (0x755B) standard with the following polynomial:

$$x^{16} + x^{14} + x^{13} + x^{12} + x^{10} + x^8 + x^6 + x^4 + x^3 + x^1 + 1.$$

The list of registers covered by the RBIST is listed in [Table 6-7](#). Not all registers feature the RBIST.

**Table 6-7. List of Registers Covered by RBIST**

| ADDR (HEX) | REGISTER                          | RESET (HEX) |
|------------|-----------------------------------|-------------|
| 01h        | <a href="#">DAC_DATA</a>          | 0000h       |
| 02h        | <a href="#">CONFIG</a>            | 0036h       |
| 03h        | <a href="#">DAC_CFG</a>           | 0B00h       |
| 04h        | <a href="#">DAC_GAIN</a>          | 8000h       |
| 05h        | <a href="#">DAC_OFFSET</a>        | 0000h       |
| 06h        | <a href="#">DAC_CLR_CODE</a>      | 0000h       |
| 08h        | <a href="#">ADC_CFG</a>           | 8810h       |
| 09h        | <a href="#">ADC_INDEX_CFG</a>     | 0080h       |
| 0Bh        | <a href="#">SPECIAL_CFG</a>       | 0000h       |
| 0Dh        | RESERVED                          | 0100h       |
| 0Eh        | RESERVED                          | 0040h       |
| 0Fh        | RESERVED                          | 00F0h       |
| 10h        | <a href="#">ALARM_ACT</a>         | 8020h       |
| 11h        | <a href="#">WDT</a>               | 0018h       |
| 12h        | <a href="#">AIN0_THRESHOLD</a>    | FF00h       |
| 13h        | <a href="#">AIN1_THRESHOLD</a>    | FF00h       |
| 14h        | <a href="#">TEMP_THRESHOLD</a>    | FF00h       |
| 1Bh        | <a href="#">GPIO_CFG</a>          | 00FFh       |
| 1Dh        | <a href="#">ALARM_STATUS_MASK</a> | EFDh        |
| 1Eh        | <a href="#">GEN_STATUS_MASK</a>   | FFFFh       |
| 1Fh        | RESERVED                          | FFFFh       |
| 3Fh        | <a href="#">RBIST_CRC</a>         | 0000h       |

#### 6.4.2 DAC Power-Down Mode

Power-down mode facilitates rapid turn-off of the voltage at the DAC output. The DAC can be set to enter and exit power-down mode through hardware, software, or automatically in response to an alarm event. The DAC output is specified for glitch-free performance when going into and out of power-down mode.

Power-down mode is also be enabled by setting DAC\_CFG.PD to 1. In power-down mode, the DAC output amplifier powers down and the DAC output pin is put into the Hi-Z configuration. The DAC output remains in power-down mode until the DAC output is re-enabled.

Alarm control of the power-down mode is enabled by setting the alarm events as DAC power-down sources. The alarm events that trigger the DAC output power-down state must be specified in the ALARM\_ACT register. After the alarm bit is cleared, the DAC returns to normal operation, as long as no other power-down controlling alarm event has been triggered.

The DAC register does not change when the DAC enters power-down mode, which enables the device to return to the original operating point after return from the power-down mode. Additionally, the DAC register can be updated while the DAC is in power-down mode, thus allowing the DAC to output a new value upon return to normal operation.

### 6.4.3 Reset

There are three reset mechanisms in the device: a power-on reset (POR), a  $\overline{\text{RESET}}$  pin, and the SW\_RST command that can be sent through either the SPI or by UBM.

When power is first applied to the device, a POR circuit holds the device in reset until all supplies reach the specified operating voltages. The power-on reset returns the device to a known operating state in case a brownout event occurs (when the supplies have dipped below the minimum operating voltages). The POR starts all digital circuits in reset as the supply settles, and releases them to make sure that the device starts in the default condition and loads the OTP memory. After the OTP memory has been loaded, the ALARM pin is released. At this time, communication with the device is safe. This  $t_{\text{POR}}$  time is less than 100  $\mu\text{s}$ .

The devices also have a  $\overline{\text{RESET}}$  pin that is used as a hardware reset to the device. Send the  $\overline{\text{RESET}}$  pin low for a minimum of 100 ns ( $t_{\text{RESET}}$ ) to reset the device. A delay time of 10  $\mu\text{s}$  ( $t_{\text{RESETWAIT}}$ ) is required before sending the first serial interface command as the device latches and releases the reset. The release of the internal reset state is synchronized to the internal clock. The  $\overline{\text{RESET}}$  pin resets the SPI and the UART interfaces, the watchdog timer, the internal oscillator, and the device registers.  $\overline{\text{RESET}}$  does not reload the OTP memory.

The command to  $\text{RESET.SW\_RST} = 0x\text{AD}$  resets the device as a software reset. The command is decoded at the rising edge of  $\overline{\text{CS}}$  with an SPI command or during the stop bit of the last character of a UBM frame. Set  $\text{UBM.REG\_MODE}$  again to put the device back into UBM when resetting the device in UBM. After sending the RESET command, no delay time is required before sending the first serial interface command as the device latches and releases the reset. The reset is synchronized to the falling edge of the internal clock and is released well before the next rising edge. The ALARM pin pulses low for the width of the internal reset. This pulse duration is less than 20 ns. This command resets the SPI and the UART interface, and the watchdog timer, but does not reset the internal oscillator. The software reset also reloads internal factory trim registers if properly configured in the SPECIAL\_CFG register. The SPECIAL\_CFG register is only reset with a POR.

The POR and hardware reset place the internal oscillator into a reset condition, which holds the clock low. When these two signals are released, there is a delay of a few microseconds before the first rising edge of the clock. The hardware reset,  $\overline{\text{RESET}}$ , pulse width must be at least 100 ns to allow the oscillator to properly reset. The SW\_RST command is a short pulse. This pulse is not long enough to adequately reset the oscillator. The SW\_RST is asserted with a falling edge of the clock. As a result of the long oscillator period, the design architecture provides that all devices are out of reset by the next rising edge.

Figure 6-16 shows the reset tree.

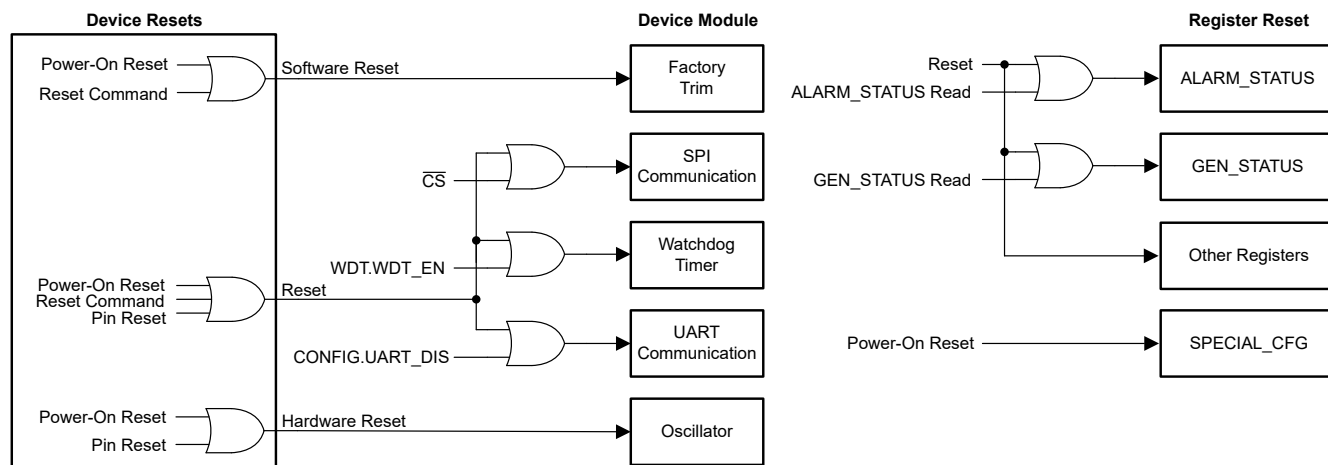


Figure 6-16. Reset Conditions

## 6.5 Programming

The AFE8201 communicate with the system controller through a serial interface that supports either a UART-compatible two-wire bus or an SPI-compatible bus. Based on the hardware configuration, either interface can be enabled. Figure 6-17 and Figure 6-18 show the configurations to enable SPI mode and UART break mode (UBM), respectively. The SPI supports an 8-bit frame-by-frame CRC that is enabled by default, but can be disabled by the user. UBM does not support CRC, but does support the UART protocol parity bit.

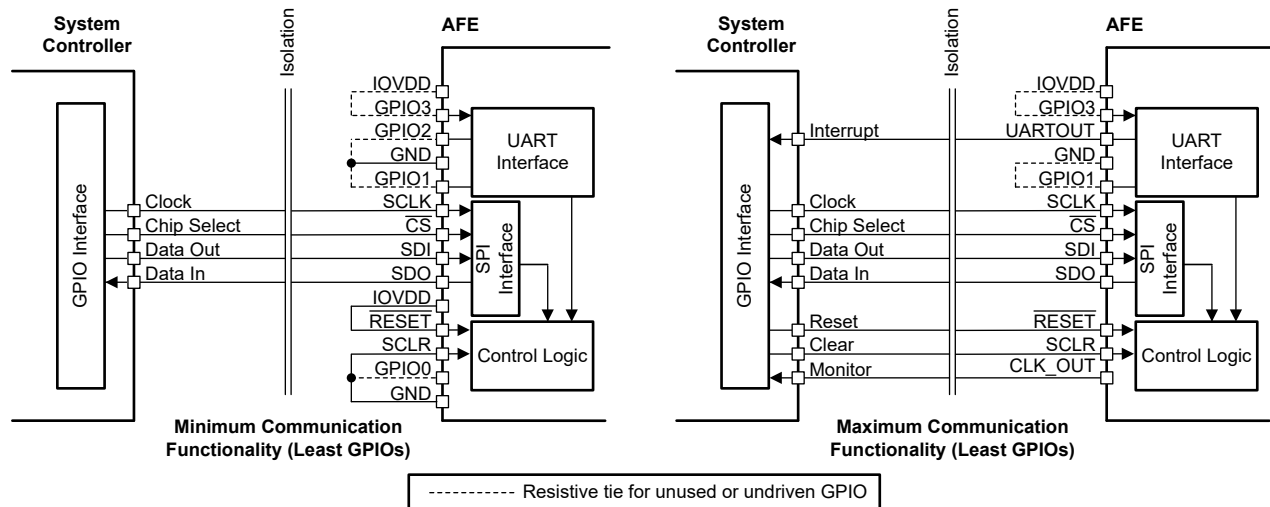
### 6.5.1 Communication Setup

After any reset or power up, the AFE8201 wake up able to use the SPI or UART break mode (UBM). The devices include a robust mechanism that configures the interface between either an SPI-compatible or UART-compatible protocol based system, thus preventing protocol change during normal operation. The selection is based on initial conditions from the respective hardware configurations (see Figure 6-17 and Figure 6-18) and any subsequent user configuration.

#### 6.5.1.1 SPI Mode

By default, the AFE8201 can be fully accessed with the SPI (except UBM.REG\_MODE). To set up the device in SPI mode:

1. Set CONFIG.UART\_DIS = 1 (disables the UART communication).
2. Optionally, set CONFIG.DSDO, CONFIG.FSDO, CONFIG.CLR\_PIN\_EN, and CONFIG.IRQ\_PIN\_EN. For details, see Table 7-5.



**Figure 6-17. SPI Mode Connections**

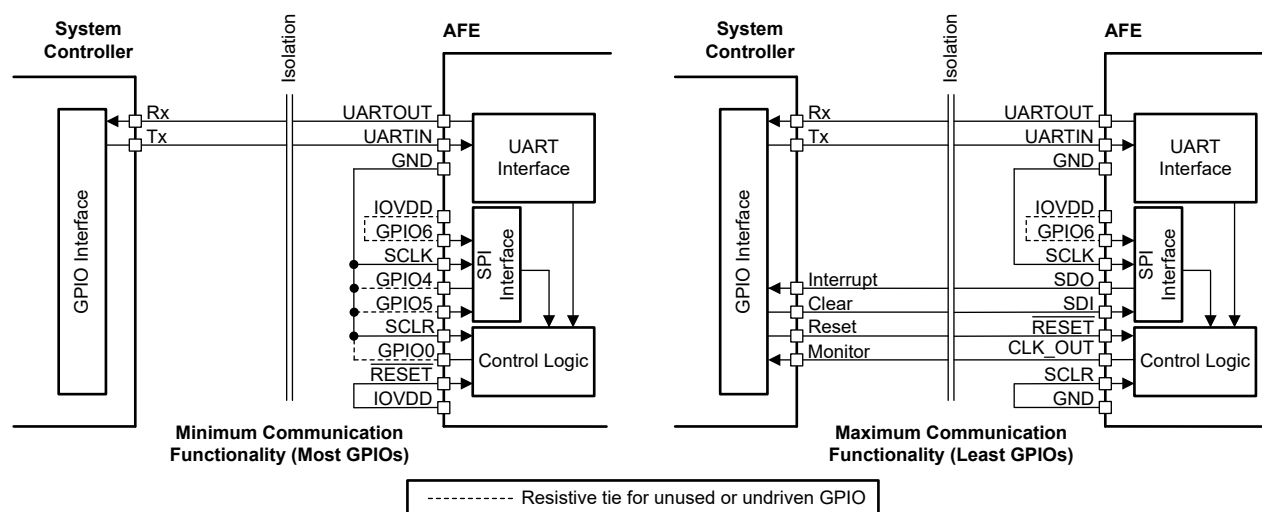
Figure 6-17 shows the SPI mode logical connections (through the isolation barrier, if used) for both minimum communication functionality (all optional communication pins disconnected, most GPIO pins available shown) and maximum communication functionality (all communication pins connected, least GPIO pins available shown). If CONFIG.IRQ\_PIN\_EN = 1 is set, then the UARTOUT pin functions as the IRQ output. In SPI mode, set CONFIG.SDO\_DSDO = 0 to enable the readback function. This function is disabled by default to save power. If the readback function not enabled, SDO remains in Hi-Z mode even during the subsequent frame after a read request. Enable each GPIO pin for use through proper register configuration. If a pin remains unused, tied the pin to either IOVDD using a pullup resistor or to GND using a pull-down resistor as indicated to avoid floating I/Os.

### 6.5.1.2 UART Mode

At power up, the UART interface is set to 9600 baud with UBM enabled. Any reset clears the UBM register, and the register must be set again to use UBM. To set up the device in UBM:

1. Using UBM, set UBM.REG\_MODE = 1 at 9600 baud. This setting blocks the SPI from accessing the device and enables the UART interface access to the entire register map.
2. Optionally, set CONFIG.CLR\_PIN\_EN and CONFIG.IRQ\_PIN\_EN (See [Table 7-5](#) for details).

[Figure 6-18](#) shows the UBM logical connections (through the isolation barrier, if used) for both minimum communication functionality (all optional communication pins disconnected, most GPIO pins available shown) and maximum communication functionality (all communication pins connected, least GPIO pins available shown). If CONFIG.IRQ\_PIN\_EN = 1 is set, then the SDO pin functions as the IRQ output. If CONFIG.CLR\_PIN\_EN = 1 is set, then the SDI pin controls the clear pin function. Enable each GPIO pin for use through proper register configuration. If a GPIO pin remains unused, tie the pin to either IOVDD using a pullup resistor or to GND using a pulldown resistor to avoid floating I/Os.



**Figure 6-18. UBM (UART Interface) Connections**

### 6.5.2 GPIO Programming

Seven physical pins are interoperable as GPIOs in the AFEx8201 when not used for communication. The state of these pins is set after the communication interface mode is determined (see [Section 6.5.1](#) for power-up conditions and connection-diagram options for each communication mode supported by the AFEx8201). Configure any unused communication pins as GPIO, and resistively tie the pins to IOVDD or GND, respectively, as described in [Section 6.5.1](#).

[Table 6-8](#) shows the pins and pin functions in UBM or SPI mode and lists the register configuration conditions to enable GPIO functionality for each pin. In addition to these register configurations, to use an available pin as GPIO, set the corresponding GPIO\_CFG.EN bit.

For a GPIO pin to be configured as an input, the following conditions must be met:

1. GPIO\_CFG.ODE for the pin must = 1
2. GPIO.DATA for the pin must = 1

After initialization, the pin state is Hi-Z. Reading the GPIO.DATA register reads the pin value.

If the previous conditions are not met, the pin is an output. In this case, the output drive type is determined by the GPIO\_CFG.ODE bits to be push-pull or pseudo open drain. The GPIO output is driven by the GPIO.DATA bits. All reads of GPIO.DATA reports the values of the pins, regardless if the pins are configured as GPIO or not. Data written to the GPIO.DATA bits cannot be read directly. If a pin is available for use as GPIO, then the corresponding GPIO\_CFG.EN bit must be set to enable GPIO functionality.

**Table 6-8. Pin Configuration in Each Interface Mode**

| PIN                           | UBM       |              | SPI                    |              | REGISTER CONFIGURATION TO ENABLE GPIO <sup>(1)</sup>               |
|-------------------------------|-----------|--------------|------------------------|--------------|--------------------------------------------------------------------|
|                               | FUNCTION  | DIRECTION    | FUNCTION               | DIRECTION    |                                                                    |
| GPIO6/ $\overline{\text{CS}}$ | GPIO      | Input/Output | $\overline{\text{CS}}$ | Input        | (UBM.REG_MODE = 1)                                                 |
| GPIO5/SDI                     | CLR/GPIO  | Input/Output | SDI                    | Input        | (UBM.REG_MODE = 1) AND (CONFIG.CLR_PIN_EN = 0)                     |
| GPIO4/SDO                     | IRQ/GPIO  | Input/Output | SDO                    | Output       | (UBM.REG_MODE = 1) AND (CONFIG.IRQ_PIN_EN = 0)                     |
| GPIO3/UARTIN                  | UARTIN    | Input        | GPIO                   | Input/Output | (CONFIG.UART_DIS = 1)                                              |
| GPIO2/UARTOUT                 | UARTOUT   | Output       | IRQ/GPIO               | Input/Output | (CONFIG.UART_DIS = 1) AND (CONFIG.IRQ_PIN_EN = 0)                  |
| GPIO1                         | GND       | N/A          | GPIO                   | Input/Output | (CONFIG.UART_DIS = 1)                                              |
| GPIO0/CLK_OUT                 | CLKO/GPIO | Input/Output | GPIO/CLKO              | Input/Output | (CONFIG.CLKO = 0) AND ((UBM.REGMODE = 1) OR (CONFIG.UART_DIS = 1)) |

(1) Required by pin in addition to the corresponding GPIO\_CFG.EN bit.

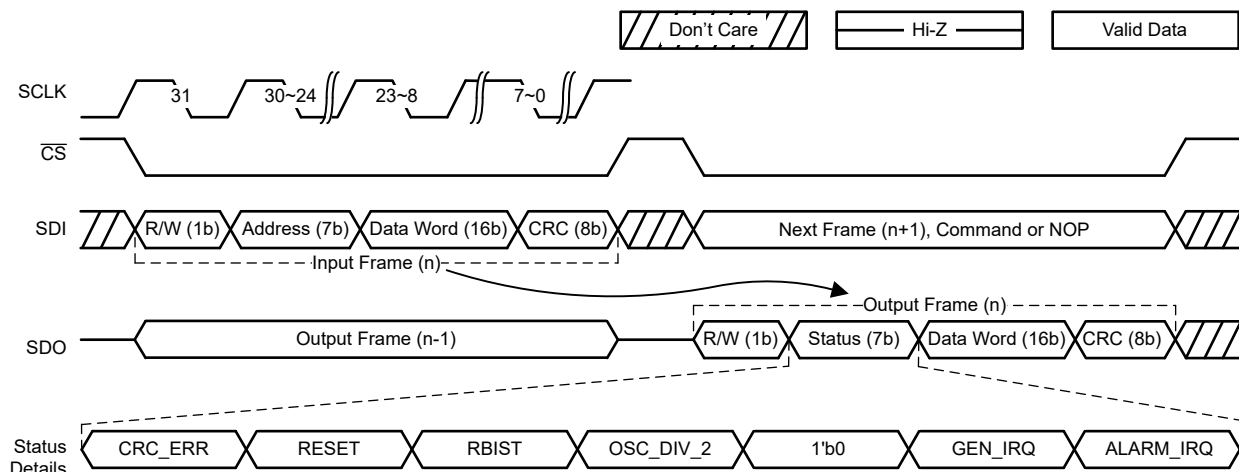
### 6.5.3 Serial Peripheral Interface (SPI)

The AFE8201 are controlled over a versatile four-wire serial interface (SDIN, SDO, SCLK, and  $\overline{\text{CS}}$ ). The interface operates at clock rates of up to 12.5 MHz and is compatible with SPI, QSPI, Microwire, and digital signal processing (DSP) standards. The SPI communication command consists of a read or write address, a data word, and an optional CRC byte.

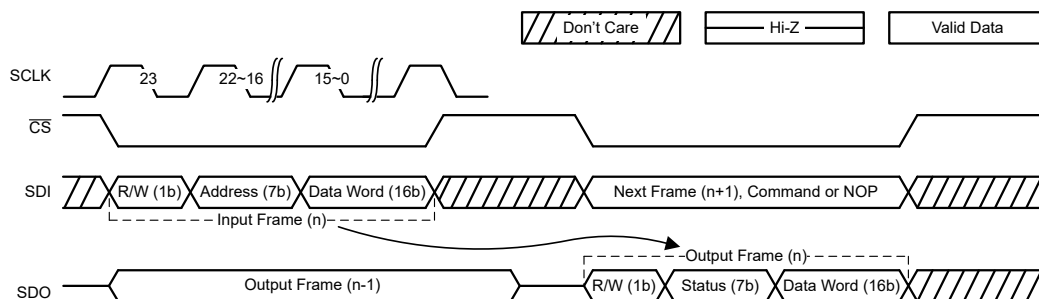
The SPI can access all register addresses except for the UBM register. Read-only and read-write capability is defined by register (see [Table 7-1](#)). The SPI supports both SPI Mode 1 (CPOL = 0, CPHA = 1) and SPI Mode 2 (CPOL = 1, CPHA = 0). The default SCLK value is low for SPI Mode 1 and high for SPI Mode 2. See [Section 5.7](#) for timing diagrams in each mode. The serial clock, SCLK, can be continuous or gated.

#### 6.5.3.1 SPI Frame Definition

Subject to the timing requirements listed in the [Timing Requirements](#), the first SCLK falling edge immediately following the falling edge of  $\overline{\text{CS}}$  captures the first frame bit. Subject to the same requirements, the last SCLK falling edge before the rising edge of  $\overline{\text{CS}}$  captures the last bit of the frame. [Figure 6-19](#) shows that the SPI shift register frame is 32-bits wide, and consists of an R/W bit, followed by a 7-bit address, and a 16-bit data word. The 8-bit CRC is optional (enabled by default) and is disabled by setting CONFIG.CRC\_EN = 0 (see also [Section 6.5.3.3](#)). [Figure 6-20](#) shows that when the CRC is disabled, the frame is 24-bits wide.



**Figure 6-19. SPI Frame Details (Default, CRC Enabled)**



**Figure 6-20. SPI Frame Details (CRC Disabled)**

For a valid frame, a full frame length of data (24 bits if CRC is disabled or 32 bits if CRC is enabled) must be transmitted before  $\overline{\text{CS}}$  is brought high. If  $\overline{\text{CS}}$  is brought high before the last falling SCLK edge of a full frame, then the data word is not transferred into the internal registers. If more than a full frame length of falling SCLK edges are applied before  $\overline{\text{CS}}$  is brought high, then the last full frame length number of bits are used. In other words, if the number of falling SCLK edges while  $\overline{\text{CS}} = 0$  is 34, then the last 32 SCLK cycles (or 24 if CRC is disabled) are treated as the valid frame. The device internal registers are updated from the SPI shift register on

the rising edge of  $\overline{CS}$ . To start another serial transfer, bring  $\overline{CS}$  low again. When  $\overline{CS}$  is high, the SCLK and SDI signals are blocked and the SDO pin is high impedance.

### 6.5.3.2 SPI Read and Write

The SDI input bit is latched on the SCLK falling edge. The SDI pin receives right-justified data. At the rising edge of  $\overline{CS}$ , the right-most (last) bits are evaluated as a frame. Extra clock cycles (exceeding frame length) during the frame begin to output on SDO the SDI data delayed by one frame length.

A read operation is started when R/W bit is 1. The data word input for SDI is ignored in the read command frame. Send the subsequent read or write command frame into SDI to clock out the data of the addressed register on SDO. If no other read or write commands are needed, then issue a NOP command to retrieve the requested data. The read register value is output most significant bit first on SDO on successive edges (rising or falling based on CONFIG.FSDO setting) of SCLK.

A write operation starts when R/W bit is 0. The SDO output to a write command, delivered in the next frame, contains status bits, data described in [Table 6-9](#), and if the CRC is enabled, an 8-bit CRC for the output frame.

**Table 6-9. Command Functions**

| COMMAND BIT     | SDI INPUT DATA WORD      | SDO RESPONSE DATA WORD <sup>(1)</sup> |
|-----------------|--------------------------|---------------------------------------|
| Write (R/W = 0) | Data to be written (16b) | 0x0000                                |
| Read (R/W = 1)  | Ignored <sup>(2)</sup>   | Register output data (16b)            |

(1) Response data portion in next frame output.

(2) The input bits are included in the calculation for CRC, if enabled (see [Section 6.5.3.3](#)).

Valid SDO output is driven only when  $\overline{CS} = 0$  and CONFIG.DSDO = 0; otherwise, the SDO pin remains Hi-Z to save power. The SDO data bits are left-justified within the frame, meaning the most significant bit is produced on the line (subject to timing details) when  $\overline{CS}$  is asserted low (bit is driven by falling edge of  $\overline{CS}$ ). The subsequent bits in the frame are driven by the rising SCLK edge when CONFIG.FSDO = 0 (default). To drive the SDO data on the falling edge of SCLK, set CONFIG.FSDO = 1. This setting effectively gives the SDO data an additional ½ clock period for setup time, but at the expense of hold time.

The frame output on SDO contains the command bit of the input that generated the frame (previous input frame), followed by seven status bits (see [Figure 6-19](#)). When an input frame CRC error is detected, the status bit CRC\_ERR = 1. If there is no input frame CRC error, then CRC\_ERR = 0. See [Table 6-10](#) for details.

### 6.5.3.3 Frame Error Checking

If the AFEx8201 are used in a noisy environment, use the CRC to check the integrity of the SPI data communication between the device and the system controller. This feature is enabled by default and is controlled by the CONFIG.CRC\_EN bit. If the CRC is not required in the system, disable frame error checking through the CRC\_EN bit, and switch from the default 32-bit frame to the 24-bit frame.

Frame error checking is based on the CRC-8-ATM (HEC) polynomial:  $x^8 + x^2 + x + 1$  (9'b100000111).

For the output register readback, the AFEx8201 supply the calculated 8-bit CRC for the 24 bits of data provided, as part of the 32-bit frame.

The AFEx8201 decodes 24-bits of the input frame data and the 8-bit CRC to compute the CRC remainder. If no error exists in the frame, the CRC remainder is zero. When the remainder is nonzero (that is, the input frame has single-bit or multiple-bit errors) the ALARM\_STATUS.CRC\_ERR\_CNT bits are incremented. A bad CRC value prevents execution of commands to the device.

When the CRC error counter reaches the limit programmed in CONFIG.CRC\_ERR\_CNT, the CRC\_FLT status bit is set in the ALARM\_STATUS register. The fault is reported (as long as the corresponding mask is not set) as an ALARM\_IRQ on SDO during the next frame. The  $\overline{ALARM}$  pin asserts low if enabled by the alarm action configuration (see [Section 6.3.3.2](#)).

The CRC\_ERR status bit (see [Figure 6-19](#)) in the SDO frame is not sticky and is only reported for the previous frame. The ALARM\_STATUS.CRC\_FLT bit is sticky and is only cleared after a successful read of

the ALARM\_STATUS register. Read the GEN\_STATUS or ALARM\_STATUS registers to clear any sticky bits that are set.

The sticky status bits are cleared at the start of the readback frame and are latched again at the end of the readback frame. Therefore, if the fault condition previously reported in the status register is no longer present at the end of the readback frame, and the data are received by the microcontroller with the CRC error, the fault information is lost. If a robust monitoring of the status bits is required in a noisy environment, use the IRQ pin in combination with the status mask bits to find out the status of each fault before clearing the status bits. Set the CONFIG.IRQ\_LVL bit to monitor the signal level on the IRQ pin, and unmask each status bit one at a time to retrieve the information from the status registers.

#### 6.5.3.4 Synchronization

The AFEx8201 register map runs on the internal clock domain. Both the SPI and UBM packets are synchronized to this domain. This synchronization adds a latency of 0.4  $\mu$ s to 1.22  $\mu$ s (1.5 internal clocks), with respect to the rising edge of CS or the STOP bit of the last byte of the UBM packet.

The effect of clock synchronization on UBM communication is not evident because of the lower speed and asynchronous nature of UBM communication.

In SPI mode, if changing register bits CONFIG.DSDO, CONFIG.FSDO, or CONFIG.CRC\_EN, keep  $\overline{CS}$  high for at least two clock cycles before issuing the next frame. Frame data corruption can occur if the two extra cycles are not used. The following are examples of frame corruption:

- Setting CONFIG.DSDO = 0: SDO begins to drive in the middle of the next frame.
- Changing CONFIG.FSDO: The launching edge of SDO changes in the middle of the next frame.
- Setting CONFIG.CRC\_EN = 1: The next frame has a CRC error because the CRC is enabled in the middle of the frame.

Send a NOP command (SDI = 0x00\_0000) after setting the DSDO, FSDO, and CRC\_EN bits to prevent the corrupted frames from impacting communication. Sending a NOP after CONFIG.CRC\_EN is set still generates a CRC error, and is reported in the STATUS portion of SDO. To avoid false errors, wait approximately 2  $\mu$ s after setting CONFIG.CRC\_EN before sending the next frame.

## 6.5.4 UART Interface

In UART mode, the device expects 1 start bit, 8 data bits, 1 odd parity bit, and 1 stop bit, or an 8O1 UART character format.

### 6.5.4.1 UART Break Mode (UBM)

In UART break mode (UBM), the microcontroller issues a UART break to start communication. The device interprets the UART break as the start to receive commands from the UART. A communication UART character consists of one start bit, eight data bits, one odd parity bit, and at least one stop bit. A UART break character is all 11 bits (including start, data, parity and stop bit) held low by the microcontroller on the UARTIN pin and by the AFE8201 on the UARTOUT pin. When a valid break character is detected on UARTIN by the AFE8201, no parity (even though parity is odd) or stop bit errors are flagged for this character. The parity and stop bit differences between valid UBM break and communication characters must be managed by the system microcontroller when receiving these characters from the UARTOUT pin of the AFE8201. See [Figure 5-2](#) for UBM break character, communication timing details, and bit order.

AFE8201 UART break mode communication is supported at 9600 baud.

Set UBM.REG\_MODE = 1 to enable register map access through the UART. By default, this bit is set to 0. The entire register map can only be accessed with SPI, except for the UBM register. The UBM register can only be accessed with UBM. After UBM.REG\_MODE is set to 1, the SPI does not have access to the register map, and the full register map is accessible by UBM.

A UBM data output packet is initiated by AFE8201 on UARTOUT in two cases. See [Figure 6-23](#) for packet structure details. If the R/IRQn status bit is 0 an IRQ event initiated the break command. If the R/IRQn status bit is 1, the break command is a response to the prior read request.

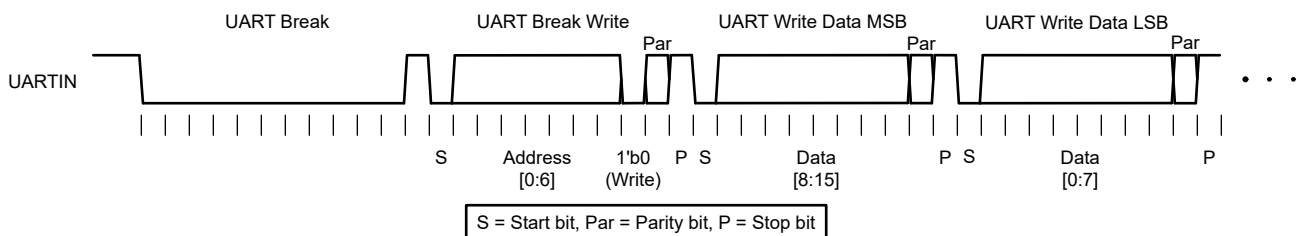
To enable IRQ events, set CONFIG.UBM\_IRQ\_EN = 1. When IRQ is enabled, the AFE8201 triggers a break command followed by data on UARTOUT (see [Figure 6-23](#)).

The contents of the data are listed in order of priority below.

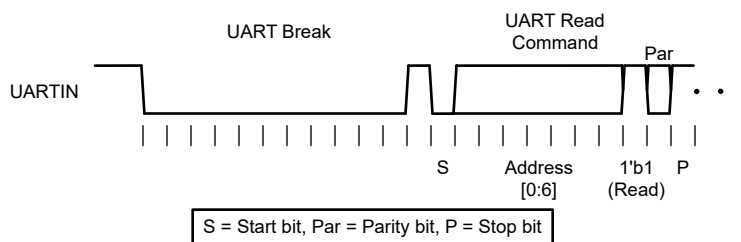
1. If ALARM\_IRQ bit is set, then the contents of the ALARM\_STATUS register are output.
2. If GEN\_IRQ is set, then the contents of the GEN\_STATUS register are output.
3. If none of the previous bits are set, then an IRQ is not generated.

A break byte is followed by three bytes. These three bytes have information identical to the SPI frame without the CRC (see [Figure 6-20](#)). The CRC cannot be enabled for UBM. All communication characters on the UART bus are transmitted least significant data bit (D0) first.

[Figure 6-21](#) shows the data structure of the UBM write command, and [Figure 6-22](#) shows the data structure of the UBM read command.

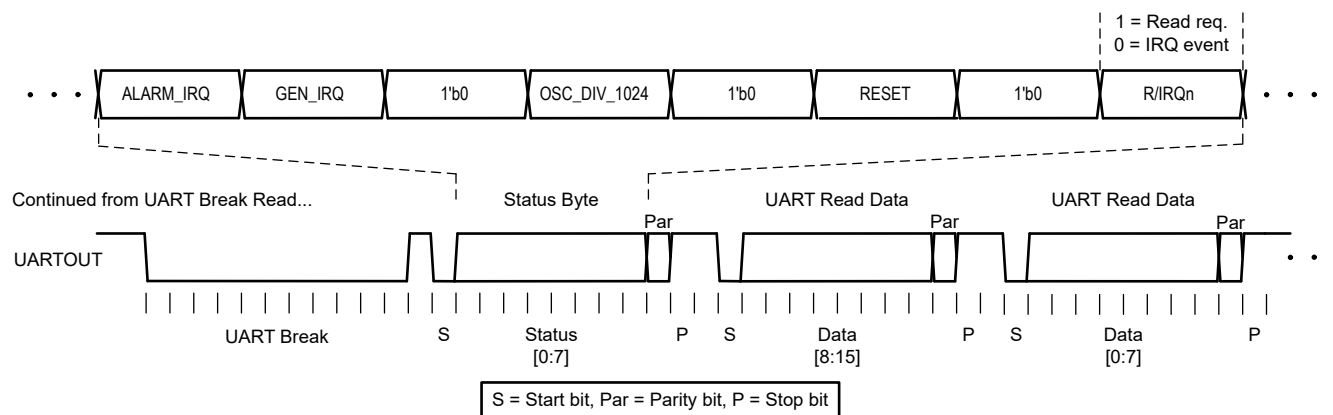


**Figure 6-21. UARTIN Break Write Data Format**



**Figure 6-22. UARTIN Break Read Data Format**

Figure 6-23 shows the UARTOUT data frame with details of the status bits produced by the AFEx8201. See Table 6-10 for details.



**Figure 6-23. UARTOUT Break Data Format**

### 6.5.5 Status Bits

In SPI mode and UBM, every response from the AFEx8201 includes a set of status bits. For SPI mode bit order, see [Section 6.5.3.1](#). For UBM bit order, [Section 6.5.4.1](#).

**Table 6-10. Status Bits**

| STATUS BIT                        | DESCRIPTION                                                                      | NOTES / REFERENCE                                                                                                                                                          |
|-----------------------------------|----------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| ALARM_IRQ                         | 1h = ALARM_IRQ asserted<br>0h = Normal operation                                 | From the GEN_STATUS <sup>(1)</sup> register ( <a href="#">Table 7-29</a> ).<br>See also <a href="#">Section 6.3.4</a> .                                                    |
| CRC_ERR<br>(CRC enabled SPI only) | 1h = CRC error detect in input frame<br>0h = No CRC error detected               | Generated by the SPI on a frame by frame basis.<br>See <a href="#">Section 6.5.3.3</a> .                                                                                   |
| GEN_IRQ                           | 1h = GEN_IRQ asserted<br>0h = Normal Operation                                   | From the ALARM_STATUS <sup>(1)</sup> register ( <a href="#">Table 7-28</a> ).<br>See also <a href="#">Section 6.3.4</a> .                                                  |
| OSC_DIV_1024 (UBM mode)           | 1h = Sampled signal is high<br>0h = Sampled signal is low                        | Subdivided internal oscillator clock signal (frequency divided by 1024) sampled at the falling edge of the status byte start bit. See also <a href="#">Section 6.3.7</a> . |
| OSC_DIV_2 (SPI mode)              | 1h = Sampled signal is high<br>0h = Sampled signal is low                        | Subdivided internal oscillator clock signal (frequency divided by 2) sampled at CS falling edge. See also <a href="#">Section 6.3.7</a> .                                  |
| R/IRQn (UBM only)                 | 1h = Read request<br>0h = IRQ event                                              | Generated by the UART interface on a frame by frame basis.<br>See <a href="#">Section 6.5.4.1</a> for details.                                                             |
| RBIST                             | 1h = RBIST busy (registers not readable)<br>0h = RBIST done (registers readable) | RBIST running status.<br>See <a href="#">Section 6.4.1</a> for details.                                                                                                    |
| RESET                             | 1h = First readback after RESET<br>0h = All other readbacks                      | From the GEN_STATUS register ( <a href="#">Table 7-29</a> ).<br>See also <a href="#">Section 6.4.3</a> .                                                                   |

- (1) ALARM\_STATUS, and GEN\_STATUS registers contain cross-readable IRQ flags for the other register. The ALARM\_STATUS register has the GEN\_IRQ bit. GEN\_STATUS has the ALARM\_IRQ bit. This functionality enables the system microcontroller to always get full status information by reading only one register, and thus save power.

### 6.5.6 Watchdog Timer

The AFEx8201 include a watchdog timer (WDT) that is used to make sure that communication between the system controller and the device is not lost. The WDT checks that the device received a communication from the system controller within a programmable period of time. To enable this feature, set WDT.WDT\_EN to 1. The WDT monitors both SPI and UBM communications.

The WDT has two limit fields: WDT.WDT\_UP and WDT.WDT\_LO. The WDT\_UP field sets the upper time limit for the WDT. The WDT\_LO field sets the lower time limit. If the WDT\_LO is set to a value other than 2'b00, then the WDT acts as a window comparator. If the write occurs too quickly (less than the WDT\_LO time), or too slowly (greater than the WDT\_UP time), then a WDT error is asserted. When acting as a window comparator, in the event of a WDT error, the WDT resets only when a write to the WDT register occurs. If the WDT\_LO is set to 2'b00, then a write to any register resets the WDT time counter. In this mode, the WDT error is asserted when the timer expires.

If enabled, the chip must have any SPI or UBM write to the device within the programmed timeout window. Otherwise, the  $\overline{\text{ALARM}}$  pin asserts low, and the ALARM\_STATUS.WD\_FLT bit is set to 1. The WD\_FLT bit is sticky. After a WD\_FLT has been asserted, WDT.WDT\_EN must be set to 0 to clear the WDT condition. Then the WDT can be re-enabled. The WDT condition is also cleared by issuing a software or hardware reset. After the WDT condition is clear, WD\_FLT is cleared by reading the ALARM\_STATUS register.

When using multiple AFEx8201 devices in a daisy-chain configuration, connect the open-drain  $\overline{\text{ALARM}}$  pins of all devices together to form a wired-OR network. The watchdog timer can be enabled in any number of the devices in the chain; although, enabling the watchdog timer in one device in the chain is usually sufficient. The wired-OR  $\overline{\text{ALARM}}$  pin can be pulled low in response to the simultaneous presence of different trigger conditions in the devices in the daisy-chain. The host processor must read the ALARM\_STATUS register of each device to know all the fault conditions present in the chain.

The watchdog timeout period is based on a 1200-Hz clock (1.2288 MHz / 1024).

## 7 Register Maps

Table 7-1 lists the memory-mapped registers for the AFEx8201 registers. Consider all register offset addresses not listed in Table 7-1 as reserved locations; do not modify these register contents.

**Table 7-1. Register Map**

| ADDR<br>(HEX) | REGISTER                   | BIT DESCRIPTION   |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
|---------------|----------------------------|-------------------|------------|----------------|----------|----------------|----|----------------|---------------|-------------------|------------|----------------|--------------|---------------------|--------------|----------------------|----------------|
|               |                            | 15                | 14         | 13             | 12       | 11             | 10 | 9              | 8             | 7                 | 6          | 5              | 4            | 3                   | 2            | 1                    | 0              |
| 00h           | NOP                        | NOP [15:0]        |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 01h           | DAC_DATA                   | DATA [15:0]       |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 02h           | CONFIG                     | CRC_ERR_CNT [1:0] |            | CLKO [3:0]     |          |                |    | UBM_IRQ_EN     | IRQ_PIN_EN    | CLR_PIN_EN        | UART_DIS   | RESERVED       | CRC_EN       | IRQ_POL             | IRQ_LVL      | DSDO                 | FSDO           |
| 03h           | DAC_CFG                    | RESERVED          |            |                | PD       | SR_CLK [2:0]   |    |                | SR_STEP [2:0] |                   |            | SR_EN          | SR_MODE      | RESERVED            | CLR          | RESERVED             |                |
| 04h           | DAC_GAIN                   | GAIN [15:0]       |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 05h           | DAC_OFFSET                 | OFFSET [15:0]     |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 06h           | DAC_CLR_CODE               | CODE [15:0]       |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 07h           | RESET                      | RESERVED          |            |                |          |                |    |                |               | SW_RST [7:0]      |            |                |              |                     |              |                      |                |
| 08h           | ADC_CFG                    | BUF_PD            | HYST [6:0] |                |          |                |    |                | FLT_CNT [2:0] |                   |            | AIN_RANGE      | EOC_PER_CH   | CONV_RATE [1:0]     |              | DIRECT_MODE          |                |
| 09h           | ADC_INDEX_CFG              | RESERVED          |            |                |          |                |    |                |               | STOP [3:0]        |            |                |              | START [3:0]         |              |                      |                |
| 0Ah           | TRIGGER                    | RESERVED          |            |                |          |                |    |                |               |                   |            |                | RBIST        | RESERVED            | SHADOW_LOAD  | ADC                  |                |
| 0Bh           | SPECIAL_CFG <sup>(1)</sup> | RESERVED          |            |                |          |                |    |                |               |                   |            |                |              | OTP_LOAD_SW_RST     | ALMV_POL     | AIN1_ENB             |                |
| 10h           | ALARM_ACT                  | SD_FLT [1:0]      |            | TEMP_FLT [1:0] |          | AIN1_FLT [1:0] |    | AIN0_FLT [1:0] |               | CRC_WDT_FLT [1:0] |            | VREF_FLT [1:0] |              | THERM_ERR_FLT [1:0] |              | THERM_WARN_FLT [1:0] |                |
| 11h           | WDT                        | RESERVED          |            |                |          |                |    |                |               |                   |            | WDT_UP [2:0]   |              |                     | WDT_LO [1:0] |                      | WDT_EN         |
| 12h           | AIN0_THRESHOLD             | Hi [7:0]          |            |                |          |                |    |                |               | Lo [7:0]          |            |                |              |                     |              |                      |                |
| 13h           | AIN1_THRESHOLD             | Hi [7:0]          |            |                |          |                |    |                |               | Lo [7:0]          |            |                |              |                     |              |                      |                |
| 14h           | TEMP_THRESHOLD             | Hi [7:0]          |            |                |          |                |    |                |               | Lo [7:0]          |            |                |              |                     |              |                      |                |
| 16h           | UBM <sup>(2)</sup>         | RESERVED          |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      | REG_MODE       |
| 18h           | SCRATCH                    | DATA [15:0]       |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 19h           | CHIP_ID_LSB                | ID [15:0]         |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 1Ah           | CHIP_ID_MSB                | ID [15:0]         |            |                |          |                |    |                |               |                   |            |                |              |                     |              |                      |                |
| 1Bh           | GPIO_CFG                   | RESERVED          | EN [6:0]   |                |          |                |    |                |               | RESERVED          | ODE [6:0]  |                |              |                     |              |                      |                |
| 1Ch           | GPIO                       | RESERVED          |            |                |          |                |    |                |               |                   | DATA [6:0] |                |              |                     |              |                      |                |
| 1Dh           | ALARM_STATUS_MASK          | RESERVED          |            | SD_FLT         | OSC_FAIL | RESERVED       |    |                | OTP_CRC_ERR   | CRC_FLT           | WD_FLT     | VREF_FLT       | ADC_AIN1_FLT | ADC_AIN0_FLT        | ADC_TEMP_FLT | THERM_ERR_FLT        | THERM_WARN_FLT |

**Table 7-1. Register Map (continued)**

| ADDR<br>(HEX) | REGISTER                        | BIT DESCRIPTION |             |               |                |               |             |             |             |            |            |            |              |                 |                  |                |                 |
|---------------|---------------------------------|-----------------|-------------|---------------|----------------|---------------|-------------|-------------|-------------|------------|------------|------------|--------------|-----------------|------------------|----------------|-----------------|
|               |                                 | 15              | 14          | 13            | 12             | 11            | 10          | 9           | 8           | 7          | 6          | 5          | 4            | 3               | 2                | 1              | 0               |
| 1Eh           | <a href="#">GEN_STATUS_MASK</a> | RESERVED        |             |               |                |               | RBIST_DONE  | RBIST_FAIL  | RESERVED    | SR_BUSYn   | ADC_EOC    | RESERVED   |              | BREAK_FRAME_ERR | BREAK_PARITY_ERR | UART_FRAME_ERR | UART_PARITY_ERR |
| 20h           | <a href="#">ALARM_STATUS</a>    | GEN_IRQ         | RESERVED    | SD_FLT        | OSC_FAIL       | CRC_CNT [1:0] |             | OTP_LOADEDn | OTP_CRC_ERR | CRC_FLT    | WD_FLT     | VREF_FLT   | ADC_AIN1_FLT | ADC_AIN0_FLT    | ADC_TEMP_FLT     | THERM_ERR_FLT  | THERM_WARN_FLT  |
| 21h           | <a href="#">GEN_STATUS</a>      | ALARM_IRQ       | RESERVED    |               | OTP_BUSY       | RBIST_MODE    | RBIST_DONE  | RBIST_FAIL  | RESET       | SR_BUSYn   | ADC_EOC    | ADC_BUSY   | PVDD_HI      | BREAK_FRAME_ERR | BREAK_PARITY_ERR | UART_FRAME_ERR | UART_PARITY_ERR |
| 23h           | <a href="#">ADC_FLAGS</a>       | RESERVED        |             |               |                |               |             |             | SD4_FAIL    | SD3_FAIL   | SD2_FAIL   | SD1_FAIL   | SD0_FAIL     | TEMP_FAIL       | AIN1_FAIL        | AIN0_FAIL      | RESERVED        |
| 24h           | <a href="#">ADC_AIN0</a>        | RESERVED        |             |               |                |               | DATA [11:0] |             |             |            |            |            |              |                 |                  |                |                 |
| 25h           | <a href="#">ADC_AIN1</a>        | RESERVED        |             |               |                |               | DATA [11:0] |             |             |            |            |            |              |                 |                  |                |                 |
| 26h           | <a href="#">ADC_TEMP</a>        | RESERVED        |             |               |                |               | DATA [11:0] |             |             |            |            |            |              |                 |                  |                |                 |
| 27h           | <a href="#">ADC_SD_MUX</a>      | RESERVED        |             |               |                |               | DATA [11:0] |             |             |            |            |            |              |                 |                  |                |                 |
| 28h           | <a href="#">ADC_OFFSET</a>      | RESERVED        |             |               |                |               | DATA [11:0] |             |             |            |            |            |              |                 |                  |                |                 |
| 2Ch           | <a href="#">DAC_OUT</a>         | DATA [15:0]     |             |               |                |               |             |             |             |            |            |            |              |                 |                  |                |                 |
| 2Dh           | <a href="#">ADC_OUT</a>         | RESERVED        |             |               |                |               | DATA [11:0] |             |             |            |            |            |              |                 |                  |                |                 |
| 2Eh           | <a href="#">ADC_BYP</a>         | DATA_BYP_EN     | OFST_BYP_EN | DIS_GND_SAMP  | RESERVED       | DATA [11:0]   |             |             |             |            |            |            |              |                 |                  |                |                 |
| 2Fh           | <a href="#">FORCE_FAIL</a>      | CRC_FLT         | VREF_FLT    | THERM_ERR_FLT | THERM_WARN_FLT | RESERVED      |             | SD4_HI_FLT  | SD4_LO_FLT  | SD3_HI_FLT | SD3_LO_FLT | SD2_HI_FLT | SD2_LO_FLT   | SD1_HI_FLT      | SD1_LO_FLT       | SD0_HI_FLT     | SD0_LO_FLT      |
| 3Bh           | <a href="#">TIMER_CFG_0</a>     | RESERVED        |             |               |                |               |             |             |             |            |            |            |              | CLK_SEL [1:0]   |                  | INVERT         | ENABLE          |
| 3Ch           | <a href="#">TIMER_CFG_1</a>     | PERIOD [15:0]   |             |               |                |               |             |             |             |            |            |            |              |                 |                  |                |                 |
| 3Dh           | <a href="#">TIMER_CFG_2</a>     | SET_TIME [15:0] |             |               |                |               |             |             |             |            |            |            |              |                 |                  |                |                 |
| 3Eh           | <a href="#">CRC_RD</a>          | CRC [15:0]      |             |               |                |               |             |             |             |            |            |            |              |                 |                  |                |                 |
| 3Fh           | <a href="#">RBIST_CRC</a>       | CRC [15:0]      |             |               |                |               |             |             |             |            |            |            |              |                 |                  |                |                 |

- (1) The SPECIAL\_CFG register can only be reset with POR, and does not respond to the **RESET** pin or SW\_RST command.
- (2) The UBM register can only be accessed with a UBM command.

## 7.1 AFEx8201 Registers

Complex bit access types are encoded to fit into small table cells. The following table shows the codes that are used for access types in this section.

**Table 7-2. AFEx8201 Access-Type Codes**

| Access Type                     | Code | Description                                                                                                                                                                                                                                                                 |
|---------------------------------|------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>Read Type</b>                |      |                                                                                                                                                                                                                                                                             |
| R                               | R    | Read                                                                                                                                                                                                                                                                        |
| <b>Write Type</b>               |      |                                                                                                                                                                                                                                                                             |
| W                               | W    | Write                                                                                                                                                                                                                                                                       |
| W                               | WO   | Write only                                                                                                                                                                                                                                                                  |
| W                               | WSC  | Write self clear                                                                                                                                                                                                                                                            |
| <b>Reset or Default Value</b>   |      |                                                                                                                                                                                                                                                                             |
| -n                              |      | Value after reset or the default value                                                                                                                                                                                                                                      |
| <b>Register Array Variables</b> |      |                                                                                                                                                                                                                                                                             |
| i,j,k,l,m,n                     |      | When used in a register name, an offset, or an address, these variables refer to the value of a register array where the register is part of a group of repeating registers. The register groups form a hierarchical structure and the array is represented with a formula. |
| y                               |      | When used in a register name, an offset, or an address, this variable refers to the value of a register array.                                                                                                                                                              |

### 7.1.1 NOP Register (Offset = 0h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-3. NOP Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                     |
|------|-------|------|-------|---------------------------------------------------------------------------------|
| 15-0 | NOP   | WO   | 0h    | No operation.<br>Data written to this field have no effect. Always reads zeros. |

### 7.1.2 DAC\_DATA Register (Offset = 1h) [Reset = 0000h]

Return to the [Register Map](#).

DAC code for VOUT.

**Table 7-4. DAC\_DATA Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                 |
|------|-------|------|-------|-----------------------------|
| 15-0 | DATA  | R/W  | 0h    | Data.<br>DAC code for VOUT. |

### 7.1.3 CONFIG Register (Offset = 2h) [Reset = 0036h]

Return to the [Register Map](#).

**Table 7-5. CONFIG Register Field Descriptions**

| Bit   | Field       | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                         |
|-------|-------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-14 | CRC_ERR_CNT | R/W  | 0h    | CRC Errors Count Limit<br>Sets the numbers of consecutive SPI CRC frames that must have errors before the status bits is set.<br>0h = 1 (default); 1h = 2; 2h = 4; 3h = 8                                                                                                                                                                                                                                                           |
| 13-10 | CLKO        | R/W  | 0h    | CLKO Enable<br>Enable the CLK_OUT pin and set the divider value.<br>0h = CLKO disabled (default);<br>1h = 1.2288 MHz;<br>2h = 1.2288 / 2 MHz;<br>3h = 1.2288 / 4 MHz;<br>4h = 1.2288 / 8 MHz;<br>5h = 1.2288 / 16 MHz;<br>6h = 1.2288 / 32 MHz;<br>7h = 1.2288 / 64 MHz;<br>8h = 1.2288 / 128 MHz;<br>9h = 1.2288 / 256 MHz;<br>Ah = 1.2288 / 512 MHz;<br>Bh = 1.2288 / 1024 MHz;<br>Ch = 1'b0; Dh = 1'b0; Eh = 1'b0;<br>Fh = Timer |
| 9     | UBM_IRQ_EN  | R/W  | 0h    | UBM IRQ Enable<br>Enable IRQ to be sent on UARTOUT through UBM.<br>0h = Disabled (default); 1h = Enabled                                                                                                                                                                                                                                                                                                                            |
| 8     | IRQ_PIN_EN  | R/W  | 0h    | IRQ Pin Enable<br>Enable IRQ pin functionality.<br>0h = Disabled (default); 1h = Enabled                                                                                                                                                                                                                                                                                                                                            |
| 7     | CLR_PIN_EN  | R/W  | 0h    | Clear Input Pin Enable<br>Enable pin-based transition to the CLEAR state in UBM and SPI.<br>0h = Disabled (default); 1h = SCLR pin enabled in SPI mode or SDI pin configured as clear input pin in UBM                                                                                                                                                                                                                              |
| 6     | UART_DIS    | R/W  | 0h    | UART Disable<br>Disable UART functionality.<br>0h = UART Enabled (default); 1h = UART Disabled                                                                                                                                                                                                                                                                                                                                      |
| 5     | RESERVED    | R    | 1h    | Reserved. Always set this bit to 1h for proper functionality.                                                                                                                                                                                                                                                                                                                                                                       |
| 4     | CRC_EN      | R/W  | 1h    | CRC Enable<br>Enable CRC for SPI.<br>0h = Disabled; 1h = Enabled (default)                                                                                                                                                                                                                                                                                                                                                          |
| 3     | IRQ_POL     | R/W  | 0h    | IRQ Polarity<br>0h = Active low (default); 1h = Active high                                                                                                                                                                                                                                                                                                                                                                         |
| 2     | IRQ_LVL     | R/W  | 1h    | IRQ Level<br>0h = Edge sensitive; 1h = Level sensitive (default)                                                                                                                                                                                                                                                                                                                                                                    |
| 1     | DSDO        | R/W  | 1h    | SDO Hi-Z<br>0h = Drive SDO during $\overline{CS} = 0$ ; 1h = SDO always Hi-Z (default)                                                                                                                                                                                                                                                                                                                                              |
| 0     | FSDO        | R/W  | 0h    | Fast SDO<br>SDO is driven on negative edge of SCLK.<br>0h = drive SDO on rising edge of SCLK (launching edge) (default)<br>1h = drive SDO on falling edge of SCLK (capture edge 1/2 clock early)                                                                                                                                                                                                                                    |

### 7.1.4 DAC\_CFG Register (Offset = 3h) [Reset = 0B00h]

Return to the [Register Map](#).

**Table 7-6. DAC\_CFG Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                                                                                                                                                      |
|-------|----------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-13 | RESERVED | R/W  | 0h    |                                                                                                                                                                  |
| 12    | PD       | R/W  | 0h    | DAC Output Buffer Power-down<br>DAC output set to Hi-Z in power-down.<br>0h = DAC output buffer enabled (default)<br>1h = DAC output buffer disabled             |
| 11-9  | SR_CLK   | R/W  | 5h    | Slew Clock Rate<br>0h = 307.2 kHz<br>1h = 153.6 kHz<br>2h = 76.8 kHz<br>3h = 38.4 kHz<br>4h = 19.2 kHz<br>5h = 9600 Hz (default)<br>6h = 4800 Hz<br>7h = 2400 Hz |
| 8-6   | SR_STEP  | R/W  | 4h    | Slew Step Size<br>0h = 1 code<br>1h = 2 codes<br>2h = 4 codes<br>3h = 8 codes<br>4h = 16 codes (default)<br>5h = 32 codes<br>6h = 64 codes<br>7h = 128 codes     |
| 5     | SR_EN    | R/W  | 0h    | Slew Enable<br>Enables slew on the output voltage.<br>0h = Disabled (default)<br>1h = Enabled                                                                    |
| 4     | SR_MODE  | R/W  | 0h    | Slew Mode<br>Output slew rate mode select.<br>0h = Linear Slew (default)<br>1h = Sinusoidal Slew                                                                 |
| 3     | RESERVED | R    | 0h    |                                                                                                                                                                  |
| 2     | CLR      | R/W  | 0h    | CLEAR State<br>0h = Normal operation (default)<br>1h = Force the DAC to the CLEAR state                                                                          |
| 1-0   | RESERVED | R    | 0h    |                                                                                                                                                                  |

### 7.1.5 DAC\_GAIN Register (Offset = 4h) [Reset = 8000h]

Return to the [Register Map](#).

**Table 7-7. DAC\_GAIN Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                                                             |
|------|-------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------|
| 15-0 | GAIN  | R/W  | 8000h | Gain<br>Set the gain of the DAC output from 0.5 – 1.499985.<br>For example:<br>0000h = 0.5<br>8000h = 1.0 (default)<br>FFFFh = 1.499985 |

### 7.1.6 DAC\_OFFSET Register (Offset = 5h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-8. DAC\_OFFSET Register Field Descriptions**

| Bit  | Field  | Type | Reset | Description                                                                                                                |
|------|--------|------|-------|----------------------------------------------------------------------------------------------------------------------------|
| 15-0 | OFFSET | R/W  | 0h    | Offset<br>Adjust the offset of the DAC output, 2's complement number.<br>For example:<br>0000h = 0 (default)<br>FFFFh = –1 |

### 7.1.7 DAC\_CLR\_CODE Register (Offset = 6h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-9. DAC\_CLR\_CODE Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                        |
|------|-------|------|-------|----------------------------------------------------------------------------------------------------|
| 15-0 | CODE  | R/W  | 0h    | CLEAR State DAC Code<br>DAC code applied in the CLEAR state. See <a href="#">Section 6.3.1.6</a> . |

### 7.1.8 RESET Register (Offset = 7h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-10. RESET Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                             |
|------|----------|------|-------|---------------------------------------------------------|
| 15-8 | RESERVED | R    | 0h    |                                                         |
| 7-0  | SW_RST   | WSC  | 0h    | Software Reset<br>Write ADh to initiate software reset. |

### 7.1.9 ADC\_CFG Register (Offset = 8h) [Reset = 8810h]

Return to the [Register Map](#).

**Table 7-11. ADC\_CFG Register Field Descriptions**

| Bit  | Field       | Type | Reset | Description                                                                                                                                                                                                                                        |
|------|-------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15   | BUF_PD      | R/W  | 1h    | ADC Buffer Power-Down<br>0h = ADC buffer enabled; 1h = ADC buffer powered down (default)                                                                                                                                                           |
| 14-8 | HYST        | R/W  | 8h    | Hysteresis<br>The number of codes of hysteresis used when a threshold is exceeded for an ADC measurement of AIN0/AIN1/TEMP.                                                                                                                        |
| 7-5  | FLT_CNT     | R/W  | 0h    | Fault Count<br>Number of successive faults to trip an alarm.<br>Number of successive faults is programmed value + 1 (1-8 faults).                                                                                                                  |
| 4    | AIN_RANGE   | R/W  | 1h    | ADC Analog Input Range<br>Can only be set if PVDD ≥ 2.7 V to use 2.5-V range for AIN0 and AIN1 inputs.<br>0h = 2 × VREF; 1h = 1 × VREF (default)                                                                                                   |
| 3    | EOC_PER_CH  | R/W  | 0h    | ADC End-of-Conversion for Every Channel<br>Sends an EOC pulse at the end of each channel instead of at the end of all the channels.<br>0h = EOC after last channel (default); 1h = EOC for every channel                                           |
| 2-1  | CONV_RATE   | R/W  | 0h    | ADC Conversion Rate<br>This setting only affects the conversion rate for channels AIN0 and AIN1. Rates are based on a 76.8-kHz ADC clock. All other channels use 2560 Hz.<br>0h = 3840 Hz (default)<br>1h = 2560 Hz<br>2h = 1280 Hz<br>3h = 640 Hz |
| 0    | DIRECT_MODE | R/W  | 0h    | Direct Mode Enable<br>0h = Auto mode (default); 1h = Direct mode                                                                                                                                                                                   |

### 7.1.10 ADC\_INDEX\_CFG Register (Offset = 9h) [Reset = 0080h]

Return to the [Register Map](#).

The ADC custom channel sequencing configuration is shown in [Table 7-12](#).

**Table 7-12. ADC\_INDEX\_CFG Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                                                                                                                                                                                                     |
|------|----------|------|-------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-8 | RESERVED | R    | 0h    |                                                                                                                                                                                                                                                                                                                 |
| 7-4  | STOP     | R/W  | 8h    | Custom Channel Sequencer Stop Index<br>CCS index to stop ADC sequence. Must be ≥ START. If not, STOP is forced to = START.<br>0h = OFFSET<br>1h = AIN0<br>2h = AIN1<br>3h = TEMP<br>4h = SD0 (VREF)<br>5h = SD1 (PVDD)<br>6h = SD2 (VDD)<br>7h = SD3 (ZTAT)<br>8h = SD4 (VOUT) (default)<br>9h through Fh = GND |
| 3-0  | START    | R/W  | 0h    | Custom Channel Sequencer Start Index<br>CCS index to start ADC sequence.<br>0h through Fh = Same as STOP field (0h is default)                                                                                                                                                                                  |

### 7.1.11 TRIGGER Register (Offset = Ah) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-13. TRIGGER Register Field Descriptions**

| Bit  | Field      | Type | Reset | Description                                                                                                                                                                                                                                                                                |
|------|------------|------|-------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-4 | RESERVED   | R    | 0h    |                                                                                                                                                                                                                                                                                            |
| 3    | RBIST      | WSC  | 0h    | RBIST Trigger<br>This trigger initiates a Register BIST. This BIST runs a CRC calculation through the configuration registers ( <a href="#">Table 6-7</a> ) and compares the result to a stored CRC value in the RBIST_CRC register.                                                       |
| 2    | RESERVED   | R    | 0h    |                                                                                                                                                                                                                                                                                            |
| 1    | SHADOWLOAD | WSC  | 0h    | Shadow Load Trigger<br>This trigger initiates the loading of the OTP array into the parallel latches. If an OTP CRC error is detected, assert this trigger to try and reload the OTP into the memory locations.                                                                            |
| 0    | ADC        | WSC  | 0h    | ADC Trigger<br>In auto mode, this bit enables or disables the conversions. Manually set to 1 (enable) or 0 (disable). In direct mode, set this bit to start a conversion sequence. The bit is cleared at the end of the sequence. To stop a sequence prematurely, manually clear this bit. |

### 7.1.12 SPECIAL\_CFG Register (Offset = Bh) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-14. SPECIAL\_CFG Register Field Descriptions**

| Bit  | Field           | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                               |
|------|-----------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-3 | RESERVED        | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                                           |
| 2    | OTP_LOAD_SW_RST | R/W  | 0h    | OTP (One Time Programmable Factory Trimmed Registers) LOAD with SW RESET<br>OTP reloads with the assertion of a software reset (SW_RST).<br>0h = No reload with SW_RST<br>1h = Reload with SW_RST                                                                                                                                                                                                                                         |
| 1    | ALMV_POL        | R/W  | 0h    | Alarm Voltage Polarity<br>This register bit is ORed with the POL_SEL/AIN1 pin (if AIN1_ENB bit is low) to control the VOUT during a hardware reset condition or if alarm is active and alarm action is set appropriately. The following Boolean function is implemented for the internal signal ALMV_POL_o that sets the VOUT voltage:<br>ALMV_POL_o = ALMV_POL OR (POL_SEL/AIN1 AND NOT AIN1_ENB)<br>0h = Low (0 V)<br>1h = High (2.5 V) |
| 0    | AIN1_ENB        | R/W  | 0h    | AIN1 Pin Enable<br>This bit determines whether the POL_SEL/AIN1 pin acts as alarm voltage polarity control bit or an input channel to the ADC.<br>0h = AIN1 pin acts as alarm voltage polarity bit and ADC converts GND<br>1h = AIN1 pin is an active channel to the ADC                                                                                                                                                                  |

### 7.1.13 ALARM\_ACT Register (Offset = 10h) [Reset = 8020h]

Return to the [Register Map](#).

**Table 7-15. ALARM\_ACT Register Field Descriptions**

| Bit   | Field          | Type | Reset | Description                                                                                                                                                                                                                                                |
|-------|----------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-14 | SD_FLT         | R/W  | 2h    | Self-Diagnostic Fault Action<br>These bits set the device action after a self-diagnostic fault.<br>0h = No Action<br>1h = Set DAC to CLEAR state<br>2h = Switch to alarm voltage determined by ALMV_POL (default)<br>3h = Place DAC into Hi-Z (power-down) |
| 13-12 | TEMP_FLT       | R/W  | 0h    | TEMP Fault Action<br>These bits set the device action if the ADC temperature is outside the TEMP_THRESHOLD Hi or Lo thresholds.<br>0h through 3h = Same as SD_FLT field (default 0h)                                                                       |
| 11-10 | AIN1_FLT       | R/W  | 0h    | AIN1 Fault Action<br>These bits set the device action if the ADC AIN1 channel is outside the AIN1_THRESHOLD Hi or Lo thresholds.<br>0h through 3h = Same as SD_FLT field (default 0h)                                                                      |
| 9-8   | AIN0_FLT       | R/W  | 0h    | AIN0 Fault Action<br>These bits set the device action if the ADC AIN0 channel is outside the AIN0_THRESHOLD Hi or Lo thresholds.<br>0h through 3h = Same as SD_FLT field (default 0h)                                                                      |
| 7-6   | CRC_WDT_FLT    | R/W  | 0h    | CRC and WDT Fault Action<br>These bits set the device action when a SPI CRC or SPI Watchdog Timeout error occurs.<br>0h through 3h = Same as SD_FLT field (default 0h)                                                                                     |
| 5-4   | VREF_FLT       | R/W  | 2h    | VREF Fault Action<br>These bits set the device action when a fault is detected on VREF.<br>0h through 3h = Same as SD_FLT field a                                                                                                                          |
| 3-2   | THERM_ERR_FLT  | R/W  | 0h    | Thermal Error Fault Action<br>These bits set the device action when a high temperature error occurs (> 130°C).<br>0h through 3h = Same as SD_FLT field (default 0h)                                                                                        |
| 1-0   | THERM_WARN_FLT | R/W  | 0h    | Thermal Warning Fault Action<br>These bits set the device action when a high temperature warning occurs (> 85°C).<br>0h through 3h = Same as SD_FLT field (default 0h)                                                                                     |

### 7.1.14 WDT Register (Offset = 11h) [Reset = 0018h]

Return to the [Register Map](#).

**Table 7-16. WDT Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
|------|----------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-6 | RESERVED | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| 5-3  | WDT_UP   | R/W  | 3h    | Watchdog Timer (WDT) Upper Limit<br>If the WDT is enabled and the timer exceeds the programmed value, a WDT error is asserted. All times are based on 1200-Hz clock (1.2288 MHz / 1024).<br>0h = 53 ms (64 clocks)<br>1h = 106 ms (128 clocks)<br>2h = 427 ms (512 clocks)<br>3h = 853 ms (1024 clocks, default)<br>4h = 1.7 s (2048 clocks)<br>5h = 2.56 s (3072 clocks)<br>6h = 3.41 s (4096 clocks)<br>7h = 5.12 s (6144 clocks)                                                                                                                               |
| 2-1  | WDT_LO   | R/W  | 0h    | WDT Lower Limit<br>If the WDT is enabled and the WDT Lower Limit is enabled, then only a write to this register resets the WDT timer. If the write occurs before the WDT Lower Limit time, or after the WDT Upper Limit time, then a WDT error is asserted. If WDT Lower Limit is disabled, then a write to any register resets the timer. This is true for both SPI and UART Break modes. All times are based on 1200-Hz clock (1.2288 MHz / 1024).<br>0h = Disabled (default)<br>1h = 53 ms (64 clocks)<br>2h = 106 ms (128 clocks)<br>3h = 427 ms (512 clocks) |
| 0    | WDT_EN   | R/W  | 0h    | WDT Enable<br>0h = Disabled (default); 1h = Enabled                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |

### 7.1.15 AIN0\_THRESHOLD Register (Offset = 12h) [Reset = FF00h]

Return to the [Register Map](#).

**Table 7-17. AIN0\_THRESHOLD Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                                 |
|------|-------|------|-------|-------------------------------------------------------------------------------------------------------------|
| 15-8 | Hi    | R/W  | FFh   | High Threshold for Channel AIN0 {[11:4],4b1111}<br>This value is compared (>) against AIN0 data bits[11:0]. |
| 7-0  | Lo    | R/W  | 0h    | Low Threshold for Channel AIN0 {[11:4],4b0000}<br>This value is compared (<) against AIN0 data bits[11:0].  |

### 7.1.16 AIN1\_THRESHOLD Register (Offset = 13h) [Reset = FF00h]

Return to the [Register Map](#).

**Table 7-18. AIN1\_THRESHOLD Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                                 |
|------|-------|------|-------|-------------------------------------------------------------------------------------------------------------|
| 15-8 | Hi    | R/W  | FFh   | High Threshold for Channel AIN1 {[11:4],4b1111}<br>This value is compared (>) against AIN1 data bits[11:0]. |
| 7-0  | Lo    | R/W  | 0h    | Low Threshold for Channel AIN1 {[11:4],4b0000}<br>This value is compared (<) against AIN1 data bits[11:0].  |

### 7.1.17 TEMP\_THRESHOLD Register (Offset = 14h) [Reset = FF00h]

Return to the [Register Map](#).

**Table 7-19. TEMP\_THRESHOLD Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                                 |
|------|-------|------|-------|-------------------------------------------------------------------------------------------------------------|
| 15-8 | Hi    | R/W  | FFh   | High Threshold for Channel TEMP {[11:4],4b1111}<br>This value is compared (>) against TEMP data bits[11:0]. |
| 7-0  | Lo    | R/W  | 0h    | Low Threshold for Channel TEMP {[11:4],4b0000}<br>This value is compared (<) against TEMP data bits[11:0].  |

### 7.1.18 UBM Register (Offset = 16h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-20. UBM Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                                                                                                                   |
|------|----------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-1 | RESERVED | R    | 0h    |                                                                                                                                                                                                                               |
| 0    | REG_MODE | R/W  | 0h    | Register Mode<br>Configure the rest of the Register Map to be accessed by UART break mode (UBM) or SPI. This register can only be written by the UART Break communication.<br>0h = SPI Mode (default)<br>1h = UART Break Mode |

### 7.1.19 SCRATCH Register (Offset = 18h) [Reset = FFFFh]

Return to the [Register Map](#).

**Table 7-21. SCRATCH Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                                             |
|------|-------|------|-------|-------------------------------------------------------------------------------------------------------------------------|
| 15-0 | DATA  | R/W  | FFFFh | Scratch Data<br>Data written is read back as the inverted value.<br>For example, writing 0xAAAA is read back as 0x5555. |

### 7.1.20 CHIP\_ID\_LSB Register (Offset = 19h)

Return to the [Register Map](#).

**Table 7-22. CHIP ID LSB Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                        |
|------|-------|------|-------|------------------------------------|
| 15-0 | ID    | R    |       | Unique part number within each lot |

### 7.1.21 CHIP\_ID\_MSB Register (Offset = 1Ah)

Return to the [Register Map](#).

**Table 7-23. CHIP ID MSB Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                       |
|------|-------|------|-------|-----------------------------------|
| 15-0 | ID    | R    |       | Encoded lot identification number |

### 7.1.22 GPIO\_CFG Register (Offset = 1Bh) [Reset = 00FFh]

Return to the [Register Map](#).

**Table 7-24. GPIO CONFIG Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                   |
|------|----------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15   | RESERVED | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                               |
| 14-8 | EN       | R/W  | 00h   | GPIO per Pin Enable. (See <a href="#">Table 6-8</a> for additional configuration required specific to each pin and communication mode)<br>[14] = GPIO6<br>[13] = GPIO5<br>[12] = GPIO4<br>[11] = GPIO3<br>[10] = GPIO2<br>[9] = GPIO1<br>[8] = GPIO0<br>0h = GPIO function disable<br>1h = GPIO function enabled<br>For any pin used either for the communication function or not used as an active GPIO, set this bit to 0h. |
| 7    | RESERVED | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                               |
| 6-0  | ODE      | R/W  | FFh   | Pseudo Open Drain Enable<br>GPIO output enable and pseudo open drain functionality on the GPIO pins. (See <a href="#">Table 6-8</a> for additional configuration required specific to each pin and communication mode.)<br>[6] = GPIO6<br>[5] = GPIO5<br>[4] = GPIO4<br>[3] = GPIO3<br>[2] = GPIO2<br>[1] = GPIO1<br>[0] = GPIO0<br>0h = Push-pull output enabled<br>1h = Pseudo open-drain output enabled                    |

### 7.1.23 GPIO Register (Offset = 1Ch) [Reset = 007Fh]

Return to the [Register Map](#).

**Table 7-25. GPIO Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
|------|----------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-7 | RESERVED | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
| 6-0  | DATA     | R/W  | 7Fh   | <p>GPIO pin data.</p> <p>For GPIO input this bit must be written as 1 and GPIO_CFG.ODE = 1 and GPIO_CFG.EN = 1. Reading this register reads the pin value when the pin is correctly enabled. (See <a href="#">Table 6-8</a> for additional configuration required specific to each pin and communication mode)</p> <p>For GPIO output this bit sets the pin value.</p> <p>[6] = GPIO6<br/> [5] = GPIO5<br/> [4] = GPIO4<br/> [3] = GPIO3<br/> [2] = GPIO2<br/> [1] = GPIO1<br/> [0] = GPIO0</p> |

## 7.1.24 ALARM\_STATUS\_MASK Register (Offset = 1Dh) [Reset = EFDh]

Return to the [Register Map](#).

**Table 7-26. ALARM\_STATUS\_MASK Register Field Descriptions**

| Bit   | Field          | Type | Reset | Description                                                                                                                                                    |
|-------|----------------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-14 | RESERVED       | R    | 3h    |                                                                                                                                                                |
| 13    | SD_FLT         | R/W  | 1h    | SD Fault Mask<br>0h = Fault asserts IRQ<br>1h = The mask prevents IRQ or Alarm being triggered (default).<br>The status is always set if the condition exists. |
| 12    | OSC_FAIL       | R/W  | 0h    | OSC_FAIL Fault Mask<br>Same as SD Fault Mask (default 0h).                                                                                                     |
| 11-9  | RESERVED       | R    | 7h    |                                                                                                                                                                |
| 8     | OTP_CRC_ERR    | R/W  | 1h    | OTP CRC Error Mask<br>Same as SD Fault Mask (default 1h).                                                                                                      |
| 7     | CRC_FLT        | R/W  | 1h    | SPI CRC Fault Mask<br>Same as SD Fault Mask (default 1h).                                                                                                      |
| 6     | WD_FLT         | R/W  | 1h    | Watchdog Fault Mask<br>Same as SD Fault Mask (default 1h).                                                                                                     |
| 5     | VREF_FLT       | R/W  | 0h    | VREF Fault Mask<br>Same as SD Fault Mask (default 0h).                                                                                                         |
| 4     | ADC_AIN1_FLT   | R/W  | 1h    | ADC AIN1 Fault Mask<br>Same as SD Fault Mask (default 1h).                                                                                                     |
| 3     | ADC_AIN0_FLT   | R/W  | 1h    | ADC AIN0 Fault Mask<br>Same as SD Fault Mask (default 1h).                                                                                                     |
| 2     | ADC_TEMP_FLT   | R/W  | 1h    | ADC TEMP Fault Mask<br>Same as SD Fault Mask (default 1h).                                                                                                     |
| 1     | THERM_ERR_FLT  | R/W  | 1h    | Temperature > 130°C Error Mask<br>Same as SD Fault Mask (default 1h).                                                                                          |
| 0     | THERM_WARN_FLT | R/W  | 1h    | Temperature > 85°C Warning Mask<br>Same as SD Fault Mask (default 1h).                                                                                         |

### 7.1.25 GEN\_STATUS\_MASK Register (Offset = 1Eh) [Reset = FFFFh]

Return to the [Register Map](#).

**Table 7-27. GEN\_STATUS\_MASK Register Field Descriptions**

| Bit   | Field            | Type | Reset | Description                                                                                                                                                      |
|-------|------------------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-11 | RESERVED         | R    | 1Fh   |                                                                                                                                                                  |
| 10    | RBIST_DONE       | R/W  | 1h    | RBIST Done Mask<br>0h = Fault asserts IRQ<br>1h = The mask prevents IRQ or Alarm being triggered (default).<br>The status is always set if the condition exists. |
| 9     | RBIST_FAIL       | R/W  | 1h    | RBIST Failed Fault Mask<br>Same as RBIST Done Mask (default 1h).                                                                                                 |
| 8     | RESERVED         | R    | 1h    |                                                                                                                                                                  |
| 7     | SR_BUSYn         | R/W  | 1h    | Slew Rate Not Busy Mask<br>Same as RBIST Done Mask (default 1h).                                                                                                 |
| 6     | ADC_EOC          | R/W  | 1h    | ADC End Of Conversion Mask<br>Same as RBIST Done Mask (default 1h).                                                                                              |
| 5-4   | RESERVED         | R    | 3h    |                                                                                                                                                                  |
| 3     | BREAK_FRAME_ERR  | R/W  | 1h    | Break Frame Error Fault Mask<br>Same as RBIST Done Mask (default 1h).                                                                                            |
| 2     | BREAK_PARITY_ERR | R/W  | 1h    | Break Parity Error Fault Mask<br>Same as RBIST Done Mask (default 1h).                                                                                           |
| 1     | UART_FRAME_ERR   | R/W  | 1h    | UART Frame Error Fault Mask<br>Same as RBIST Done Mask (default 1h).                                                                                             |
| 0     | UART_PARITY_ERR  | R/W  | 1h    | UART Parity Error Fault Mask<br>Same as RBIST Done Mask (default 1h).                                                                                            |

## 7.1.26 ALARM\_STATUS Register (Offset = 20h) [Reset = 0200h]

Return to the [Register Map](#).

**Table 7-28. ALARM\_STATUS Register Field Descriptions**

| Bit   | Field          | Type | Reset | Description                                                                                                                                                                                                                                       |
|-------|----------------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15    | GEN_IRQ        | R    | 0h    | General IRQ OR of all the unmasked bits in the GEN_STATUS register.<br>0h = All of the unmasked bits of the GEN_STATUS register are low<br>1h = At least one of the unmasked bits in the GEN_STATUS register is high                              |
| 14    | RESERVED       | R    | 0h    |                                                                                                                                                                                                                                                   |
| 13    | SD_FLT         | R    | 0h    | Self Diagnostic (SD) Fault<br>0h = All self diagnostic channels are within threshold limits<br>1h = At least one of the self diagnostic channels has failed                                                                                       |
| 12    | OSC_FAIL       | R    | 0h    | Oscillator Fault Oscillator failed to start. This bit holds $\overline{\text{ALARM}}$ low and does not feed IRQ.<br>0h = Oscillator started; 1h = Oscillator has failed to start                                                                  |
| 11-10 | CRC_CNT        | R    | 0h    | CRC Fault Counter<br>If counter limit $\leq 4$ then bits[1:0] of the counter are shown here.<br>If the counter limit = 8 then bits[2:1] of the counter are shown.                                                                                 |
| 9     | OTP_LOADEDn    | R    | 1h    | OTP NOT Loaded Clears when OTP has loaded at least once.<br>Keeps $\overline{\text{ALARM}}$ asserted until OTP finishes loading. Does not feed IRQ.<br>0h = OTP has loaded at least once; 1h = OTP has not finished loading                       |
| 8     | OTP_CRC_ERR    | R    | 0h    | OTP CRC Error Maskable fault. An error occurred with the OTP CRC calculation.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No OTP CRC fault; 1h = OTP CRC fault                                                |
| 7     | CRC_FLT        | R    | 0h    | CRC Fault Maskable fault. Invalid CRC value transmitted during SPI frame.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No CRC fault; 1h = CRC fault                                                            |
| 6     | WD_FLT         | R    | 0h    | Watchdog Timer Fault<br>Maskable fault. Sticky, cleared by reading register, unless condition still persist.<br>0h = No watchdog fault; 1h = Watchdog fault                                                                                       |
| 5     | VREF_FLT       | R    | 0h    | Invalid Reference Voltage Maskable fault. OR with FORCE_FAIL.VREF_FLT bit.<br>Active signal, set as long as condition is true. Direct input from analog circuit.<br>0h = Valid VREF voltage; 1h = Invalid VREF voltage                            |
| 4     | ADC_AIN1_FLT   | R    | 0h    | ADC AIN1 Fault. Maskable fault.<br>0h = AIN1 ADC measurement within threshold limits<br>1h = AIN1 ADC measurement outside threshold limits                                                                                                        |
| 3     | ADC_AIN0_FLT   | R    | 0h    | ADC AIN0 Fault. Maskable fault.<br>0h = AIN0 ADC measurement within threshold limits<br>1h = AIN0 ADC measurement outside threshold limits                                                                                                        |
| 2     | ADC_TEMP_FLT   | R    | 0h    | ADC Temp Fault. Maskable fault.<br>0h = TEMP ADC measurement within threshold limits<br>1h = TEMP ADC measurement outside threshold limits                                                                                                        |
| 1     | THERM_ERR_FLT  | R    | 0h    | Temperature > 130°C error. Maskable fault.<br>OR with FORCE_FAIL.THERM_ERR_FLT bit.<br>Active signal, set as long as condition is true. Direct input from analog circuit.<br>0h = Temperature $\leq 130^\circ\text{C}$ ; 1h = Temperature > 130°C |
| 0     | THERM_WARN_FLT | R    | 0h    | Temperature > 85°C warning. Maskable fault.<br>OR with FORCE_FAIL.THERM_WARN_FLT bit.<br>Active signal, set as long as condition is true. Direct input from analog circuit.<br>0h = Temperature $\leq 85^\circ\text{C}$ ; 1h = Temperature > 85°C |

### 7.1.27 GEN\_STATUS Register (Offset = 21h) [Reset = 1180h]

Return to the [Register Map](#).

**Table 7-29. GEN\_STATUS Register Field Descriptions**

| Bit   | Field            | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
|-------|------------------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15    | ALARM_IRQ        | R    | 0h    | Alarm IRQ OR of all the unmasked bits in the ALARM_STATUS register.<br>0h = All of the unmasked bits of the ALARM_STATUS register are low<br>1h = At least one of the unmasked bits in the ALARM_STATUS register is high                                                                                                                                                                                                                                                                                                  |
| 14-13 | RESERVED         | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
| 12    | OTP_BUSY         | R    | 1h    | OTP Busy Status = 1h at power up while the OTP is being loaded into the trim latches.<br>0h = OTP has completed loading into the device<br>1h = OTP is being loaded into the device                                                                                                                                                                                                                                                                                                                                       |
| 11    | RBIST_MODE       | R    | 0h    | Enables RBIST to run.<br>0h = RBIST disabled; 1h = RBIST enabled                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| 10    | RBIST_DONE       | R    | 0h    | RBIST Completed. Maskable fault.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = RBIST has not completed; 1h = RBIST has completed                                                                                                                                                                                                                                                                                                                                                        |
| 9     | RBIST_FAIL       | R    | 0h    | RBIST Failed. Maskable fault.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = RBIST has passed; 1h = RBIST has failed                                                                                                                                                                                                                                                                                                                                                                     |
| 8     | RESET            | R    | 1h    | Device Reset Occurred. Status only. Does not feed IRQ.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = Device has not reset since last read of register<br>1h = Device has reset since last read of register                                                                                                                                                                                                                                                                              |
| 7     | SR_BUSYn         | R    | 1h    | Slew Rate Not Busy. Maskable fault.<br>0h = DAC is slewing to the target code<br>1h = DAC_OUT has reached the DAC_DATA.<br>If slew rate is disabled, then this signal produces a rising edge within 3 internal clock cycles. If slew rate is enabled, this signal creates an IRQ event when the DAC_OUT has reached the DAC_DATA. At this time, slew rate can be safely disabled. If slew rate is disabled prior to DAC_OUT = DAC_DATA then a jump of DAC_OUT occurs. This can cause an unwanted fast transition on VOUT. |
| 6     | ADC_EOC          | R    | 0h    | ADC End of Conversion (EOC). Maskable fault.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No EOC since last read of register; 1h = ADC end of conversion                                                                                                                                                                                                                                                                                                                               |
| 5     | ADC_BUSY         | R    | 0h    | ADC Busy. Status only. Does not feed IRQ. Active signal, set as long as condition is true.<br>0h = No ADC activity; 1h = ADC is actively converting                                                                                                                                                                                                                                                                                                                                                                       |
| 4     | PVDD_HI          | R    | 0h    | PVDD High. Status only. Does not feed IRQ. Set as long as condition is true.<br>0h = PVDD < 2.7 V; 1h = PVDD ≥ 2.7 V                                                                                                                                                                                                                                                                                                                                                                                                      |
| 3     | BREAK_FRAME_ERR  | R    | 0h    | Incorrect Stop Bit During Break Character. Maskable fault. Applies to UARTIN.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No break frame error; 1h = Break frame error                                                                                                                                                                                                                                                                                                                |
| 2     | BREAK_PARITY_ERR | R    | 0h    | Incorrect parity (ODD) bit during break character. Maskable fault. Applies to UARTIN.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No break parity error; 1h = Break parity error                                                                                                                                                                                                                                                                                                      |
| 1     | UART_FRAME_ERR   | R    | 0h    | Incorrect Stop Bit During UART Character. Maskable fault. Applies to UARTIN.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No UART frame error; 1h = UART frame error                                                                                                                                                                                                                                                                                                                   |
| 0     | UART_PARITY_ERR  | R    | 0h    | Incorrect Parity (ODD) Bit During UART Character. Maskable fault. Applies to UARTIN.<br>Sticky, cleared by reading register, unless condition still persist.<br>0h = No UART parity error; 1h = UART parity error                                                                                                                                                                                                                                                                                                         |

### 7.1.28 ADC\_FLAGS Register (Offset = 23h) [Reset = 0000h]

Return to the [Register Map](#).

The limits for Self Diagnostic (SD) Alarm ADC Thresholds are shown in [Table 6-5](#).

**Table 7-30. ADC\_FLAGS Register Field Descriptions**

| Bit  | Field     | Type | Reset | Description           |
|------|-----------|------|-------|-----------------------|
| 15-9 | RESERVED  | R    | 0h    |                       |
| 8    | SD4_FAIL  | R    | 0h    | SD4 (VOUT) Limit Fail |
| 7    | SD3_FAIL  | R    | 0h    | SD3 (ZTAT) Limit Fail |
| 6    | SD2_FAIL  | R    | 0h    | SD2 (VDD) Limit Fail  |
| 5    | SD1_FAIL  | R    | 0h    | SD1 (PVDD) Limit Fail |
| 4    | SD0_FAIL  | R    | 0h    | SD0 (VREF) Limit Fail |
| 3    | TEMP_FAIL | R    | 0h    | TEMP Limit Fail       |
| 2    | AIN1_FAIL | R    | 0h    | AIN1 Limit Fail       |
| 1    | AIN0_FAIL | R    | 0h    | AIN0 Limit Fail       |
| 0    | RESERVED  | R    | 0h    |                       |

### 7.1.29 ADC\_AIN0 Register (Offset = 24h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-31. ADC\_AIN0 Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                            |
|-------|----------|------|-------|----------------------------------------|
| 15-12 | RESERVED | R    | 0h    |                                        |
| 11-0  | DATA     | R    | 0h    | Converted Value of Voltage on Pin AIN0 |

### 7.1.30 ADC\_AIN1 Register (Offset = 25h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-32. ADC\_AIN1 Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                            |
|-------|----------|------|-------|----------------------------------------|
| 15-12 | RESERVED | R    | 0h    |                                        |
| 11-0  | DATA     | R    | 0h    | Converted Value of Voltage on Pin AIN1 |

### 7.1.31 ADC\_TEMP Register (Offset = 26h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-33. ADC\_TEMP Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                    |
|-------|----------|------|-------|--------------------------------|
| 15-12 | RESERVED | R    | 0h    |                                |
| 11-0  | DATA     | R    | 0h    | Converted Value of Temperature |

### 7.1.32 ADC\_SD\_MUX Register (Offset = 27h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-34. ADC\_SD\_MUX Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                                                  |
|-------|----------|------|-------|--------------------------------------------------------------|
| 15-12 | RESERVED | R    | 0h    |                                                              |
| 11-0  | DATA     | R    | 0h    | Converted Value of Voltage on Self-Diagnostic (SD) MUX Input |

### 7.1.33 ADC\_OFFSET Register (Offset = 28h) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-35. ADC\_OFFSET Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                                                                                                                                                                                                                                                 |
|-------|----------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-12 | RESERVED | R    | 0h    |                                                                                                                                                                                                                                                             |
| 11-0  | DATA     | R    | 0h    | ADC Comparator Offset<br>This value reports the offset measured in the device, and can be used to adjust each conversion value. If ADC_BYP.OFST_BYP_EN is set, then the value in ADC_BYP.DATA is used as the offset. This value is not affected by ADC_BYP. |

### 7.1.34 DAC\_OUT Register (Offset = 2Ch) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-36. DAC\_OUT Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                            |
|------|-------|------|-------|----------------------------------------|
| 15-0 | DATA  | R    | 0h    | DAC Code Applied to the Analog Circuit |

### 7.1.35 ADC\_OUT Register (Offset = 2Dh) [Reset = 0000h]

Return to the [Register Map](#).

**Table 7-37. ADC\_OUT Register Field Descriptions**

| Bit   | Field    | Type | Reset | Description                                                                                                   |
|-------|----------|------|-------|---------------------------------------------------------------------------------------------------------------|
| 15-12 | RESERVED | R    | 0h    |                                                                                                               |
| 11-0  | DATA     | R    | 0h    | ADC Data for Each Conversion<br>Does not include ADC_OFFSET.DATA adjustment. Is not affected by ADC_BYP.DATA. |

### 7.1.36 ADC\_BYP Register (Offset = 2Eh) [Reset = 0000h]

Return to the [Register Map](#).

ADC\_BYP is shown in [ADC\\_BYP Register Field Descriptions](#).

**Table 7-38. ADC\_BYP Register Field Descriptions**

| Bit  | Field        | Type | Reset | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|------|--------------|------|-------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15   | DATA_BYP_EN  | R/W  | 0h    | Data Bypass Enable<br>Applies ADC_BYP.DATA to the ADC channel being converted. ADC_OFFSET is ignored. Do not set OFST_BYP_EN and DATA_BYP_EN at the same time. If OFST_BYP_EN is also set, DATA_BYP_EN takes priority over OFST_BYP_EN. After a channel is converted, the ADC_BYP.DATA value appears in the readback register for the converted channel and is used to calculate faults.<br>0h = Data bypass disabled (default)<br>1h = Data bypass enabled |
| 14   | OFST_BYP_EN  | R/W  | 0h    | Offset Bypass Enable<br>Overrides the offset register with the ADC_BYP.DATA value. When using this bit, the ADC_BYP.DATA field is processed as 2's complement. Do not set OFST_BYP_EN and DATA_BYP_EN at the same time.<br>0h = Offset bypass disabled (default)<br>1h = Offset bypass enabled                                                                                                                                                              |
| 13   | DIS_GND_SAMP | R/W  | 0h    | Disable GND Sampling<br>This bit disables the sampling of GND during SAR activity. The sampling of GND is used to fully discharge the sampling CAP to reduce channel crosstalk.<br>0h = GND sampling enabled (default)<br>1h = GND sampling disabled                                                                                                                                                                                                        |
| 12   | RESERVED     | R    | 0h    |                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
| 11-0 | DATA         | R/W  | 0h    | Bypass Data                                                                                                                                                                                                                                                                                                                                                                                                                                                 |

### 7.1.37 FORCE\_FAIL Register (Offset = 2Fh) [Reset = 0000h]

Return to the [Register Map](#).

Force failures for fault detection.

**Table 7-39. FORCE\_FAIL Register Field Descriptions**

| Bit   | Field          | Type | Reset | Description                                                                                                                                             |
|-------|----------------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15    | CRC_FLT        | R/W  | 0h    | Force CRC Failure on SDO by Inverting the CRC Byte<br>0h = No force failure of CRC (default)<br>1h = Force failure of CRC                               |
| 14    | VREF_FLT       | R/W  | 0h    | Force Reference Voltage Failure. Analog signal.<br>0h = No force failure of VREF (default)<br>1h = Force failure of VREF                                |
| 13    | THERM_ERR_FLT  | R/W  | 0h    | Force Temperature > 130°C Thermal Error. Analog signal.<br>0h = No force temperature > 130°C error (default)<br>1h = Force temperature > 130°C error    |
| 12    | THERM_WARN_FLT | R/W  | 0h    | Force Temperature > 85°C thermal Warning. Analog signal.<br>0h = No force temperature > 85°C warning (default)<br>1h = Force temperature > 85°C warning |
| 11-10 | RESERVED       | R/W  | 0h    |                                                                                                                                                         |
| 9     | SD4_HI_FLT     | R/W  | 0h    | SD4 (VOUT) High Limit Failure. ADC measurement.<br>0h = No force failure of SD4 (VOUT) (default)<br>1h = Force failure of SD4 (VOUT)                    |
| 8     | SD4_LO_FLT     | R/W  | 0h    | SD4 (VOUT) Low limit failure. ADC measurement.<br>0h = No force failure of SD4 (VOUT) (default)<br>1h = Force failure of SD4 (VOUT)                     |
| 7     | SD3_HI_FLT     | R/W  | 0h    | SD3 (ZTAT) High Limit Failure. ADC measurement.<br>0h = No force failure of SD3 (ZTAT) (default)<br>1h = Force failure of SD3 (ZTAT)                    |
| 6     | SD3_LO_FLT     | R/W  | 0h    | SD3 (ZTAT) Low Limit Failure. ADC measurement.<br>0h = No force failure of SD3 (ZTAT) (default)<br>1h = Force failure of SD3 (ZTAT)                     |
| 5     | SD2_HI_FLT     | R/W  | 0h    | SD2 (VDD) High Limit Failure. ADC measurement.<br>0h = No force failure of SD2 (VDD) (default)<br>1h = Force failure of SD2 (VDD)                       |
| 4     | SD2_LO_FLT     | R/W  | 0h    | SD2 (VDD) Low Limit Failure. ADC measurement.<br>0h = No force failure of SD2 (VDD) (default)<br>1h = Force failure of SD2 (VDD)                        |
| 3     | SD1_HI_FLT     | R/W  | 0h    | SD1 (PVDD) High Limit Failure. ADC measurement.<br>0h = No force failure of SD1 (PVDD) (default)<br>1h = Force failure of SD1 (PVDD)                    |
| 2     | SD1_LO_FLT     | R/W  | 0h    | SD1 (PVDD) Low Limit Failure. ADC measurement.<br>0h = No force failure of SD1 (PVDD) (default)<br>1h = Force failure of SD1 (PVDD)                     |
| 1     | SD0_HI_FLT     | R/W  | 0h    | SD0 (VREF) High Limit Failure. ADC measurement.<br>0h = No force failure of SD0 (VREF) (default)<br>1h = Force failure of SD0 (VREF)                    |
| 0     | SD0_LO_FLT     | R/W  | 0h    | SD0 (VREF) Low Limit Failure. ADC measurement.<br>0h = No force failure of SD0 (VREF) (default)<br>1h = Force failure of SD0 (VREF)                     |

### 7.1.38 TIMER\_CFG\_0 Register (Offset = 3Bh) [Reset = 0000h]

Return to the [Register Map](#).

TIMER Configuration 0.

**Table 7-40. TIMER CONFIG 0 Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                     |
|------|----------|------|-------|---------------------------------------------------------------------------------------------------------------------------------|
| 15-4 | RESERVED | TO   | 0h    |                                                                                                                                 |
| 3-2  | CLK_SEL  | R/W  | 0h    | Clock Select<br>Selects the timer clock frequency.<br>0h = None (default)<br>1h = 1.2288 MHz<br>2h = 1.200 kHz<br>3h = 1.171 Hz |
| 1    | INVERT   | R/W  | 0h    | Invert Output<br>Invert the Timer output. By default, the output is set to 1 when the counter is $\geq$ SET_TIME (3Dh).         |
| 0    | ENABLE   | R/W  | 0h    | Timer Enable<br>The CLK_OUT pin must also be configured to output the Timer.                                                    |

### 7.1.39 TIMER\_CFG\_1 Register (Offset = 3Ch) [Reset = 0000h]

Return to the [Register Map](#).

TIMER Configuration 1.

**Table 7-41. TIMER CONFIG 1 Register Field Descriptions**

| Bit  | Field  | Type | Reset | Description                                                                                                                                                                                             |
|------|--------|------|-------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-0 | PERIOD | R/W  | 0h    | This field defines the period of the timer. The period is the product of (PERIOD + 1) and the clock period of CLK_SEL. For example, CLK_SEL = 2h (1200 Hz), The period is (PERIOD + 1) $\times$ 853 ms. |

### 7.1.40 TIMER\_CFG\_2 Register (Offset = 3Dh) [Reset = 0000h]

Return to the [Register Map](#).

TIMER Configuration 2.

**Table 7-42. TIMER CONFIG 2 Register Field Descriptions**

| Bit  | Field    | Type | Reset | Description                                                                                                                                                                                                                                                                          |
|------|----------|------|-------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 15-0 | SET_TIME | R/W  | 0h    | The SET_TIME determine when the output of the timer goes high. The bits define the duty cycle of the timer (PERIOD – SET_TIME). The timer starts out as 0 and transitions to 1 when the SET_TIME is met. The polarity of the timer can be inverted using the TIMER_CFG_0.INVERT bit. |

### 7.1.41 CRC\_RD Register (Offset = 3Eh) [Reset = 0000h]

Return to the [Register Map](#).

CRC read.

**Table 7-43. CRC Read Register Field Descriptions**

| Bit  | Field | Type | Reset | Description                                                                                                                              |
|------|-------|------|-------|------------------------------------------------------------------------------------------------------------------------------------------|
| 15-0 | CRC   | R/O  | 0h    | Calculated CRC for RBIST or SHADOWLOAD. Final value is calculated internally. This value changes while RBIST or shadow load are running. |

### 7.1.42 RBIST\_CRC Register (Offset = 3Fh) [Reset = 0000h]

Return to the [Register Map](#).

RBIST CRC.

**Table 7-44. RBIST CRC Register Field Descriptions**

| Bit  | Field     | Type | Reset | Description                       |
|------|-----------|------|-------|-----------------------------------|
| 15-0 | RBIST CRC | R/W  | 0h    | Calculated CRC for Register RBIST |

## 8 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

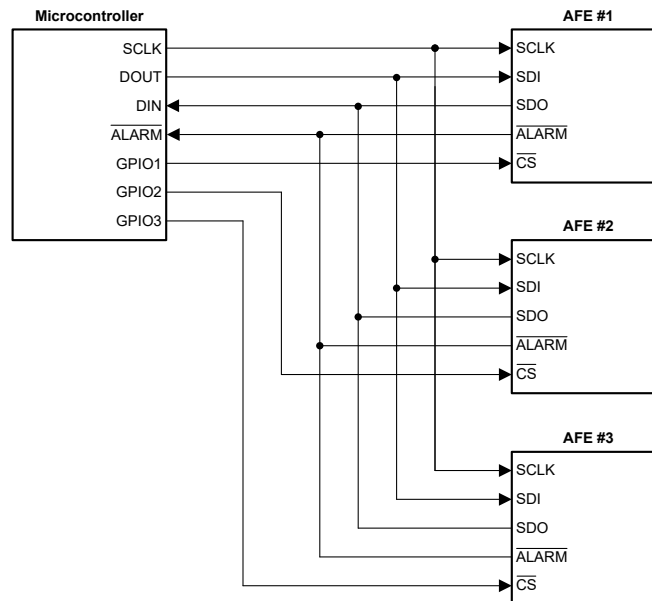
### 8.1 Application Information

The AFEx8201 are extremely low-power 16-bit and 14-bit voltage output DACs. The DACs support an output range of 0 V to 2.5 V. These devices have an onboard oscillator and an optional precision internal reference. This DAC is designed for analog voltage or current output modules. These devices also feature a SAR ADC that is used to measure internal and external nodes for making diagnostic measurements with fault detection and alarm actions. Use these diagnostic measurements together with the CRC and watchdog timer monitoring for device and system monitoring for functional safety.

The PVDD power supply has an operating range of 2.7 V to 5.5 V. The VDD is powered from an onboard LDO. Run the digital interface supply, IOVDD, from 1.71 V to 5.5 V.

#### 8.1.1 Multichannel Configuration

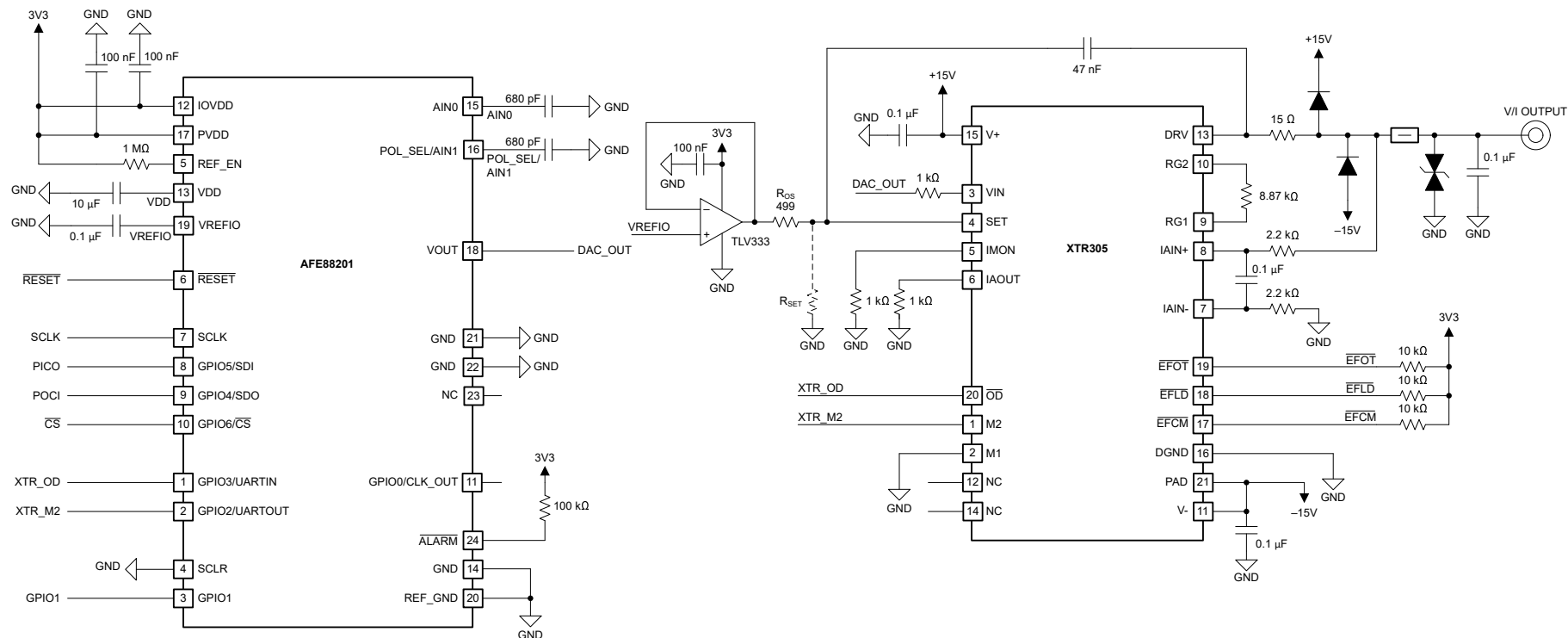
Because  $\overline{CS}$  low is required for communication and SDO can be set to a tri-state condition, only individual  $\overline{CS}$  signals are required from the microcontroller for all the AFEx8201 devices in the system. The SDI, SDO, and SCLK signals can be combined. All the individual  $\overline{ALARM}$  pins can be wired-OR together. This minimizes the number of microcontroller GPIO signals required for communication, as well as the number of isolation channels for isolated systems. The multichannel configuration block diagram is shown in [Figure 8-1](#).



**Figure 8-1. Multichannel Configuration**

## 8.2 Typical Application

### 8.2.1 Analog Output Module



**Figure 8-2. AFE88201 With an XTR305 in an Analog Output Module**

This design example shows the construction of an analog output module capable of current and voltage outputs for a programmable logic controller (PLC). This example combines several circuit elements to create a subsystem that can support most analog output applications. This application requires supplies of 3.3 V and  $\pm 15$  V. The circuit output sets a precision voltage or current with an accuracy of less than 0.1% full scale range (FSR) of total error at room temperature after calibration. The high integration in the system allows for a compact circuit, making this device an excellent choice for analog outputs for ac inverters and servo drives where space is a concern. Error flags and output load monitoring capability enable a robust design. [Figure 8-2](#) shows the schematic diagram for the analog output module.

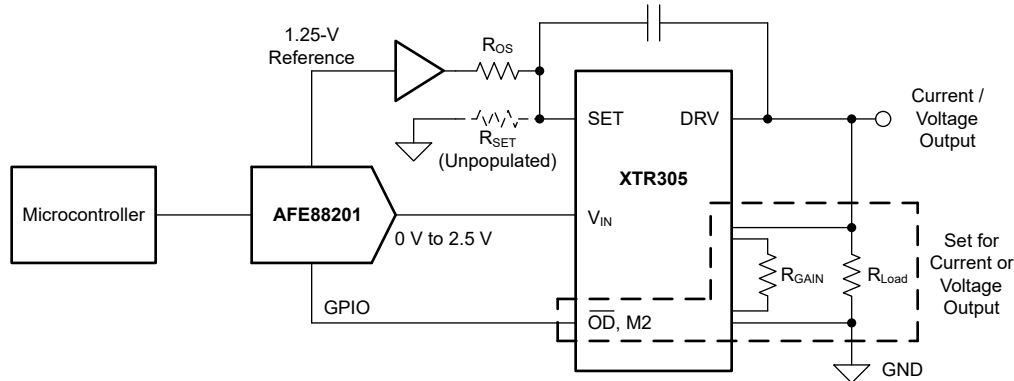
### 8.2.1.1 Design Requirements

The design requirements are:

- Bipolar analog output voltage range:  $\pm 11$  V
- Bipolar analog output current range:  $-25$  mA to  $25$  mA
- Operation with standard industrial automation supply voltages from  $3.3$  V and  $\pm 15$  V
- Current and voltage outputs with TUE less than  $0.5\%$  at  $25^\circ\text{C}$  after calibration

### 8.2.1.2 Detailed Design Procedure

Figure 8-3 shows a block diagram of an analog output module using the AFE8201 and the XTR305.



**Figure 8-3. Block Diagram of the Analog Output Module Using the AFE8201 and XTR305**

The AFE88201 sets an output voltage from  $0$  V to  $2.5$  V using a 16-bit code. Use the AFE78201 in this same application if 14-bit performance is required. This DAC voltage is converted to an output voltage or an output current by the XTR305. The XTR305 provides two basic functional blocks: an instrumentation amplifier (IA) and an operational amplifier (OPA) for an output driver.

This application is a configurable current or voltage analog output. Figure 8-2 shows a schematic of the circuit. The AFE88201 DAC controls the XTR305, which is an industrial analog current or voltage output driver. The XTR305 takes an analog input control signal and drives a proportional analog output. The output is configured as a current output if M2 is high and M1 is low, and a voltage output if M2 and M1 are both low.

The input-to-output gain of the XTR305 is set by  $R_{SET}$  and  $R_{GAIN}$ . The gain components in this design are selected for  $\pm 11$ -V or  $0$ -mA to  $25$ -mA output.

During current-output mode, a precision current mirror generates an exact  $1/10$ th copy of the output current, and this current is routed to the summing junction of the OPA to close the feedback loop. In voltage-output mode, the IA senses the output voltage and feeds back a current equal to  $2 \times V_{OUT} / R_{GAIN}$  to the summing junction of the OPA to close the feedback loop.

A basic design procedure using the XTR305 as an output stage is described in the following list.

- Leave  $R_{SET}$  open for bipolar output
- Select  $R_{OS}$  for current-output transfer function
- Select  $R_{GAIN}$  for the voltage-output transfer function
- Select EMC protection components

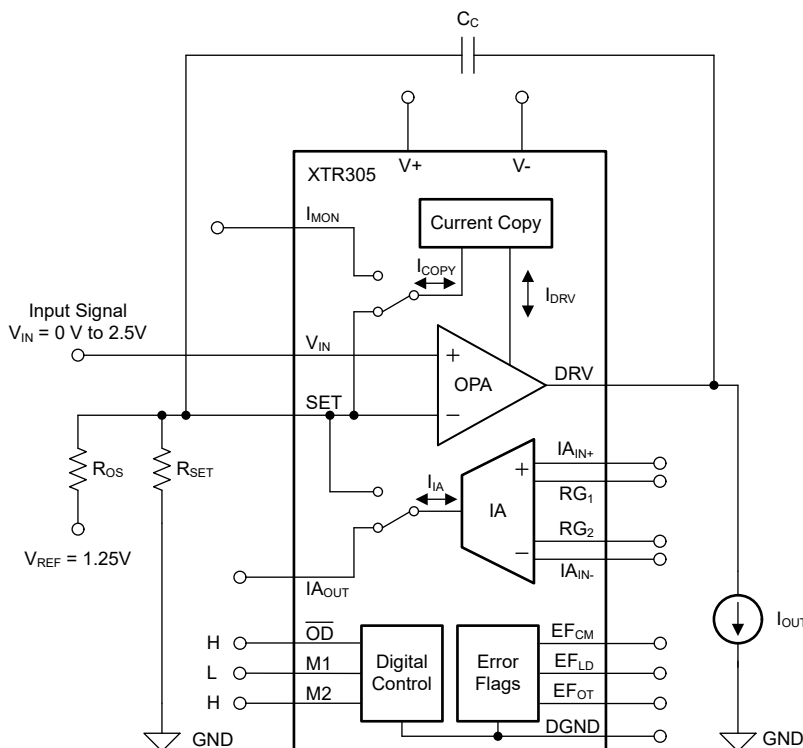
### 8.2.1.2.1 XTR305

The XTR305 is a complete output driver for cost-sensitive industrial and process-control applications. Use the M2 pin to configure the application for current or voltage output. No external shunt resistor is required. Only external gain-setting resistors and a loop-compensation capacitor are required.

The separate driver and receiver channels provide flexibility. The instrumentation amplifier can be used for remote voltage sensing or as a high-voltage, high-impedance measurement channel. In voltage-output mode, a copy of the output current is provided, allowing calculation of load resistance. The digital-output selection capability, error flags, and monitor pins make remote configuration and troubleshooting possible. Fault conditions on the output and on the IA input, as well as overtemperature conditions, are indicated by error flags. The monitoring pins provide continuous feedback about load power or impedance.

#### 8.2.1.2.1.1 Current-Output Mode

In the current-output mode, a 0-V to 2.5-V control input is converted to a  $\pm 25$ -mA current output. As the input is unipolar, and the output is bipolar, a reference bias voltage ( $V_{REF}$ ) is required on the input stage of the XTR305. The bias voltage of 1.25 V is taken from a buffered VREFIO output from the AFE88201. Figure 8-4 shows the configuration of the XTR305 in current-output mode.



**Figure 8-4. The XTR305 Standard Circuit for Current Output**

For current-output mode,  $\overline{OD}$  is set high, M1 is set low, and M2 is set high. The normal transfer function for this circuit is given in Equation 10.

$$I_{OUT} = 10 \times \left( \frac{V_{IN}}{R_{SET}} + \frac{V_{IN} - V_{REF}}{R_{OS}} \right) \quad (10)$$

However, with the  $R_{SET}$  resistor as an open circuit, the singular  $V_{IN}$  term drops out. Using Equation 10, the  $R_{OS}$  term sets the output. The transconductance gain is set by  $R_{OS}$  according to Equation 11.

$$R_{OS} = \frac{10}{I_{outFSR}} \times V_{inFSR} = \frac{10}{50 \text{ mA}} \times 2.5 \text{ V} = 500 \, \Omega \quad (11)$$

Select  $R_{OS} = 499 \, \Omega$  as a standard resistor value. This gives an  $I_{outFSR}$  of 50.1 mA, with an output range of  $\pm 25.05$  mA. The transfer function is given by Equation 12.

$$I_{OUT} = \frac{10}{R_{OS}} \times (V_{in} - V_{REF}) \quad (12)$$

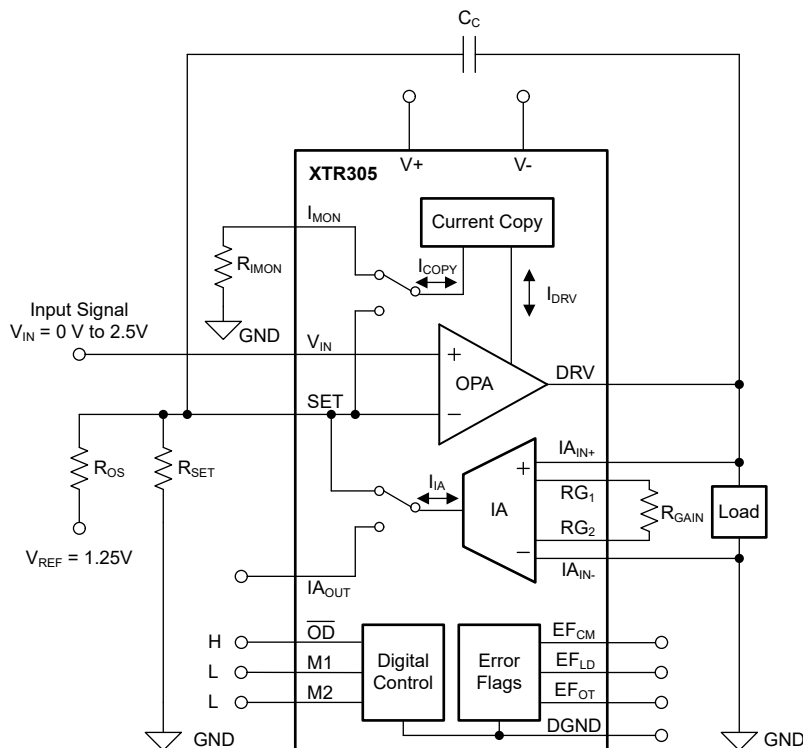
Using the AFE88201, the transfer function from code to output current is shown in Equation 13.

$$I_{OUT} = \frac{10}{R_{OS}} \times \left( \frac{DAC\_CODE \times 2.5\text{ V}}{2^{16}} - 1.25\text{ V} \right) \quad (13)$$

When using the current-output mode, the output load voltage can be monitored through an analog output monitor in the XTR305. See also [Section 8.2.1.2.1.3](#).

#### 8.2.1.2.1.2 Voltage Output Mode

For voltage-output mode, the 0-V to 2.5-V control input is translated to a  $\pm 11$ -V voltage output. Similar to current-output mode, a unipolar input is used to create a bipolar output. Figure 8-5 shows the configuration of the XTR305 in voltage-output mode.



**Figure 8-5. The XTR305 Standard Circuit for Voltage Output**

For voltage-output mode,  $\overline{\text{OD}}$  is set high, while M1 and M2 are set low. The normal transfer function for this circuit is given in [Equation 14](#).

$$V_{OUT} = \frac{R_{GAIN}}{2} \times \left( \frac{V_{IN}}{R_{SET}} + \frac{V_{IN} - V_{REF}}{R_{OS}} \right) \quad (14)$$

Again, with  $R_{SET}$  as an open circuit, the singular  $V_{IN}$  term drops out. The gain is set by  $R_{OS}$  and  $R_{GAIN}$  as per [Equation 15](#).

$$R_{\text{GAIN}} = \frac{2 \times V_{\text{outFSR}} \times R_{\text{OS}}}{V_{\text{inFSR}}} = \frac{2 \times 22 \times 499}{2.5} = 8782 \, \Omega \quad (15)$$

Select  $R_{\text{GAIN}} = 8870 \, \Omega$ , which gives a  $V_{\text{outFSR}}$  of 22.22 V, with an output range of  $\pm 11.11 \, \text{V}$ . The transfer function is given by [Equation 16](#).

$$V_{\text{OUT}} = \frac{R_{\text{GAIN}}}{2} \times \left( \frac{V_{\text{IN}} - V_{\text{REF}}}{R_{\text{OS}}} \right) \quad (16)$$

Using the AFE88201, the transfer function from code to output voltage is shown in [Equation 17](#).

$$V_{\text{OUT}} = \frac{R_{\text{GAIN}}}{2 \times R_{\text{OS}}} \times \left( \frac{\text{DAC\_CODE} \times 2.5 \, \text{V}}{2^{16}} - 1.25 \, \text{V} \right) \quad (17)$$

When using the voltage-output mode, the output load current can be monitored through an analog output monitor in the XTR305. See also [Section 8.2.1.2.1.3](#).

#### 8.2.1.2.1.3 Diagnostic Features

In addition to the diagnostic ADC and alarms of the AFEx8201 described in [Section 6.3.2](#) and [Section 6.3.3.6](#), the XTR305 has several additional diagnostic features.

**IA Common-Mode Overvoltage Range ( $EF_{\text{CM}}$ ):** This flag goes low as soon as the input of the IA reach the limits of the linear operation for the input voltage.

**Overtemperature Flag ( $EF_{\text{OT}}$ ):** This flag goes low if the chip temperature reaches  $140^\circ\text{C}$  and resets as soon as the temperature cools down to less than  $125^\circ\text{C}$ .

**Load Error ( $EF_{\text{LD}}$ ):** Indicates fault conditions driving voltage or current into the load. In voltage-output mode, the device monitors the voltage limits of the output swing and the current limit condition caused from short or low load resistance. In current-output mode, the alarm indicates a saturation into the supply rails from a high-load resistance or open load. The fault flag helps detect whether the analog output wire is broken or shorted. This feature improves the reliability of the analog output function. In case of a short-circuited load, the output current is limited to  $\pm 20 \, \text{mA}$  in voltage-output mode, and  $\pm 32 \, \text{mA}$  in the current-output mode.

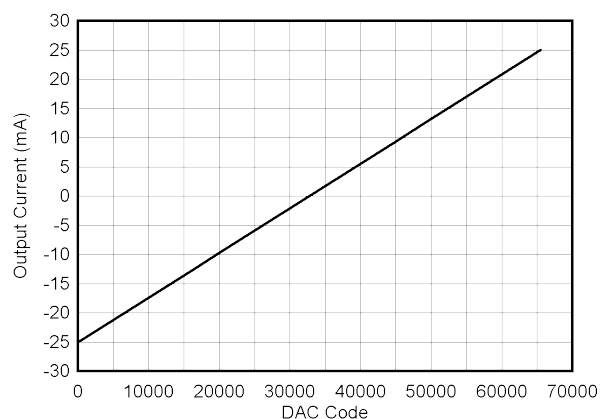
All three fault flags are open collector, and therefore require pullup resistors.

**Analog Output Monitor:** In current-output mode, the IA output is connected to a resistor through the IAOUT pin and the IMON pin is internally disconnected. IAOUT is proportional to the output voltage given by [Equation 18](#). This current is converted into voltage across a  $500\text{-}\Omega$  resistor that can be sensed by the ADC on the AFEx8201. This current measurement enables a monitor of the output power delivered to the load. If the load resistance is known, then the output current can be calculated and compared with the commanded value.

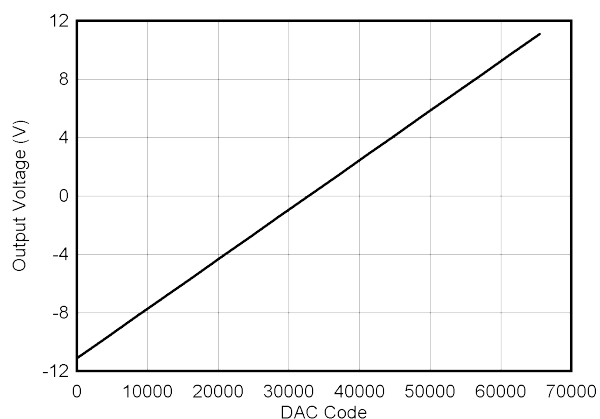
$$I_{\text{AOUT}} = \frac{2 \times V_{\text{OUT}}}{R_{\text{GAIN}}} \quad (18)$$

During voltage-output mode, 1/10th of the output drive current is mirrored onto the IMON pin and IAOUT is internally disconnected. The IMON pin is connected to a  $1\text{-k}\Omega$  resistor. The voltage across this resistor is sensed by the ADC on the AFE88201. If the output load is known, then the output voltage can be calculated and compared with the commanded value. The output power delivered to the load can also be calculated. Output monitor functions help detect load changes enabling predictive maintenance, which increase reliability of the analog output function.

### 8.2.1.3 Application Curves



**Figure 8-6. DAC Code to XTR Output Current**



**Figure 8-7. DAC Code to XTR Output Voltage**

## 8.3 Initialization Setup

This section describes several recommendations to set up the AFEx8201.

The AFEx8201 power up with the CRC enabled. If the device is intended to be run without the CRC, the CRC must be disabled by setting the CRC\_EN bit to 0h in the CONFIG register. Be aware that the command to write to this register is first done with the CRC enabled. The CRC byte must be appended to the command for the device to interpret the command correctly. To disable the CRC after start up, write 0x02 0x00 0x26 0x24 to the device. The first three bytes write the command, while the last byte is the CRC byte. For more information on the CRC, see the communication description in [Section 6.5.3.3](#).

The AFEx8201 also power up with the SDO pin disabled. The SDO pin is required for reading from any of the device registers, as well as reading any data from the ADC in SPI mode. The SDO pin is enabled by writing 0h into the DSDO bit in the CONFIG register. See also [Section 6.5.3.1](#) and [Section 6.5.3.2](#).

To enable the ADC, first enable the ADC buffer by writing 0h into the BUF\_PD bit in the ADC\_CFG register. For information about using the ADC in different modes of operation, see [Section 6.3.2](#).

## 8.4 Power Supply Recommendations

The AFEx8201 can operate within a single-supply range of 2.7 V to 5.5 V applied to the PVDD pin. When 2.7 V to 5.5 V is provided to PVDD, an internal LDO is enabled that drives VDD internally. VDD pin must have 1  $\mu$ F to 10  $\mu$ F of capacitance for operation.

The digital interface supply, IOVDD, can operate with a supply range of 1.71 V to 5.5 V.

Switching power supplies and DC/DC converters often have high-frequency glitches or spikes riding on the output voltage. In addition, digital components can create similar high-frequency spikes. This noise can easily couple into the DAC output voltage or current through various paths between the power connections and analog output. To further reduce noise, include bulk and local decoupling capacitors. The current consumption on the PVDD and IOVDD pins, the short-circuit current limit for the voltage output, and the current ranges for the current output are listed in the [Electrical Characteristics](#). The power supply must meet the requirements listed in the [Recommended Operating Conditions](#).

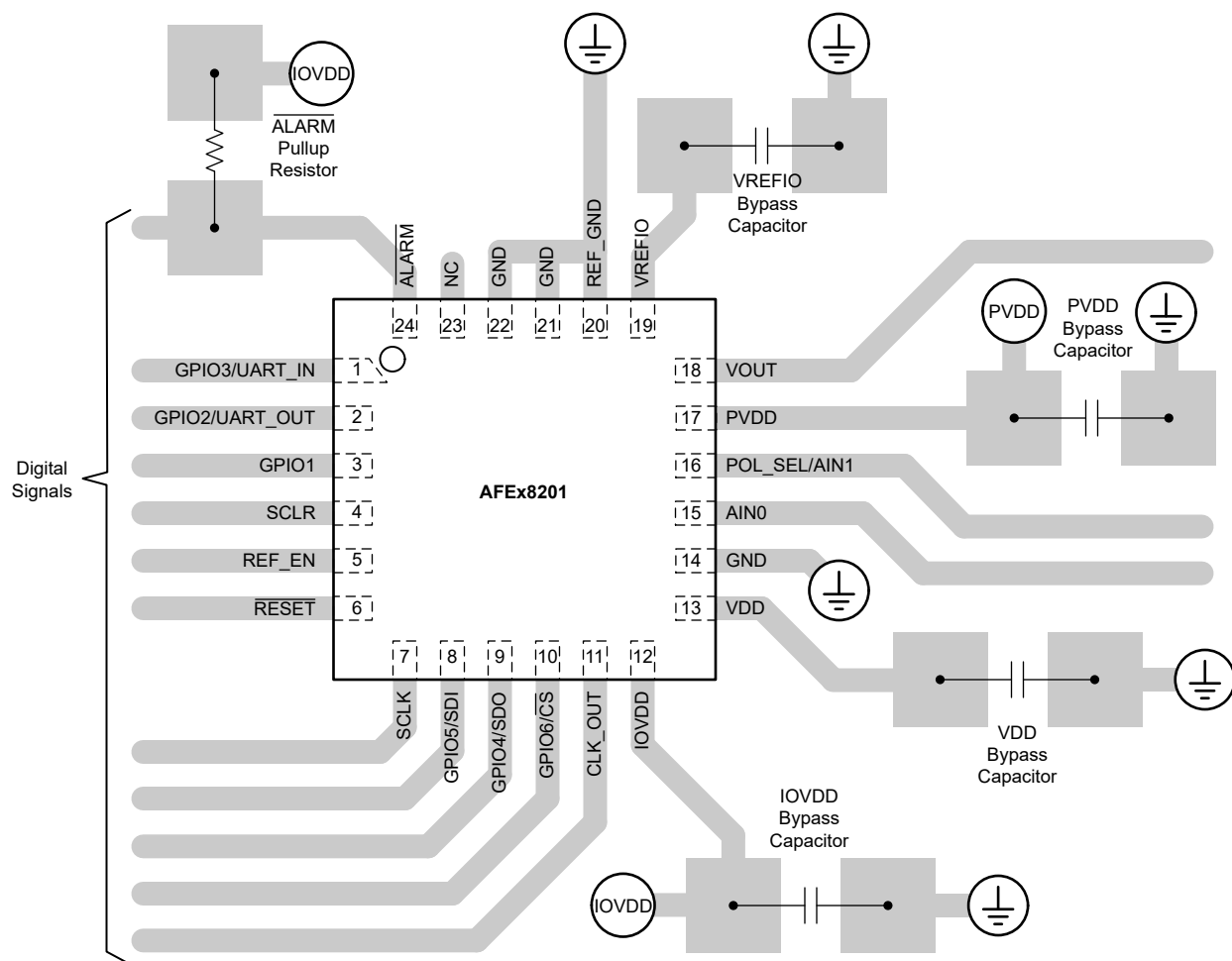
## 8.5 Layout

### 8.5.1 Layout Guidelines

To maximize the performance of the AFEx8201 in any application, follow good layout practices and proper circuit design. The following recommendations are specific to the device:

- For best performance, dedicate an entire PCB layer to a ground plane and do not route any other signal traces on this layer. However, depending on restrictions imposed by specific end equipment, a dedicated ground plane is not always practical. If ground-plane separation is necessary, make a direct connection of the planes at the DAC. Do not connect individual ground planes at multiple locations because this configuration creates ground loops.
- IOVDD and PVDD must have 100-nF decoupling capacitors local to the respective pins. VDD must have at least a 1-μF decoupling capacitor used for the internal LDO. Use a high-quality ceramic-type NP0 or X7R capacitor for best performance across temperature and a very low dissipation factor.
- Place a 100-nF reference capacitor close to the VREFIO pin.
- Avoid routing switching signals near the reference input.
- Maintain proper placement for the digital and analog sections with respect to the digital and analog components. Separate the analog and digital circuitry for less coupling into neighboring blocks and to minimize the interaction between analog and digital return currents.
- For designs that include protection circuits:
  - Place diversion elements, such as TVS diodes or capacitors, close to off-board connectors to make sure that return current from high-energy transients does not cause damage to sensitive devices
  - Use large, wide traces to provide a low-impedance path to divert high-energy transients away from the I/O pins.

## 8.5.2 Layout Example



All pins with GPIO should have an external pullup or pulldown resistor (not shown)

**Figure 8-8. Layout Example**

## 9 Device and Documentation Support

### 9.1 Documentation Support

#### 9.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, [AFE882H1 Evaluation Module User's Guide](#)
- Texas Instruments, [REF35 Ultra Low-Power, High-Precision Voltage Reference data sheet](#)
- Texas Instruments, [XTR305 Industrial Analog Current or Voltage Output Driver data sheet](#)
- Texas Instruments, [ADS1220 4-Channel, 2-kSPS, Low-Power, 24-Bit ADC with Integrated PGA and Reference data sheet](#)
- Texas Instruments, [TPS7A16 60-V, 5- \$\mu\$ A IQ, 100-mA, Low-Dropout Voltage Regulator With Enable and Power-Good data sheet](#)
- Texas Instruments, [TPS7A02 Nanopower IQ, 25-nA, 200-mA, Low-Dropout Voltage Regulator With Fast Transient Response data sheet](#)
- Texas Instruments, [ISO7021 Ultra-Low Power Two-Channel Digital Isolator data sheet](#)
- Texas Instruments, [Isolated, Ultra-Low Power Design for 4- to 20-mA Loop Powered Transmitters design guide](#)
- Texas Instruments, [Isolated Loop Powered Thermocouple Transmitter design guide](#)
- Texas Instruments, [Small Form Factor, 2-Wire, 4- to 20-mA Current-Loop, RTD Temperature Transmitter design guide](#)
- Texas Instruments, [Isolated Power and Data Interface for Low-power Applications reference design](#)
- Texas Instruments, [Uniquely Efficient Isolated DC/DC Converter for Ultra-Low Power and Low-Power Applications design guide](#)

### 9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](#). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 9.3 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

### 9.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 9.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

# 10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision * (May 2023) to Revision A (June 2024)                         | Page               |
|--------------------------------------------------------------------------------------|--------------------|
| • Updated GPIO pin descriptions for clarity.....                                     | <a href="#">3</a>  |
| • Updated reset values in Table 6-7, <i>List of Registers Covered by RBIST</i> ..... | <a href="#">40</a> |

# 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable part number        | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">AFE78201RRUR</a> | Active        | Production           | UQFN (RRU)   24 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>78201        |
| AFE78201RRUR.A               | Active        | Production           | UQFN (RRU)   24 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>78201        |
| AFE78201RRUT                 | Active        | Production           | UQFN (RRU)   24 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>78201        |
| AFE78201RRUT.A               | Active        | Production           | UQFN (RRU)   24 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>78201        |
| <a href="#">AFE88201RRUR</a> | Active        | Production           | UQFN (RRU)   24 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>88201        |
| AFE88201RRUR.A               | Active        | Production           | UQFN (RRU)   24 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>88201        |
| <a href="#">AFE88201RRUT</a> | Active        | Production           | UQFN (RRU)   24 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>88201        |
| AFE88201RRUT.A               | Active        | Production           | UQFN (RRU)   24 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -55 to 125   | AFE<br>88201        |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

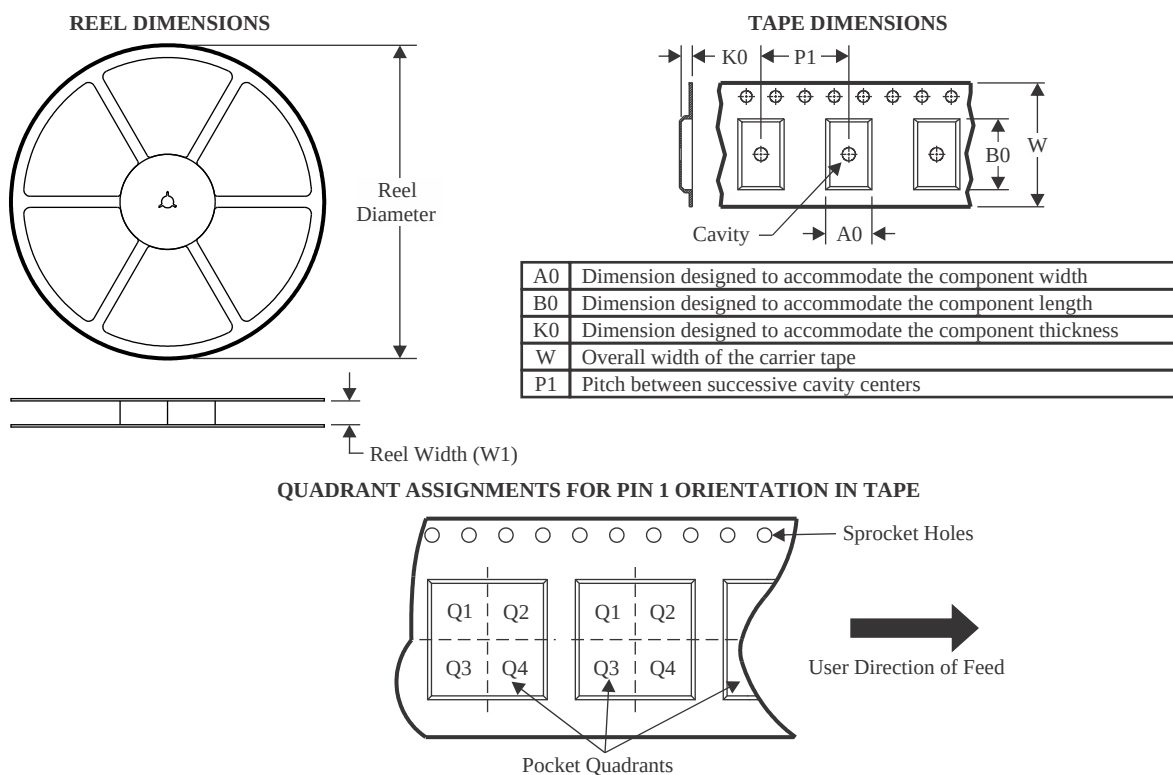
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

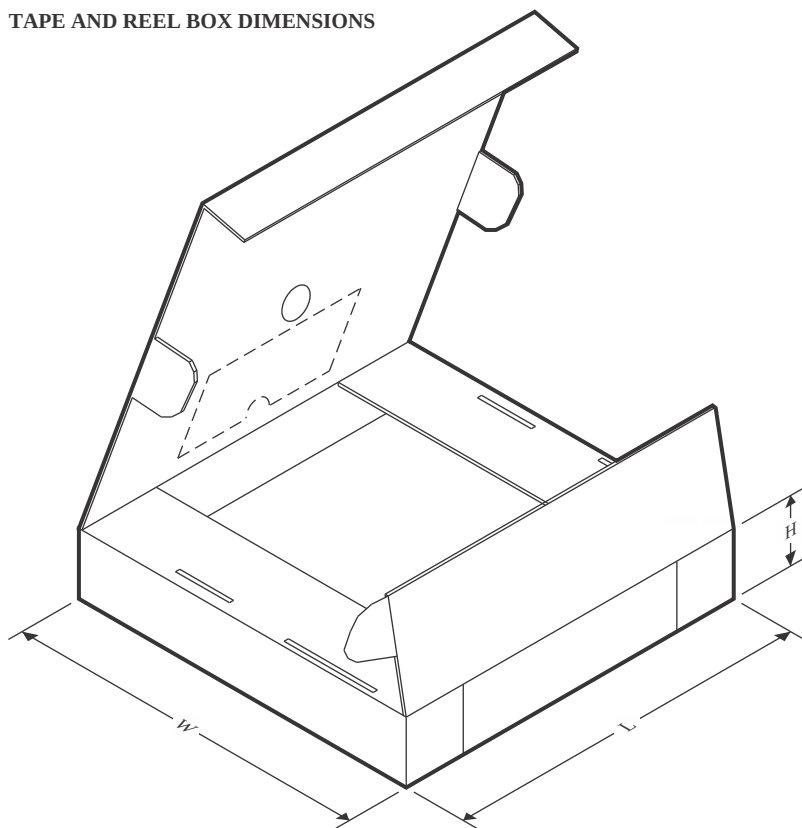
## TAPE AND REEL INFORMATION



\*All dimensions are nominal

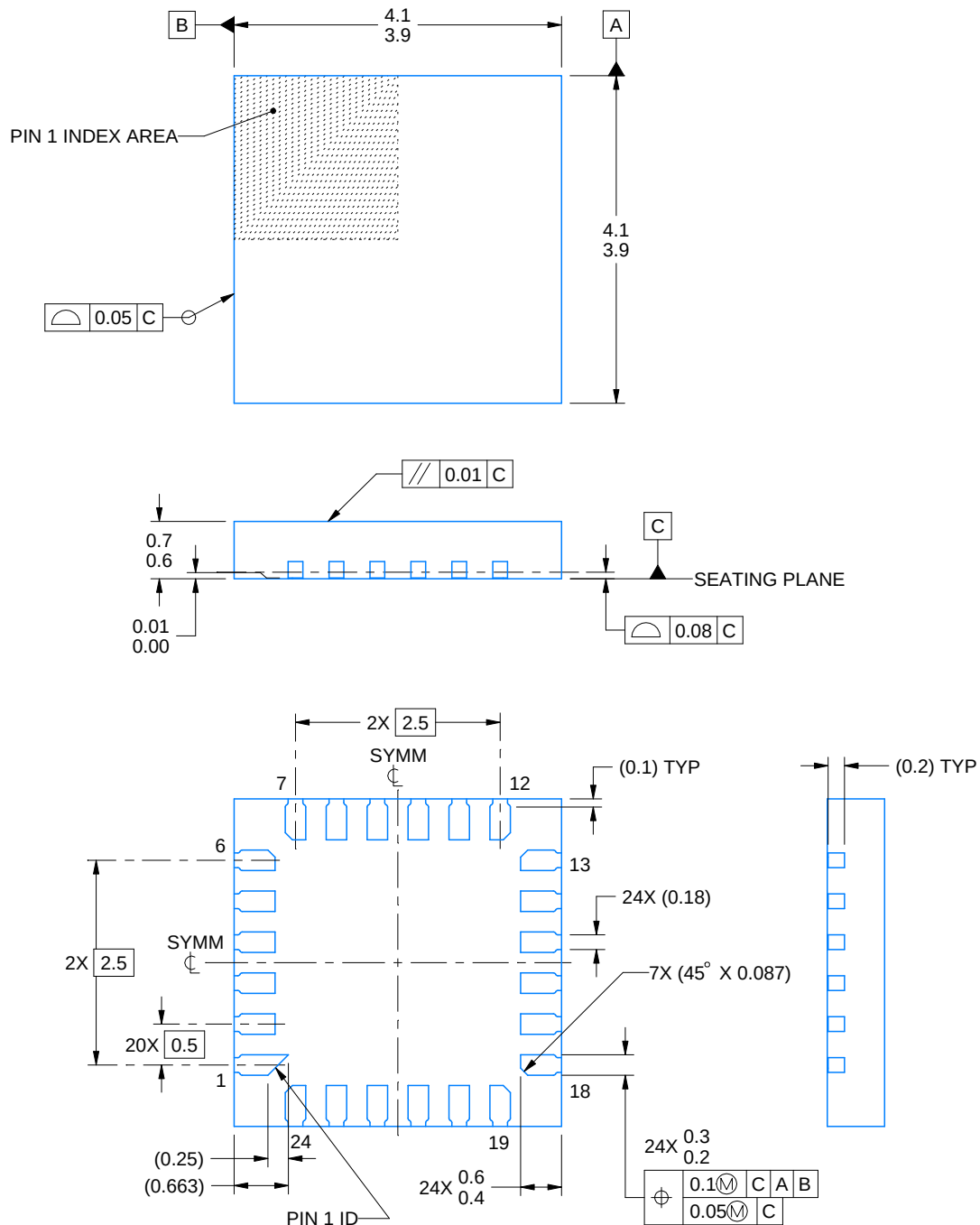
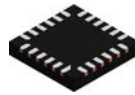
| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| AFE78201RRUR | UQFN         | RRU             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 0.8     | 8.0     | 12.0   | Q2            |
| AFE78201RRUT | UQFN         | RRU             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 0.8     | 8.0     | 12.0   | Q2            |
| AFE88201RRUR | UQFN         | RRU             | 24   | 3000 | 330.0              | 12.4               | 4.25    | 4.25    | 0.8     | 8.0     | 12.0   | Q2            |
| AFE88201RRUT | UQFN         | RRU             | 24   | 250  | 180.0              | 12.4               | 4.25    | 4.25    | 0.8     | 8.0     | 12.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| AFE78201RRUR | UQFN         | RRU             | 24   | 3000 | 360.0       | 360.0      | 36.0        |
| AFE78201RRUT | UQFN         | RRU             | 24   | 250  | 210.0       | 185.0      | 35.0        |
| AFE88201RRUR | UQFN         | RRU             | 24   | 3000 | 367.0       | 367.0      | 35.0        |
| AFE88201RRUT | UQFN         | RRU             | 24   | 250  | 210.0       | 185.0      | 35.0        |



4225850/A 04/2020

## NOTES:

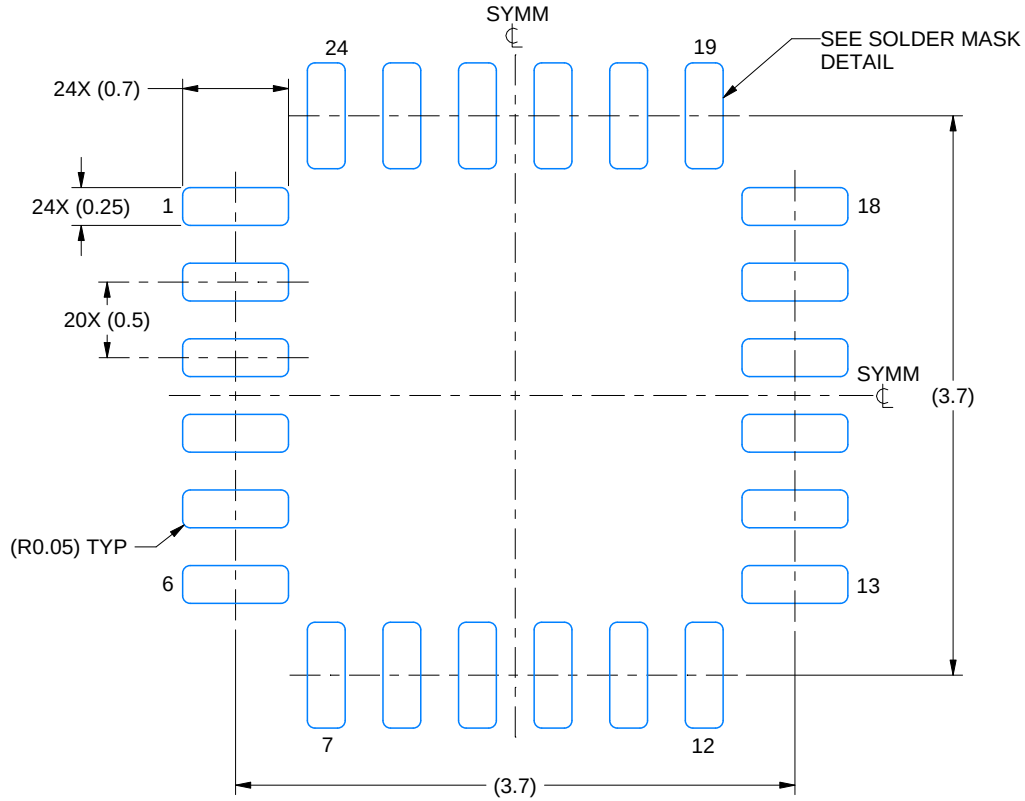
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

# EXAMPLE BOARD LAYOUT

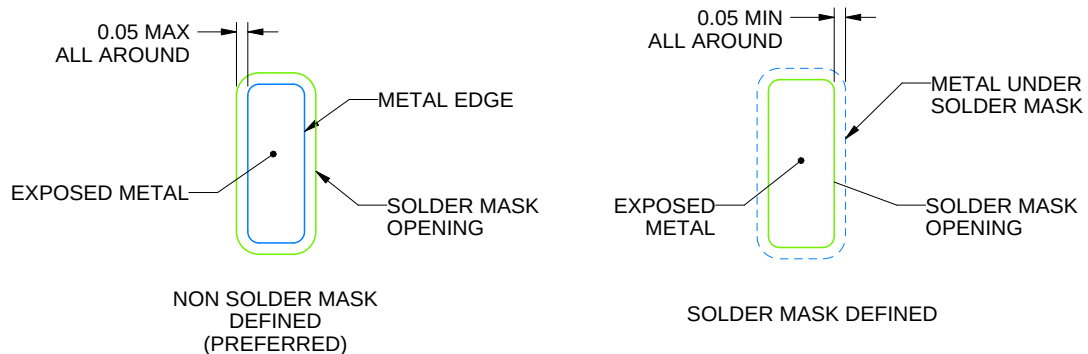
RRU0024A

UQFN - 0.7 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 20X



SOLDER MASK DETAILS

4225850/A 04/2020

NOTES: (continued)

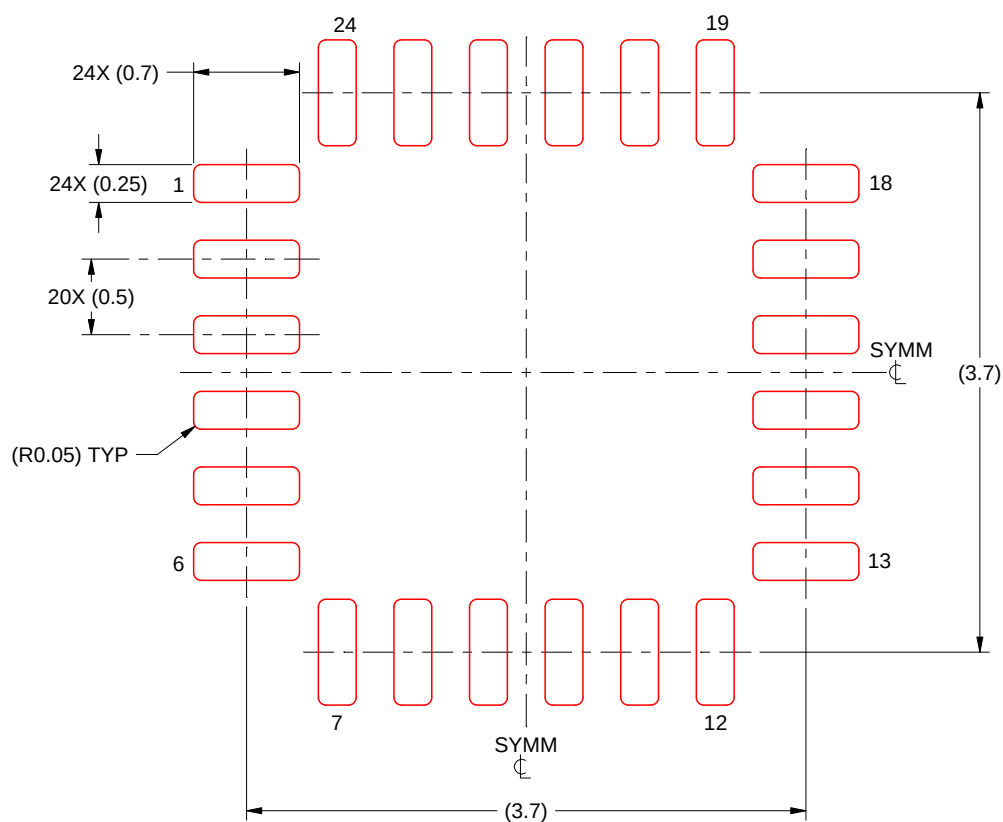
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/sluea271](http://www.ti.com/lit/sluea271)).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

# EXAMPLE STENCIL DESIGN

RRU0024A

UQFN - 0.7 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 MM THICK STENCIL  
SCALE: 20X

4225850/A 04/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on [ti.com](#) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2026, Texas Instruments Incorporated

Last updated 10/2025